# CC1312R SimpleLink™ 高性能 Sub-1GHz 无线 MCU

## 1 特性

- 微控制器
  - 功能强大的 48MHz Arm® Cortex®-M4F 处理器
  - EEMBC CoreMark® 评分：148
  - 352KB 系统内可编程闪存
  - 256KB ROM，用于协议和库函数
  - 8KB 缓存 SRAM（也可作为通用 RAM 提供）
  - 80KB 超低泄漏 SRAM。SRAM 通过奇偶校验得到保护，从而确保高度可靠运行。
  - 2 引脚 cJTAG 和 JTAG 调试
  - 支持无线 (OTA) 升级
- 具有 4KB SRAM 的超低功耗传感器控制器
  - 采样、存储和处理传感器数据
  - 独立于系统 CPU 运行
  - 快速唤醒进入低功耗运行
- TI-RTOS、驱动程序、引导加载程序和 IEEE 802.15.4 MAC 嵌入在 ROM 中，优化了应用尺寸
- 符合 RoHS 标准的封装
  - 7mm × 7mm RGZ VQFN48（30 个 GPIO）
- 外设
  - 数字外设可连接至任何 GPIO
  - 4 个 32 位或 8 个 16 位通用计时器
  - 12 位 ADC、200ksps、8 通道
  - 2 个具有内部基准 DAC 的比较器（1 个连续时间比较器、1 个超低功耗比较器）
  - 可编程电流源
  - 2 个异步收发器 (UART)
  - 2 个同步串行接口 (SSI)（SPI、MICROWIRE 和 TI）
  - $I^2C$
  - $I^2S$
  - 实时时钟 (RTC)
  - AES 128 位和 256 位加密加速计
  - ECC 和 RSA 公钥硬件加速器
  - SHA2 加速器（包括至 SHA-512 的全套装）
  - 真随机数发生器 (TRNG)
  - 电容式检测，最多 8 通道
  - 集成温度和电池监控器
- 外部系统
  - 片上降压直流/直流转换器
  - TCXO 支持
- 低功耗
  - 宽电源电压范围：1.8V 至 3.8V
  - 有源模式 RX：5.8mA（3.6V，868MHz）
  - 有源模式 TX (+14dBm)：24.9mA (868MHz)
  - 有源模式 MCU 48MHz (CoreMark)：2.9 mA (60 µA/MHz)
  - 传感器控制器（低功耗模式、2MHz、运行无限环路）：30.1 µA
  - 传感器控制器，有源模式，24MHz，运行无限循环：808 µA
  - 待机：0.85 µA（RTC 运行，80KB RAM 和 CPU 保持）
  - 关断电流：150nA（发生外部事件时唤醒）
- 无线电部分
  - 灵活的高性能 Sub-1GHz 射频收发器
  - 出色的接收器灵敏度：SimpleLink 远距离模式下为 -121dBm，50kbps 时为 -110dBm
  - 高达 +14dBm 的输出功率，具有温度补偿
  - 适用于符合各项全球射频规范的系统
    - ETSI EN 300 220 接收器类别 1.5 和 2、 EN 303 131、EN 303 204（欧洲）
    - FCC CFR47 第 15 部分
    - ARIB STD-T108
  - 支持广泛的标准
- 无线协议
  - IEEE 802.15.4g、支持 IPv6 的智能对象 (6LoWPAN)、MIOTY®、无线 M-Bus、Wi-SUN®、KNX RF、Amazon Sidewalk、专有系统、SimpleLink™ TI 15.4 stack（Sub-1GHz），以及动态多协议管理器 (DMM) 驱动程序
- 开发*工具和软件*
  - CC1312R LaunchPad™ 开发套件
  - SimpleLink™ CC13x2 和 CC26x2 软件开发套件 (SDK)
  - 用于简单无线电配置的 SmartRF™ Studio
  - 用于构建低功耗检测应用的 Sensor Controller Studio

本文档旨在为方便起见，提供有关 TI 产品中文版本的信息，以确认产品的概要。有关适用的官方英文版本的最新信息，请访问 www.ti.com，其内容始终优先。TI 不保证翻译的准确性和有效性。在实际设计之前，请务必参考最新版本的英文版本。

## 2 应用

- 169、433、470 至 510、868 和 902 至 928MHz ISM 和 SRD 系统，[1]
  接收带宽低至 4kHz
- 楼宇自动化
  - 楼宇安防系统 – 运动检测器、电子智能锁、门窗传感器、车库门系统、网关
  - HVAC – 恒温器、无线环境传感器、HVAC 系统控制器、网关
  - 防火安全系统 – 烟雾和热量探测器、火警控制面板 (FACP)
  - 视频监控 – IP 网络摄像头
  - 升降机和自动扶梯 – 升降机和自动扶梯的电梯主控板
- 电网基础设施
  - 智能仪表 – 水表、燃气表、电表和热量分配表
  - 电网通信 – 无线通信 – 远距离传感器应用
  - 其他替代能源 – 能量收集
- 工业运输 – 资产跟踪
- 工厂自动化和控制
- 医疗
- 电子销售终端 (EPOS) – 电子货架标签 (ESL)
- 个人电子产品
  - 联网外设 – 消费类无线模块
  - 家庭影院和娱乐 – 智能扬声器、机顶盒
  - 游戏
  - 可穿戴设备（非医用）

## 3 说明

SimpleLink™ CC1312R 器件是一款多协议 Sub-1GHz 无线微控制器 (MCU)，支持 IEEE 802.15.4g、支持 IPv6 的智能对象 (6LoWPAN)、MIOTY®、Wi-SUN®、专有系统（包括 Sub-1GHz 的 TI 15.4-Stack）。该器件经过优化，可用于楼宇安防系统、HVAC、智能仪表、医疗、有线网络、便携式电子产品、家庭影院和娱乐以及联网外设市场中的低功耗无线通信和高级检测。该器件的突出特性包括：

- 灵活的低于 1GHz 无线电，支持业界通用频带（315MHz、433MHz、868MHz、900MHz 等），可满足工业需求。
- 包含完整 SimpleLink™ 15.4-Stack (Sub-1GHz) 解决方案的 SimpleLink™ CC13x2 和 CC26x2 软件开发套件 (SDK) 提供丰富灵活的协议栈支持。
- 对于 Sub-1GHz，最大发送功率为 +14dBm（电流消耗为 24.9mA）。
- 具有 0.85µA 的低待机电流（完全 RAM 保持），从而延长无线应用的电池寿命。
- 支持工业温度，在 105°C 下最低待机电流为 11µA。
- 通过具有快速唤醒功能的可编程、自主式超低功耗传感器控制器 CPU 实现高级检测。例如，传感器控制器能够在 1µA 系统电流下进行 1Hz ADC 采样。
- 低 SER（软错误率）FIT（时基故障），可延长运行寿命，不会对工业市场造成干扰，SRAM 奇偶校验功能始终开启，可防止潜在辐射事件导致的损坏。
- 软件控制的专用无线电控制器 (Arm® Cortex®-M0) 提供灵活的低功耗射频收发器功能，支持多个物理层和射频标准。
- 出色的无线电敏感度 (-121dBm) 和稳健性（选择性与阻断）性能，适用于 SimpleLink™ 远距离模式。

CC1312R 器件是 SimpleLink™ MCU 平台的一部分，该平台包括 Wi-Fi®、低功耗*蓝牙*、Thread、Zigbee、Sub-1GHz MCU 和主机 MCU，它们共用一个通用、易于使用的开发环境，其中包含单核软件开发套件 (SDK) 和丰富的工具集。借助一次性集成的 SimpleLink™ 平台，可以将产品组合中的任何器件组合添加至您的设计中，从而在设计要求变更时实现 100% 的代码重用。如需更多信息，请访问 SimpleLink™ MCU 平台。

**器件信息**

| 器件型号(1) | 封装 | 封装尺寸（标称值） |
|---|---|---|
| CC1312R1F3RGZ | VQFN (48) | 7.00mm × 7.00mm |

(1) 如需所有可用器件的最新器件、封装和订购信息，请参阅节 12 中的“封装选项附录”或访问 TI 网站。

[1] 请参阅*射频内核*，了解有关支持的协议标准、调制格式和数据速率的其他详细信息。


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# 4 Functional Block Diagram

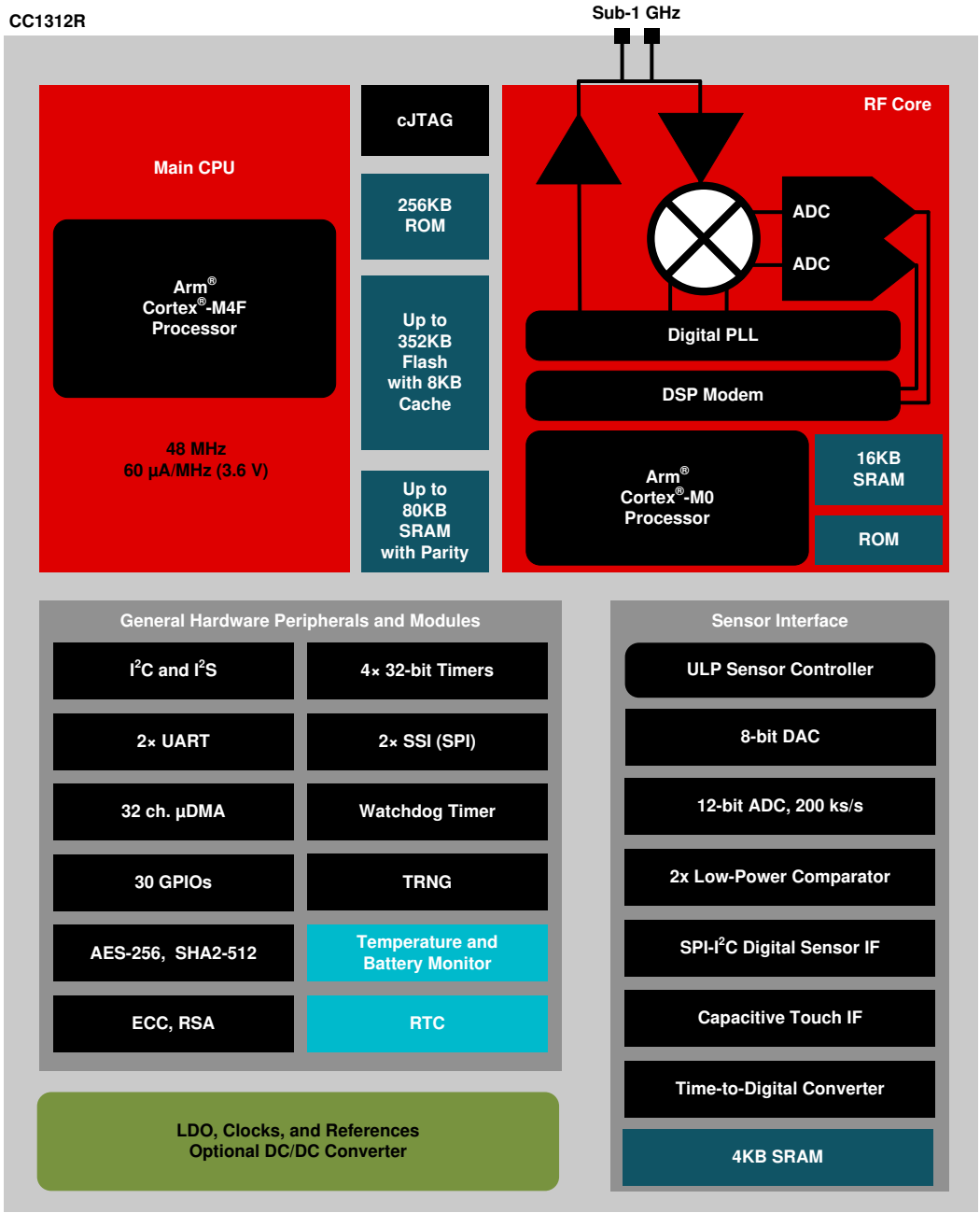



图 4-1. CC1312R Block Diagram

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# 5 Revision History

注：以前版本的页码可能与当前版本的页码不同

**Changes from May 19, 2020 to November 18, 2020 (from Revision G (May 2020) to Revision H (November 2020))** **Page**

- 更新了整个文档中的表格、图和交叉参考的编号格式 ..... 1
- 向节 1，*特性* 的“无线协议”列表项中添加了 Amazon Sidewalk ..... 1
- 向节 1，*特性* 添加了 TCXO 支持 ..... 1
- 向节 2，*应用* 添加了 169MHz 频段 ..... 2
- Changed the test condition to "Zero cycles" for the Flash sector erase time parameter in 节 8.7, *Nonvolatile (Flash) Memory Characteristics* ..... 10
- Added the 169 MHz band in 节 8.9, *RF Frequency Bands* ..... 10
- Changed the name of "802.15.4g Mandatory Mode" to "IEEE 802.15.4" and added deviation to conditions in 节 8.10, *861 MHz to 1054 MHz - Receive (RX)* ..... 10
- Added the following sections to 节 8.10, *861 MHz to 1054 MHz - Receive (RX)*: 100 kbps, ±25 kHz deviation, 2-GFSK, 137 kHz RX Bandwidth; 200 kbps, ±50 kHz deviation, 2-GFSK, 311 kHz RX Bandwidth; 500 kbps, ±190 kHz deviation, 2-GFSK, 1150 kHz RX Bandwidth; OOK, 4.8 kbps; Narrowband, 9.6 kbps ±2.4 kHz deviation, 2-GFSK, 868 MHz, 17.1 kHz RX Bandwidth; 1 Mbps, ±350 kHz deviation, 2-GFSK, 2.2 MHz RX Bandwidth; Wi-SUN; WB-DSSS, 240/120/60/30 kbps (480 ksym/s, 2-GFSK, ±195 kHz Deviation, FEC (Half Rate), DSSS = 1/2/4/8, 622 kHz RX BW) ..... 10
- Added the Adjacent Channel Power and Alternate Channel Power parameters to 节 8.11, *861 MHz to 1054 MHz - Receive (TX)* ..... 10
- Added the OOK 4.8 kbps section to 节 8.14, *359 MHz to 527 MHz - Receive (RX)* ..... 10
- Added 143 MHz to 176 MHz band specifications: 节 8.17, 节 8.18, and 节 8.19 ..... 10
- Added 节 8.20.3.1, *48 MHz Clock Input (TCXO)* ..... 27
- Changed the frequency of the input tone for 14-bit and 15-bit mode in 节 8.21.1.1 ..... 31
- Updated 图 8-17; added 图 8-18, 图 8-19, and 图 8-20 ..... 45
- Added the TXCO option in the paragraph that begins "The 48 MHz SCLK_HF is used as⋯" in 节 9.13, *Clock Systems* ..... 63
- Added the paragraph that begins "Integrated matched filter-balun devices can be used⋯" in 节 10.1, *Reference Designs* ..... 64

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# 6 Device Comparison

表 6-1. Device Family Overview

| DEVICE | RADIO SUPPORT | FLASH (KB) | RAM (KB) | GPIO | PACKAGE SIZE |
|---|---|---|---|---|---|
| CC1312R | Sub-1 GHz | 352 | 80 | 30 | RGZ (7-mm × 7-mm VQFN48) |
| CC1352P | Multiprotocol<br>Sub-1 GHz<br>Bluetooth 5.1 Low Energy<br>Zigbee<br>Thread<br>2.4 GHz proprietary FSK-based formats<br>+20-dBm high-power amplifier | 352 | 80 | 26 | RGZ (7-mm × 7-mm VQFN48) |
| CC1352R | Multiprotocol<br>Sub-1 GHz<br>Bluetooth 5.1 Low Energy<br>Zigbee<br>Thread<br>2.4 GHz proprietary FSK-based formats | 352 | 80 | 28 | RGZ (7-mm × 7-mm VQFN48) |
| CC2642R | Bluetooth 5.1 Low Energy<br>2.4 GHz proprietary FSK-based formats | 352 | 80 | 31 | RGZ (7-mm × 7-mm VQFN48) |
| CC2642R-Q1 | Bluetooth 5.1 Low Energy | 352 | 80 | 31 | RTC (7-mm × 7-mm VQFN48) |
| CC2652R | Multiprotocol<br>Bluetooth 5.1 Low Energy<br>Zigbee<br>Thread<br>2.4 GHz proprietary FSK-based formats | 352 | 80 | 31 | RGZ (7-mm × 7-mm VQFN48) |
| CC2652RB | Multiprotocol<br>Bluetooth 5.1 Low Energy<br>Zigbee<br>Thread<br>2.4 GHz proprietary FSK-based formats | 352 | 80 | 31 | RGZ (7-mm × 7-mm VQFN48) |
| CC2652P | Multiprotocol<br>Bluetooth 5.1 Low Energy<br>Zigbee<br>Thread<br>2.4 GHz proprietary FSK-based formats<br>+19.5-dBm high-power amplifier | 352 | 80 | 26 | RGZ (7-mm × 7-mm VQFN48) |
| CC1310 | Sub-1 GHz | 32 – 128 | 16 – 20 | 10 – 31 | RGZ (7-mm × 7-mm VQFN48)<br>RHB (5-mm × 5-mm VQFN32)<br>RSM (4-mm × 4-mm VQFN32) |
| CC1350 | Sub-1 GHz<br>Bluetooth 4.2 Low Energy | 128 | 20 | 10 – 31 | RGZ (7-mm × 7-mm VQFN48)<br>RHB (5-mm × 5-mm VQFN32)<br>RSM (4-mm × 4-mm VQFN32) |
| CC2640R2F | Bluetooth 5.1 Low Energy<br>2.4 GHz proprietary FSK-based formats | 128 | 20 | 10 – 31 | RGZ (7-mm × 7-mm VQFN48)<br>RHB (5-mm × 5-mm VQFN32)<br>RSM (4-mm × 4-mm VQFN32)<br>YFV (2.7-mm × 2.7-mm DSBGA34) |
| CC2640R2F-Q1 | Bluetooth 5.1 Low Energy<br>2.4 GHz proprietary FSK-based formats | 128 | 20 | 31 | RGZ (7-mm × 7-mm VQFN48) |


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# 7 Terminal Configuration and Functions

## 7.1 Pin Diagram – RGZ Package (Top View)

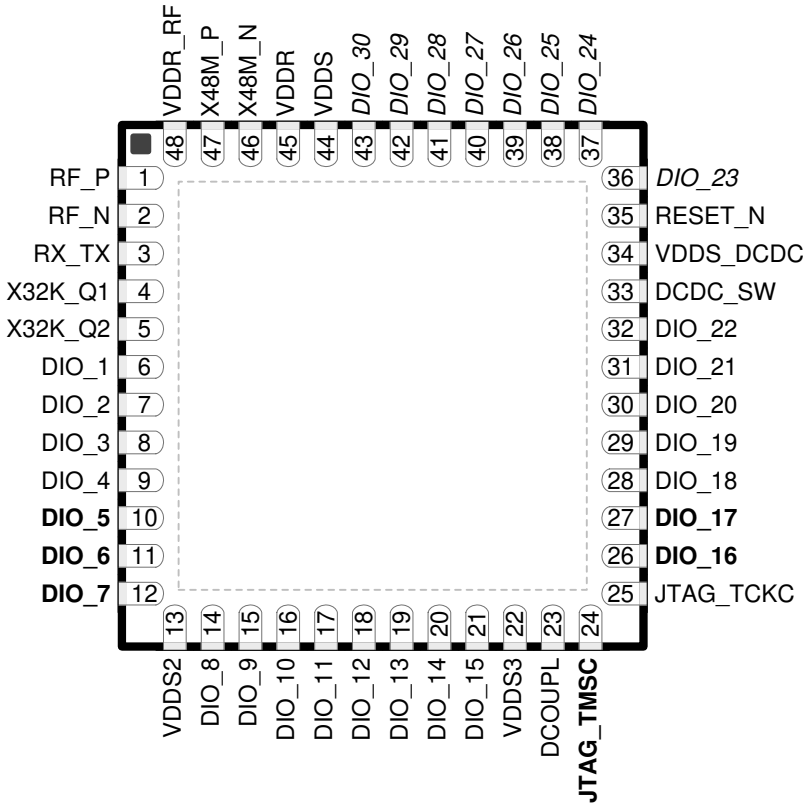



**图 7-1. RGZ (7-mm × 7-mm) Pinout, 0.5-mm Pitch (Top View)**

The following I/O pins marked in 图 7-1 in **bold** have high-drive capabilities:

- Pin 10, DIO_5
- Pin 11, DIO_6
- Pin 12, DIO_7
- Pin 24, JTAG_TMSC
- Pin 26, DIO_16
- Pin 27, DIO_17

The following I/O pins marked in 图 7-1 in *italics* have analog capabilities:

- Pin 36, DIO_23
- Pin 37, DIO_24
- Pin 38, DIO_25
- Pin 39, DIO_26
- Pin 40, DIO_27
- Pin 41, DIO_28
- Pin 42, DIO_29
- Pin 43, DIO_30

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## 7.2 Signal Descriptions – RGZ Package

表 7-1. Signal Descriptions – RGZ Package

| PIN | | I/O | TYPE | DESCRIPTION |
|---|---|---|---|---|
| NAME | NO. | | | |
| DCDC_SW | 33 | — | Power | Output from internal DC/DC converter(1) |
| DCOUPL | 23 | — | Power | For decoupling of internal 1.27 V regulated digital-supply (2) |
| DIO_1 | 6 | I/O | Digital | GPIO |
| DIO_2 | 7 | I/O | Digital | GPIO |
| DIO_3 | 8 | I/O | Digital | GPIO |
| DIO_4 | 9 | I/O | Digital | GPIO |
| DIO_5 | 10 | I/O | Digital | GPIO, high-drive capability |
| DIO_6 | 11 | I/O | Digital | GPIO, high-drive capability |
| DIO_7 | 12 | I/O | Digital | GPIO, high-drive capability |
| DIO_8 | 14 | I/O | Digital | GPIO |
| DIO_9 | 15 | I/O | Digital | GPIO |
| DIO_10 | 16 | I/O | Digital | GPIO |
| DIO_11 | 17 | I/O | Digital | GPIO |
| DIO_12 | 18 | I/O | Digital | GPIO |
| DIO_13 | 19 | I/O | Digital | GPIO |
| DIO_14 | 20 | I/O | Digital | GPIO |
| DIO_15 | 21 | I/O | Digital | GPIO |
| DIO_16 | 26 | I/O | Digital | GPIO, JTAG_TDO, high-drive capability |
| DIO_17 | 27 | I/O | Digital | GPIO, JTAG_TDI, high-drive capability |
| DIO_18 | 28 | I/O | Digital | GPIO |
| DIO_19 | 29 | I/O | Digital | GPIO |
| DIO_20 | 30 | I/O | Digital | GPIO |
| DIO_21 | 31 | I/O | Digital | GPIO |
| DIO_22 | 32 | I/O | Digital | GPIO |
| DIO_23 | 36 | I/O | Digital or Analog | GPIO, analog capability |
| DIO_24 | 37 | I/O | Digital or Analog | GPIO, analog capability |
| DIO_25 | 38 | I/O | Digital or Analog | GPIO, analog capability |
| DIO_26 | 39 | I/O | Digital or Analog | GPIO, analog capability |
| DIO_27 | 40 | I/O | Digital or Analog | GPIO, analog capability |
| DIO_28 | 41 | I/O | Digital or Analog | GPIO, analog capability |
| DIO_29 | 42 | I/O | Digital or Analog | GPIO, analog capability |
| DIO_30 | 43 | I/O | Digital or Analog | GPIO, analog capability |
| EGP | — | — | GND | Ground – exposed ground pad(3) |
| JTAG_TMSC | 24 | I/O | Digital | JTAG TMSC, high-drive capability |
| JTAG_TCKC | 25 | I | Digital | JTAG TCKC |
| RESET_N | 35 | I | Digital | Reset, active low. No internal pullup resistor |
| RF_P | 1 | — | RF | Positive RF input signal to LNA during RX<br>Positive RF output signal from PA during TX |
| RF_N | 2 | — | RF | Negative RF input signal to LNA during RX<br>Negative RF output signal from PA during TX |
| RX_TX | 3 | — | RF | Optional bias pin for the RF LNA |
| VDDR | 45 | — | Power | Internal supply, must be powered from the internal DC/DC converter or the internal LDO(4) (2) (6) |


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表 7-1. Signal Descriptions – RGZ Package (continued)

| PIN | | I/O | TYPE | DESCRIPTION |
|---|---|---|---|---|
| NAME | NO. | | | |
| VDDR_RF | 48 | — | Power | Internal supply, must be powered from the internal DC/DC converter or the internal LDO(5) (2) (6) |
| VDDS | 44 | — | Power | 1.8-V to 3.8-V main chip supply(1) |
| VDDS2 | 13 | — | Power | 1.8-V to 3.8-V DIO supply(1) |
| VDDS3 | 22 | — | Power | 1.8-V to 3.8-V DIO supply(1) |
| VDDS_DCDC | 34 | — | Power | 1.8-V to 3.8-V DC/DC converter supply |
| X48M_N | 46 | — | Analog | 48-MHz crystal oscillator pin 1 |
| X48M_P | 47 | — | Analog | 48-MHz crystal oscillator pin 2 |
| X32K_Q1 | 4 | — | Analog | 32-kHz crystal oscillator pin 1 |
| X32K_Q2 | 5 | — | Analog | 32-kHz crystal oscillator pin 2 |

(1) For more details, see technical reference manual listed in 节 11.2.
(2) Do not supply external circuitry from this pin.
(3) EGP is the only ground connection for the device. Good electrical connection to device ground on printed circuit board (PCB) is imperative for proper device operation.
(4) If internal DC/DC converter is not used, this pin is supplied internally from the main LDO.
(5) If internal DC/DC converter is not used, this pin must be connected to VDDR for supply from the main LDO.
(6) Output from internal DC/DC and LDO is trimmed to 1.68 V.

## 7.3 Connections for Unused Pins and Modules

表 7-2. Connections for Unused Pins

| FUNCTION | SIGNAL NAME | PIN NUMBER | ACCEPTABLE PRACTICE(1) | PREFERRED PRACTICE(1) |
|---|---|---|---|---|
| GPIO | DIO_n | 6 – 12<br>14 – 21<br>26 – 32<br>36 – 43 | NC or GND | NC |
| 32.768-kHz crystal | X32K_Q1 | 4 | NC or GND | NC |
| | X32K_Q2 | 5 | | |
| DC/DC converter(2) | DCDC_SW | 33 | NC | NC |
| | VDDS_DCDC | 34 | VDDS | VDDS |

(1) NC = No connect
(2) When the DC/DC converter is not used, the inductor between DCDC_SW and VDDR can be removed. VDDR and VDDR_RF must still be connected and the 22 uF DCDC capacitor must be kept on the VDDR net.

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# 8 Specifications

## 8.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)(1) (2)

| | | | MIN | MAX | UNIT |
|---|---|---|---|---|---|
| VDDS(3) | Supply voltage | | –0.3 | 4.1 | V |
| | Voltage on any digital pin(4) | | –0.3 | VDDS + 0.3, max 4.1 | V |
| | Voltage on crystal oscillator pins, X32K_Q1, X32K_Q2, X48M_N and X48M_P | | –0.3 | VDDR + 0.3, max 2.25 | V |
| $V_{in}$ | Voltage on ADC input | Voltage scaling enabled | –0.3 | VDDS | V |
| | | Voltage scaling disabled, internal reference | –0.3 | 1.49 | |
| | | Voltage scaling disabled, VDDS as reference | –0.3 | VDDS / 2.9 | |
| | Input level, RF pins | | | 10 | dBm |
| $T_{stg}$ | Storage temperature | | –40 | 150 | °C |

(1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
(2) All voltage values are with respect to ground, unless otherwise noted.
(3) VDDS_DCDC, VDDS2 and VDDS3 must be at the same potential as VDDS.
(4) Including analog capable DIOs.

## 8.2 ESD Ratings

| | | | | VALUE | UNIT |
|---|---|---|---|---|---|
| $V_{ESD}$ | Electrostatic discharge | Human body model (HBM), per ANSI/ESDA/JEDEC JS-001(1) | All pins | ±2000 | V |
| | | Charged device model (CDM), per ANSI/ESDA/JEDEC JS-002(2) | All pins | ±500 | V |

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process
(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process

## 8.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

| | | MIN | MAX | UNIT |
|---|---|---|---|---|
| Operating junction temperature(2) | | –40 | 105 | °C |
| Operating supply voltage (VDDS) | | 1.8 | 3.8 | V |
| Operating supply voltage (VDDS), boost mode | VDDR = 1.95 V<br>+14 dBm RF output power | 2.1 | 3.8 | V |
| Rising supply voltage slew rate | | 0 | 100 | mV/µs |
| Falling supply voltage slew rate(1) | | 0 | 20 | mV/µs |

(1) For small coin-cell batteries, with high worst-case end-of-life equivalent source resistance, a 22-µF VDDS input capacitor must be used to ensure compliance with this slew rate.
(2) For thermal resistance characteristics refer to 节 8.8. For application considerations, refer to 节 10.2.


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## 8.4 Power Supply and Modules

over operating free-air temperature range (unless otherwise noted)

| PARAMETER | | MIN | TYP | MAX | UNIT |
|---|---|---|---|---|---|
| VDDS Power-on-Reset (POR) threshold | | | 1.1 - 1.55 | | V |
| VDDS Brown-out Detector (BOD) (1) | Rising threshold | | 1.77 | | V |
| VDDS Brown-out Detector (BOD), before initial boot (2) | Rising threshold | | 1.70 | | V |
| VDDS Brown-out Detector (BOD) (1) | Falling threshold | | 1.75 | | V |

(1) For boost mode (VDDR =1.95 V), TI drivers software initialization will trim VDDS BOD limits to maximum (approximately 2.0 V)
(2) Brown-out Detector is trimmed at initial boot, value is kept until device is reset by a POR reset or the RESET_N pin

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## 8.5 Power Consumption - Power Modes

When measured on the CC1312REM-XD7793 reference design with $T_c$ = 25 °C, $V_{DDS}$ = 3.6 V with DC/DC enabled unless otherwise noted.

| PARAMETER | | TEST CONDITIONS | TYP | UNIT |
|---|---|---|---|---|
| **Core Current Consumption** | | | | |
| $I_{core}$ | Reset and Shutdown | Reset. RESET_N pin asserted or VDDS below power-on-reset threshold | 150 | nA |
| | | Shutdown. No clocks running, no retention | 150 | |
| | Standby without cache retention | RTC running, CPU, 80KB RAM and (partial) register retention. RCOSC_LF | 0.85 | µA |
| | | RTC running, CPU, 80KB RAM and (partial) register retention XOSC_LF | 0.99 | µA |
| | Standby with cache retention | RTC running, CPU, 80KB RAM and (partial) register retention. RCOSC_LF | 2.78 | µA |
| | | RTC running, CPU, 80KB RAM and (partial) register retention. XOSC_LF | 2.92 | µA |
| | Idle | Supply Systems and RAM powered RCOSC_HF | 590 | µA |
| | Active | MCU running CoreMark at 48 MHz RCOSC_HF | 2.89 | mA |
| **Peripheral Current Consumption** (1), (2) | | | | |
| $I_{peri}$ | Peripheral power domain | Delta current with domain enabled | 82.3 | µA |
| | Serial power domain | Delta current with domain enabled | 5.5 | |
| | RF Core | Delta current with power domain enabled, clock enabled, RF core idle | 178.9 | |
| | µDMA | Delta current with clock enabled, module is idle | 53.6 | |
| | Timers | Delta current with clock enabled, module is idle(5) | 67.8 | |
| | I2C | Delta current with clock enabled, module is idle | 8.2 | |
| | I2S | Delta current with clock enabled, module is idle | 21.7 | |
| | SSI | Delta current with clock enabled, module is idle(4) | 69.4 | |
| | UART | Delta current with clock enabled, module is idle(3) | 140.8 | |
| | CRYPTO (AES) | Delta current with clock enabled, module is idle | 21.1 | |
| | PKA | Delta current with clock enabled, module is idle | 71.1 | |
| | TRNG | Delta current with clock enabled, module is idle | 29.7 | |
| **Sensor Controller Engine Consumption** | | | | |
| $I_{SCE}$ | Active mode | 24 MHz, infinite loop, $V_{DDS}$ = 3.0 V | 808.5 | µA |
| | Low-power mode | 2 MHz, infinite loop, $V_{DDS}$ = 3.0 V | 30.1 | |

(1) Adds to core current $I_{core}$ for each peripheral unit activated.
(2) $I_{peri}$ is not supported in Standby or Shutdown modes.
(3) Only one UART running
(4) Only one SSI running
(5) Only one GPTimer running


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## 8.6 Power Consumption - Radio Modes

When measured on the CC1312REM-XD7793 reference design with $T_c$ = 25 °C, $V_{DDS}$ = 3.6 V with DC/DC enabled unless otherwise noted.
Using boost mode (increasing VDDR up to 1.95 V), will increase system current by 15% (does not apply to TX +14 dBm setting where this current is already included).
Relevant $I_{core}$ and $I_{peri}$ currents are included in below numbers.

| PARAMETER | | TEST CONDITIONS | TYP | UNIT |
|---|---|---|---|---|
| | Radio receive current, 868 MHz | | 5.8 | mA |
| | Radio transmit current | 0 dBm output power setting<br>868 MHz | 8.0 | mA |
| | | +10 dBm output power setting<br>868 MHz | 14.3 | mA |
| | Radio transmit current<br>Boost mode | +14 dBm output power setting<br>868 MHz | 24.9 | mA |

## 8.7 Nonvolatile (Flash) Memory Characteristics

Over operating free-air temperature range and $V_{DDS}$ = 3.0 V (unless otherwise noted)

| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|---|---|---|---|---|---|
| Flash sector size | | | 8 | | KB |
| Supported flash erase cycles before failure, full bank(1) (5) | | 30 | | | k Cycles |
| Supported flash erase cycles before failure, single sector(2) | | 60 | | | k Cycles |
| Maximum number of write operations per row before sector erase(3) | | | | 83 | Write Operations |
| Flash retention | 105 °C | 11.4 | | | Years at 105 °C |
| Flash sector erase current | Average delta current | | 10.7 | | mA |
| Flash sector erase time(4) | Zero cycles | | 10 | | ms |
| Flash write current | Average delta current, 4 bytes at a time | | 6.2 | | mA |
| Flash write time(4) | 4 bytes at a time | | 21.6 | | µs |

(1) A full bank erase is counted as a single erase cycle on each sector
(2) Up to 4 customer-designated sectors can be individually erased an additional 30k times beyond the baseline bank limitation of 30k cycles
(3) Each wordline is 2048 bits (or 256 bytes) wide. This limitation corresponds to sequential memory writes of 4 (3.1) bytes minimum per write over a whole wordline. If additional writes to the same wordline are required, a sector erase is required once the maximum number of write operations per row is reached.
(4) This number is dependent on Flash aging and increases over time and erase cycles
(5) Aborting flash during erase or program modes is not a safe operation.

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## 8.8 Thermal Resistance Characteristics

| THERMAL METRIC[1] | | PACKAGE | UNIT |
|---|---|---|---|
| | | RGZ (VQFN) | |
| | | 48 PINS | |
| $R_{\theta JA}$ | Junction-to-ambient thermal resistance | 23.4 | °C/W[2] |
| $R_{\theta JC(top)}$ | Junction-to-case (top) thermal resistance | 13.3 | °C/W[2] |
| $R_{\theta JB}$ | Junction-to-board thermal resistance | 8.0 | °C/W[2] |
| $\psi_{JT}$ | Junction-to-top characterization parameter | 0.1 | °C/W[2] |
| $\psi_{JB}$ | Junction-to-board characterization parameter | 7.9 | °C/W[2] |
| $R_{\theta JC(bot)}$ | Junction-to-case (bottom) thermal resistance | 1.7 | °C/W[2] |

(1) For more information about traditional and new thermal metrics, see Semiconductor and IC Package Thermal Metrics.
(2) °C/W = degrees Celsius per watt.

## 8.9 RF Frequency Bands

Over operating free-air temperature range (unless otherwise noted).

| PARAMETER | MIN | TYP | MAX | UNIT |
|---|---|---|---|---|
| Frequency bands | 1076 | | 1315 | MHz |
| | 861 | | 1054 | |
| | 431 | | 527 | |
| | 359 | | 439 | |
| | 287 | | 351 | |
| | 143 | | 176 | |


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## 8.10 861 MHz to 1054 MHz - Receive (RX)

When measured on the CC1312REM-XD7793 reference design with $T_c$ = 25 °C, $V_{DDS}$ = 3.0 V with DC/DC enabled unless otherwise noted. All measurements are performed at the antenna input with a combined RX and TX path. All measurements are performed conducted.

| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|---|---|---|---|---|---|
| **General Parameters** | | | | | |
| Digital channel filter programmable receive bandwidth | | 4 | | 4000 | kHz |
| Data rate step size | | | 1.5 | | bps |
| Spurious emissions 25 MHz to 1 GHz | 868 MHz<br>Conducted emissions measured according to ETSI EN 300 220 | | < -57 | | dBm |
| Spurious emissions 1 GHz to 13 GHz | | | < -47 | | dBm |
| **IEEE 802.15.4, 50 kbps, ±25 kHz Deviation, 2-GFSK, 100 kHz RX Bandwidth** | | | | | |
| Sensitivity | BER = $10^{-2}$, 868 MHz | | –110 | | dBm |
| Saturation limit | BER = $10^{-2}$, 868 MHz | | 10 | | dBm |
| Selectivity, ±200 kHz | BER = $10^{-2}$, 868 MHz(1) | | 44 | | dB |
| Selectivity, ±400 kHz | BER = $10^{-2}$, 868 MHz(1) | | 48 | | dB |
| Blocking, ±1 MHz | BER = $10^{-2}$, 868 MHz(1) | | 57 | | dB |
| Blocking, ±2 MHz | BER = $10^{-2}$, 868 MHz(1) | | 61 | | dB |
| Blocking, ±5 MHz | BER = $10^{-2}$, 868 MHz(1) | | 67 | | dB |
| Blocking, ±10 MHz | BER = $10^{-2}$, 868 MHz(1) | | 76 | | dB |
| Image rejection (image compensation enabled) | BER = $10^{-2}$, 868 MHz(1) | | 39 | | dB |
| RSSI dynamic range | Starting from the sensitivity limit | | 95 | | dB |
| RSSI accuracy | Starting from the sensitivity limit across the given dynamic range | | ±3 | | dB |
| **100 kbps, ±25 kHz Deviation, 2-GFSK, 137 kHz RX Bandwidth** | | | | | |
| Sensitivity 100 kbps | 1% PER, 127 byte payload, 868 MHz | | -104 | | dBm |
| Selectivity, ±200 kHz | 1% PER, 127 byte payload, 868 MHz. Wanted signal at -96 dBm | | 31 | | dB |
| Selectivity, ±400 kHz | 1% PER, 127 byte payload, 868 MHz. Wanted signal at -96 dBm | | 37 | | dB |
| Co-channel rejection | 1% PER, 127 byte payload, 868 MHz. Wanted signal at -79 dBm | | -9 | | dB |
| **200 kbps, ±50 kHz Deviation, 2-GFSK, 311 kHz RX Bandwidth** | | | | | |
| Sensitivity | BER = $10^{-2}$, 868 MHz | | –103 | | dBm |
| Sensitivity | BER = $10^{-2}$, 915 MHz | | –103 | | dBm |
| Selectivity, ±400 kHz | BER = $10^{-2}$, 915 MHz. Wanted signal 3 dB above sensitivity limit. | | 41 | | dB |
| Selectivity, ±800 kHz | BER = $10^{-2}$, 915 MHz. Wanted signal 3 dB above sensitivity limit. | | 47 | | dB |
| Blocking, ±2 MHz | BER = $10^{-2}$, 915 MHz. Wanted signal 3 dB above sensitivity limit. | | 55 | | dB |
| Blocking, ±10 MHz | BER = $10^{-2}$, 915 MHz. Wanted signal 3 dB above sensitivity limit. | | 67 | | dB |
| **500 kbps, ±190 kHz Deviation, 2-GFSK, 1150 kHz RX Bandwidth** | | | | | |
| Sensitivity 500 kbps | 1% PER, 127 byte payload, 915 MHz | | -94 | | dBm |
| Selectivity, ±1 MHz | 1% PER, 127 byte payload, 915 MHz. Wanted signal at -88 dBm | | 14 | | dB |
| Selectivity, ±2 MHz | 1% PER, 127 byte payload, 915 MHz. Wanted signal at -88 dBm | | 42 | | dB |

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## 8.10 861 MHz to 1054 MHz - Receive (RX) (continued)

When measured on the CC1312REM-XD7793 reference design with $T_c$ = 25 °C, $V_{DDS}$ = 3.0 V with DC/DC enabled unless otherwise noted. All measurements are performed at the antenna input with a combined RX and TX path. All measurements are performed conducted.

| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|---|---|---|---|---|---|
| Co-channel rejection | 1% PER, 127 byte payload, 915 MHz. Wanted signal at -71 dBm | | -9 | | dB |
| **1 Mbps, ±350 kHz Deviation, 2-GFSK, 2.2 MHz RX Bandwidth** | | | | | |
| Sensitivity | BER = $10^{-2}$, 868 MHz | | -97 | | dBm |
| Sensitivity | BER = $10^{-2}$, 915 MHz | | -96 | | dBm |
| Blocking, +2 MHz | BER = $10^{-2}$, 915 MHz. Wanted signal 3 dB above sensitivity limit. | | 43 | | dB |
| Blocking, -2 MHz | BER = $10^{-2}$, 915 MHz. Wanted signal 3 dB above sensitivity limit. | | 26 | | dB |
| Blocking, +10 MHz | BER = $10^{-2}$, 915 MHz. Wanted signal 3 dB above sensitivity limit. | | 54 | | dB |
| Blocking, -10 MHz | BER = $10^{-2}$, 915 MHz. Wanted signal 3 dB above sensitivity limit. | | 48 | | dB |
| **SimpleLink™ Long Range, 2.5/5 kbps (20 ksps), ±5 kHz Deviation, 2-GFSK, 34 kHz RX Bandwidth, FEC = 1:2, DSSS = 1:4/1:2** | | | | | |
| Sensitivity | 2.5 kbps, BER = $10^{-2}$ , 868 MHz | | -121 | | dBm |
| Sensitivity | 5 kbps, BER = $10^{-2}$ , 868 MHz | | -120 | | dBm |
| Saturation limit | 2.5 kbps, BER = $10^{-2}$ , 868 MHz | | 10 | | dBm |
| Selectivity, ±100 kHz | 2.5 kbps, BER = $10^{-2}$, 868 MHz(1) | | 49 | | dB |
| Selectivity, ±200 kHz | 2.5 kbps, BER = $10^{-2}$, 868 MHz(1) | | 50 | | dB |
| Selectivity, ±300 kHz | 2.5 kbps, BER = $10^{-2}$, 868 MHz(1) | | 51 | | dB |
| Blocking, ±1 MHz | 2.5 kbps, BER = $10^{-2}$, 868 MHz(1) | | 63 | | dB |
| Blocking, ±2 MHz | 2.5 kbps, BER = $10^{-2}$, 868 MHz(1) | | 68 | | dB |
| Blocking, ±5 MHz | 2.5 kbps, BER = $10^{-2}$, 868 MHz(1) | | 78 | | dB |
| Blocking, ±10 MHz | 2.5 kbps, BER = $10^{-2}$, 868 MHz(1) | | 88 | | dB |
| Image rejection (image compensation enabled) | 2.5 kbps, BER = $10^{-2}$, 868 MHz(1) | | 45 | | dB |
| RSSI dynamic range | Starting from the sensitivity limit | | 97 | | dB |
| RSSI accuracy | Starting from the sensitivity limit across the given dynamic range | | ±3 | | dB |
| **4.8 kbps, OOK, 39 kHz RX Bandwidth** | | | | | |
| Sensitivity | BER = $10^{-2}$, 868 MHz, 38.9 kHz RX bandwidth | | -115 | | dBm |
| Sensitivity | BER = $10^{-2}$, 915 MHz, 41.0 kHz RX bandwidth | | -115 | | dBm |
| **Narrowband, 9.6 kbps, ±2.4 kHz Deviation, 2-GFSK, 17.1 kHz RX Bandwidth** | | | | | |
| Sensitivity | BER = $10^{-2}$, 868 MHz | | -118 | | dBm |
| Adjacent Channel Rejection | BER = $10^{-2}$, 868 MHz. Wanted signal 3 dB above the ETSI reference sensitivity limit (-104.6 dBm). Interferer ±20 kHz | | 39 | | dB |
| Alternate Channel Rejection | BER = $10^{-2}$, 868 MHz. Wanted signal 3 dB above the ETSI reference sensitivity limit (-104.6 dBm). Interferer ±40 kHz | | 40 | | dB |
| Blocking, ±1 MHz | BER = $10^{-2}$, 868 MHz. Wanted signal 3 dB above the ETSI reference sensitivity limit (-104.6 dBm). | | 65 | | dB |
| Blocking, ±2 MHz | BER = $10^{-2}$, 868 MHz. Wanted signal 3 dB above the ETSI reference sensitivity limit (-104.6 dBm). | | 69 | | dB |
| Blocking, ±10 MHz | BER = $10^{-2}$, 868 MHz. Wanted signal 3 dB above the ETSI reference sensitivity limit (-104.6 dBm). | | 85 | | dB |
| **Wi-SUN** | | | | | |


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## 8.10 861 MHz to 1054 MHz - Receive (RX) (continued)

When measured on the CC1312REM-XD7793 reference design with $T_c$ = 25 °C, $V_{DDS}$ = 3.0 V with DC/DC enabled unless otherwise noted. All measurements are performed at the antenna input with a combined RX and TX path. All measurements are performed conducted.

| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|---|---|---|---|---|---|
| Sensitivity | 50 kbps, ±12.5 kHz Deviation, 2-GFSK, 68 kHz RX Bandwidth, 868 MHz, 10% PER, 250 byte payload | | -107 | | dBm |
| Sensitivity | 100 kbps, ±25 kHz Deviation, 2-GFSK, 135 kHz RX Bandwidth, 868 MHz, 10% PER, 250 byte payload | | -104 | | dBm |
| Sensitivity | 100 kbps, ±50 kHz Deviation, 2-GFSK, 196 kHz RX Bandwidth, 920.9 MHz, 10% PER, 250 byte payload | | -102 | | dBm |
| Sensitivity | 200 kbps, ±100 kHz Deviation, 2-GFSK, 273 kHz RX Bandwidth, 920.8 MHz, 10% PER, 250 byte payload | | -99 | | dBm |
| **WB-DSSS, 30/60/120/240 kbps (480 ksps), ±195 kHz Deviation, 2-GFSK, 622 RX Bandwidth, FEC = 1:2, DSSS = 1:8/1:4/1:2/1:1** | | | | | |
| Sensitivity | 30 kbps, BER = $10^{-2}$, 915 MHz | | -109 | | dBm |
| Sensitivity | 60 kbps, BER = $10^{-2}$, 915 MHz | | -108 | | dBm |
| Sensitivity | 120 kbps, BER = $10^{-2}$, 915 MHz | | -106 | | dBm |
| Sensitivity | 240 kbps, BER = $10^{-2}$, 915 MHz | | -105 | | dBm |
| Blocking ±1 MHz | 240 kbps, BER = $10^{-2}$, 915 MHz | | 49 | | dB |
| Blocking ±2 MHz | 240 kbps, BER = $10^{-2}$, 915 MHz | | 53 | | dB |
| Blocking ±5 MHz | 240 kbps, BER = $10^{-2}$, 915 MHz | | 54 | | dB |
| Blocking ±10 MHz | 240 kbps, BER = $10^{-2}$, 915 MHz | | 65 | | dB |

(1) Wanted signal 3 dB above the reference sensitivity limit according to ETSI EN 300 220 v. 3.1.1

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## 8.11 861 MHz to 1054 MHz - Transmit (TX)

When measured on the CC1312REM-XD7793 reference design with $T_c$ = 25 °C, $V_{DDS}$ = 3.0 V with DC/DC enabled unless otherwise noted. All measurements are performed at the antenna input with a combined RX and TX path. All measurements are performed conducted. (1)

| PARAMETER | | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|---|---|---|---|---|---|---|
| **General parameters** | | | | | | |
| Max output power, boost mode | | VDDR = 1.95 V<br>Minimum supply voltage (VDDS ) for boost mode is 2.1 V<br>868 MHz and 915 MHz | | 14 | | dBm |
| Max output power | | 868 MHz and 915 MHz | | 12 | | dBm |
| Output power programmable range | | 868 MHz and 915 MHz | | 24 | | dB |
| Output power variation over temperature | | +10 dBm setting<br>Over recommended temperature operating range | | ±2 | | dB |
| Output power variation over temperature Boost mode | | +14 dBm setting<br>Over recommended temperature operating range | | ±1.5 | | dB |
| **Spurious emissions and harmonics** | | | | | | |
| Spurious emissions (excluding harmonics) (2) | 30 MHz to 1 GHz | +14 dBm setting<br>ETSI restricted bands | | < -54 | | dBm |
| | | +14 dBm setting<br>ETSI outside restricted bands | | < -36 | | dBm |
| | 1 GHz to 12.75 GHz (outside ETSI restricted bands) | +14 dBm setting<br>measured in 1 MHz bandwidth (ETSI) | | < -30 | | dBm |
| Adjacent Channel Power | 9.6 kbps, ±2.4 kHz deviation, 2-GFSK, 20 kHz channel spacing. Narrowband mode. | Adjacent channel (ETSI EN 300 220 requirement). TxPower = 12.5 dBm. 868 MHz | | -24 | | dBm |
| Alternate Channel Power | 9.6 kbps, ±2.4 kHz deviation, 2-GFSK, 20 kHz channel spacing. Narrowband mode. | Alternate channel (ETSI EN 300 220 requirement). TxPower = 12.5 dBm. 868 MHz | | -31 | | dBm |
| Spurious emissions out-of-band, 915 MHz (2) | 30 MHz to 88 MHz (within FCC restricted bands) | +14 dBm setting | | < -56 | | dBm |
| | 88 MHz to 216 MHz (within FCC restricted bands) | +14 dBm setting | | < -52 | | dBm |
| | 216 MHz to 960 MHz (within FCC restricted bands) | +14 dBm setting | | < -50 | | dBm |
| | 960 MHz to 2390 MHz and above 2483.5 MHz (within FCC restricted band) | +14 dBm setting | | <-42 | | dBm |
| | 1 GHz to 12.75 GHz (outside FCC restricted bands) | +14 dBm setting | | < -40 | | dBm |
| Spurious emissions out-of-band, 920.6/928 MHz (2) | Below 710 MHz (ARIB T-108) | +14 dBm setting | | < -36 | | dBm |
| | 710 MHz to 900 MHz (ARIB T-108) | +14 dBm setting | | < -55 | | dBm |
| | 900 MHz to 915 MHz (ARIB T-108) | +14 dBm setting | | < -55 | | dBm |
| | 930 MHz to 1000 MHz (ARIB T-108) | +14 dBm setting | | < -55 | | dBm |
| | 1000 MHz to 1215 MHz (ARIB T-108) | +14 dBm setting | | < -45 | | dBm |
| | Above 1215 MHz (ARIB T-108) | +14 dBm setting | | < -30 | | dBm |


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## 8.11 861 MHz to 1054 MHz - Transmit (TX) (continued)

When measured on the CC1312REM-XD7793 reference design with $T_c$ = 25 °C, $V_{DDS}$ = 3.0 V with DC/DC enabled unless otherwise noted. All measurements are performed at the antenna input with a combined RX and TX path. All measurements are performed conducted. (1)

| PARAMETER | | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|---|---|---|---|---|---|---|
| Harmonics | Second harmonic | +14 dBm setting, 868 MHz | | < -30 | | dBm |
| | | +14 dBm setting, 915 MHz | | < -30 | | |
| | Third harmonic | +14 dBm setting, 868 MHz | | < -30 | | dBm |
| | | +14 dBm setting, 915 MHz | | < -42 | | |
| | Fourth harmonic | +14 dBm setting, 868 MHz | | < -30 | | dBm |
| | | +14 dBm setting, 915 MHz | | < -30 | | |
| | Fifth harmonic | +14 dBm setting, 868 MHz | | < -30 | | dBm |
| | | +14 dBm setting, 915 MHz | | < -42 | | |

(1) Some combinations of frequency, data rate and modulation format requires use of external crystal load capacitors for regulatory compliance. More details can be found in the device errata.
(2) Suitable for systems targeting compliance with EN 300 220, EN 303 131, EN 303 204, FCC CFR47 Part 15, ARIB STD-T108.

## 8.12 861 MHz to 1054 MHz - PLL Phase Noise Wideband Mode

When measured on the CC1312REM-XD7793 reference design with $T_c$ = 25 °C, $V_{DDS}$ = 3.0 V.

| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|---|---|---|---|---|---|
| Phase noise in the 868- and 915-MHz bands<br>20 kHz PLL loop bandwidth | ±10 kHz offset | | -74 | | dBc/Hz |
| | ±100 kHz offset | | -97 | | dBc/Hz |
| | ±200 kHz offset | | -107 | | dBc/Hz |
| | ±400 kHz offset | | -113 | | dBc/Hz |
| | ±1000 kHz offset | | -120 | | dBc/Hz |
| | ±2000 kHz offset | | -127 | | dBc/Hz |
| | ±10000 kHz offset | | -141 | | dBc/Hz |

## 8.13 861 MHz to 1054 MHz - PLL Phase Noise Narrowband Mode

When measured on the CC1312REM-XD7793 reference design with $T_c$ = 25 °C, $V_{DDS}$ = 3.0 V.

| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|---|---|---|---|---|---|
| Phase noise in the 868- and 915-MHz bands<br>150 kHz PLL loop bandwith | ±10 kHz offset | | -93 | | dBc/Hz |
| | ±100 kHz offset | | -93 | | dBc/Hz |
| | ±200 kHz offset | | -94 | | dBc/Hz |
| | ±400 kHz offset | | -104 | | dBc/Hz |
| | ±1000 kHz offset | | -121 | | dBc/Hz |
| | ±2000 kHz offset | | -130 | | dBc/Hz |
| | ±10000 kHz offset | | -140 | | dBc/Hz |

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## 8.14 359 MHz to 527 MHz - Receive (RX)

When measured on the LAUNCHXL-CC1352P-4 reference design with $T_c$ = 25 °C, $V_{DDS}$ = 3.0 V with DC/DC enabled unless otherwise noted. All measurements are performed at the antenna input with a combined RX and TX path. All measurements are performed conducted.

| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|---|---|---|---|---|---|
| **General Parameters** | | | | | |
| Spurious emissions 25 MHz to 1 GHz | 433.92 MHz<br>Conducted emissions measured according to ETSI EN 300 220 | | < -57 | | dBm |
| Spurious emissions 1 GHz to 13 GHz | | | < -47 | | dBm |
| **IEEE 802.15.4, 50 kbps, ±25 kHz Deviation, 2-GFSK, 78 kHz RX Bandwidth** | | | | | |
| Sensitivity | BER = $10^{-2}$, 433.92 MHz | | –110 | | dBm |
| Saturation limit | BER = $10^{-2}$, 433.92 MHz | | 10 | | dBm |
| Selectivity, +200 kHz | BER = $10^{-2}$, 433.92 MHz(1) | | 48 | | dB |
| Selectivity, -200 kHz | BER = $10^{-2}$, 433.92 MHz(1) | | 43 | | dB |
| Selectivity, +400 kHz | BER = $10^{-2}$, 433.92 MHz(1) | | 53 | | dB |
| Selectivity, -400 kHz | BER = $10^{-2}$, 433.92 MHz(1) | | 44 | | dB |
| Blocking, +1 MHz | BER = $10^{-2}$, 433.92 MHz(1) | | 60 | | dB |
| Blocking, -1 MHz | BER = $10^{-2}$, 433.92 MHz(1) | | 54 | | dB |
| Blocking, +2 MHz | BER = $10^{-2}$, 433.92 MHz(1) | | 62 | | dB |
| Blocking, -2 MHz | BER = $10^{-2}$, 433.92 MHz(1) | | 61 | | dB |
| Blocking, +10 MHz | BER = $10^{-2}$, 433.92 MHz(1) | | 75 | | dB |
| Blocking, -10 MHz | BER = $10^{-2}$, 433.92 MHz(1) | | 75 | | dB |
| Image rejection (image compensation enabled) | BER = $10^{-2}$, 433.92 MHz(1) | | 44 | | dB |
| RSSI dynamic range | Starting from the sensitivity limit | | 95 | | dB |
| RSSI accuracy | Starting from the sensitivity limit across the given dynamic range | | ±3 | | dB |
| **200 kbps, ±50 kHz Deviation, 2-GFSK, 273 kHz RX Bandwidth** | | | | | |
| Sensitivity | BER = $10^{-2}$, 433.92 MHz | | –104 | | dBm |
| Saturation limit | BER = $10^{-2}$, 433.92 MHz | | 10 | | dBm |
| Selectivity, ±400 kHz | BER = $10^{-2}$, 433.92 MHz(1) | | 48 | | dB |
| Blocking, ±1 MHz | BER = $10^{-2}$, 433.92 MHz(1) | | 51 | | dB |
| Blocking, ±2 MHz | BER = $10^{-2}$, 433.92 MHz(1) | | 53 | | dB |
| Blocking, ±10 MHz | BER = $10^{-2}$, 433.92 MHz(1) | | 68 | | dB |
| Image rejection (image compensation enabled) | BER = $10^{-2}$, 433.92 MHz(1) | | 45 | | dB |
| RSSI dynamic range | Starting from the sensitivity limit | | 89 | | dB |
| RSSI accuracy | Starting from the sensitivity limit across the given dynamic range | | ±3 | | dB |
| **Narrowband, 4.8 kbps, ±2 kHz Deviation, 2-GFSK, 10.1 kHz RX Bandwidth** | | | | | |
| Sensitivity | BER = $10^{-2}$, 426.1 MHz | | –120 | | dBm |
| Saturation limit | BER = $10^{-2}$, 426.1 MHz | | 10 | | dBm |
| Selectivity, +12.5 kHz | BER = $10^{-2}$, 426.1 MHz(1) | | 53 | | dB |
| Selectivity, -12.5 kHz | BER = $10^{-2}$, 426.1 MHz(1) | | 52 | | dB |
| Selectivity, +25 kHz | BER = $10^{-2}$, 426.1 MHz(1) | | 53 | | dB |
| Selectivity, -25 kHz | BER = $10^{-2}$, 426.1 MHz(1) | | 52 | | dB |
| Blocking, +1 MHz | BER = $10^{-2}$, 426.1 MHz(1) | | 70 | | dB |
| Blocking, -1 MHz | BER = $10^{-2}$, 426.1 MHz(1) | | 66 | | dB |
| Blocking, +2 MHz | BER = $10^{-2}$, 426.1 MHz(1) | | 72 | | dB |


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## 8.14 359 MHz to 527 MHz - Receive (RX) (continued)

When measured on the LAUNCHXL-CC1352P-4 reference design with $T_c$ = 25 °C, $V_{DDS}$ = 3.0 V with DC/DC enabled unless otherwise noted. All measurements are performed at the antenna input with a combined RX and TX path. All measurements are performed conducted.

| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|---|---|---|---|---|---|
| Blocking, -2 MHz | BER = $10^{-2}$, 426.1 MHz(1) | | 70 | | dB |
| Blocking, +10 MHz | BER = $10^{-2}$, 426.1 MHz(1) | | 84 | | dB |
| Blocking, -10 MHz | BER = $10^{-2}$, 426.1 MHz(1) | | 84 | | dB |
| Image rejection (image compensation enabled) | BER = $10^{-2}$, 426.1 MHz(1) | | 44 | | dB |
| RSSI dynamic range | Starting from the sensitivity limit | | 102 | | dB |
| RSSI accuracy | Starting from the sensitivity limit across the given dynamic range | | ±3 | | dB |
| **4.8 kbps, OOK, 34.1 kHz RX Bandwidth** | | | | | |
| Sensitivity | BER = $10^{-2}$, 433.92 MHz | | -115 | | dBm |
| **SimpleLink™ Long Range, 2.5/5 kbps (20 ksps), ±5 kHz Deviation, 2-GFSK, 34 kHz RX Bandwidth, FEC = 1:2, DSSS = 1:4/1:2** | | | | | |
| Sensitivity | 2.5 kbps, BER = $10^{-2}$, 433.92 MHz | | -121 | | dBm |
| Sensitivity | 5 kbps, BER = $10^{-2}$, 433.92 MHz | | -119 | | dBm |
| Saturation limit | 5 kbps, BER = $10^{-2}$, 433.92 MHz | | 10 | | dBm |
| Selectivity, +100 kHz | 5 kbps, BER = $10^{-2}$, 433.92 MHz(1) | | 55 | | dB |
| Selectivity, -100 kHz | 5 kbps, BER = $10^{-2}$, 433.92 MHz(1) | | 53 | | dB |
| Blocking, +1 MHz | 5 kbps, BER = $10^{-2}$, 433.92 MHz(1) | | 69 | | dB |
| Blocking, -1 MHz | 5 kbps, BER = $10^{-2}$, 433.92 MHz(1) | | 65 | | dB |
| Blocking, +2 MHz | 5 kbps, BER = $10^{-2}$, 433.92 MHz(1) | | 71 | | dB |
| Blocking, -2 MHz | 5 kbps, BER = $10^{-2}$, 433.92 MHz(1) | | 70 | | dB |
| Blocking, +10 MHz | 5 kbps, BER = $10^{-2}$, 433.92 MHz(1) | | 84 | | dB |
| Blocking, -10 MHz | 5 kbps, BER = $10^{-2}$, 433.92 MHz(1) | | 84 | | dB |
| Image rejection (image compensation enabled) | 5 kbps, BER = $10^{-2}$, 433.92 MHz | | 49 | | dB |
| RSSI dynamic range | Starting from the sensitivity limit | | 101 | | dB |
| RSSI accuracy | Starting from the sensitivity limit across the given dynamic range | | ±3 | | dB |

(1) Wanted signal 3 dB above sensitivity limit

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## 8.15 359 MHz to 527 MHz - Transmit (TX)

When measured on the LAUNCHXL-CC1352P-4 reference design with $T_c$ = 25 °C, $V_{DDS}$ = 3.0 V with DC/DC enabled unless otherwise noted. All measurements are performed at the antenna input with a combined RX and TX path. All measurements are performed conducted. (1)

| PARAMETER | | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|---|---|---|---|---|---|---|
| **General parameters** | | | | | | |
| Max output power | | 433.92 MHz, without BOOST (VDDR = 1.7 V) | | 13 | | dBm |
| Output power programmable range | | 433.92 MHz, without BOOST (VDDR = 1.7 V) | | 24 | | dB |
| Output power variation over temperature | | +13 dBm setting. 433.92 MHz Over recommended temperature operating range | | ±1.5 | | dB |
| **Spurious emissions and harmonics** | | | | | | |
| Spurious emissions (excluding harmonics) (2) | 30 MHz to 1 GHz | +10 dBm setting ETSI restricted bands | | < -54 | | dBm |
| | | +10 dBm setting ETSI outside restricted bands | | < -36 | | dBm |
| | 1 GHz to 12.75 GHz (outside ETSI restricted bands) | +10 dBm setting measured in 1 MHz bandwidth (ETSI) | | < -30 | | dBm |
| Spurious emissions out-of-band, 429 MHz (2) | Outside the necessary requency band (ARIB T-67) | +10 dBm setting | | < -26 | | dBm |
| | 710 MHz to 900 MHz (ARIB T-67) | +10 dBm setting | | < -55 | | dBm |
| | 900 MHz to 915 MHz (ARIB T-67) | +10 dBm setting | | < -55 | | dBm |
| | 930 MHz to 1000 MHz (ARIB T-67) | +10 dBm setting | | < -55 | | dBm |
| | 1000 MHz to 1215 MHz (ARIB T-67) | +10 dBm setting | | < -45 | | dBm |
| | Above 1215 MHz (ARIB T-67) | +10 dBm setting | | < -30 | | dBm |
| Harmonics | Second harmonic | +13 dBm setting, 433 MHz | | < -36 | | dBm |
| Harmonics | Third harmonic | +13 dBm setting, 433 MHz | | < -30 | | dBm |
| Harmonics | Fourth harmonic | +13 dBm setting, 433 MHz | | < -30 | | dBm |
| Harmonics | Fifth harmonic | +13 dBm setting, 433 MHz | | < -30 | | dBm |

(1) Some combinations of frequency, data rate and modulation format requires use of external crystal load capacitors for regulatory compliance. More details can be found in the device errata.
(2) Suitable for systems targeting compliance with EN 300 220, EN 303 131, EN 303 204, FCC CFR47 Part 15, ARIB STD-T108.


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## 8.16 359 MHz to 527 MHz - PLL Phase Noise

When measured on the LAUNCHXL-CC1352P-4 reference design with $T_c$ = 25 °C, $V_{DDS}$ = 3.0 V.

| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|---|---|---|---|---|---|
| Phase noise in the 429 MHz band 200 kHz PLL loop bandwidth | ±10 kHz offset | | -103 | | dBc/Hz |
| | ±100 kHz offset | | -101 | | dBc/Hz |
| | ±200 kHz offset | | -101 | | dBc/Hz |
| | ±400 kHz offset | | -106 | | dBc/Hz |
| | ±1000 kHz offset | | -122 | | dBc/Hz |
| | ±2000 kHz offset | | -133 | | dBc/Hz |
| | ±10000 kHz offset | | -143 | | dBc/Hz |
| Phase noise in the 433 MHz band 20 kHz PLL loop bandwidth | ±10 kHz offset | | -86 | | dBc/Hz |
| | ±100 kHz offset | | -108 | | dBc/Hz |
| | ±200 kHz offset | | -115 | | dBc/Hz |
| | ±400 kHz offset | | -122 | | dBc/Hz |
| | ±1000 kHz offset | | -130 | | dBc/Hz |
| | ±2000 kHz offset | | -137 | | dBc/Hz |
| | ±10000 kHz offset | | -145 | | dBc/Hz |

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## 8.17 143 MHz to 176 MHz - Receive (RX)

When measured on the CC1352EM-XS169-XS24 reference design with $T_c$ = 25 °C, $V_{DDS}$ = 3.0 V with DC/DC enabled unless otherwise noted. All measurements are performed at the antenna input with a combined RX and TX path. All measurements are performed conducted.

| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|---|---|---|---|---|---|
| **General Parameters** | | | | | |
| Spurious emissions 25 MHz to 1 GHz | 169.44375 MHz<br>Conducted emissions measured according to ETSI EN 300 220 | | < -57 | | dBm |
| Spurious emissions 1 GHz to 13 GHz | | | < -47 | | dBm |
| **WMBUS N-MODE, 4.8 kbps, ±2.4 kHz Deviation, 2-GFSK, 10 kHz RX Bandwidth** | | | | | |
| Sensitivity 4.8 kbps ± 2.4 kHz | BER = $10^{-2}$, 169.40625 MHz | | –119 | | dBm |
| Saturation limit | BER = $10^{-2}$, 169.40625 MHz | | 10 | | dBm |
| Selectivity, +12.5 kHz (1) | BER = $10^{-2}$, 169.40625 MHz | | 51 | | dB |
| Selectivity, -12.5 kHz (1) | BER = $10^{-2}$, 169.40625 MHz | | 51 | | dB |
| Selectivity, +25 kHz (1) | BER = $10^{-2}$, 169.40625 MHz | | 52 | | dB |
| Selectivity, -25 kHz (1) | BER = $10^{-2}$, 169.40625 MHz | | 52 | | dB |
| Blocking, +1 MHz (1) | BER = $10^{-2}$, 169.40625 MHz | | 73 | | dB |
| Blocking, -1 MHz (1) | BER = $10^{-2}$, 169.40625 MHz | | 72 | | dB |
| Blocking, +2 MHz (1) | BER = $10^{-2}$, 169.40625 MHz | | 77 | | dB |
| Blocking, -2 MHz (1) | BER = $10^{-2}$, 169.40625 MHz | | 75 | | dB |
| Blocking, +10 MHz (1) | BER = $10^{-2}$, 169.40625 MHz | | 86 | | dB |
| Blocking, -10 MHz (1) | BER = $10^{-2}$, 169.40625 MHz | | 86 | | dB |
| Image rejection (image compensation enabled) (1) | BER = $10^{-2}$, 169.40625 MHz | | 46 | | dB |
| RSSI dynamic range | Starting from the sensitivity limit | | 91 | | dB |
| RSSI accuracy | Starting from the sensitivity limit across the given dynamic range | | ±3 | | dB |
| **WMBUS N-MODE, 2.4 kbps, ±2.4 kHz Deviation, 2-GFSK, 10 kHz RX Bandwidth** | | | | | |
| Sensitivity | BER = $10^{-2}$, 169.43125 MHz | | –121 | | dBm |
| Saturation limit | BER = $10^{-2}$, 169.43125 MHz | | 10 | | dBm |
| Selectivity, +12.5 kHz (1) | BER = $10^{-2}$, 169.43125 MHz | | 51 | | dB |
| Selectivity, -12.5 kHz (1) | BER = $10^{-2}$, 169.43125 MHz | | 51 | | dB |
| Selectivity, +25 kHz (1) | BER = $10^{-2}$, 169.43125 MHz | | 52 | | dB |
| Selectivity, -25 kHz (1) | BER = $10^{-2}$, 169.43125 MHz | | 52 | | dB |
| Blocking, +1 MHz (1) | BER = $10^{-2}$, 169.43125 MHz | | 74 | | dB |
| Blocking, -1 MHz (1) | BER = $10^{-2}$, 169.43125 MHz | | 73 | | dB |
| Blocking, +2 MHz (1) | BER = $10^{-2}$, 169.43125 MHz | | 78 | | dB |
| Blocking, -2 MHz (1) | BER = $10^{-2}$, 169.43125 MHz | | 77 | | dB |
| Blocking, +10 MHz (1) | BER = $10^{-2}$, 169.43125 MHz | | 88 | | dB |
| Blocking, -10 MHz (1) | BER = $10^{-2}$, 169.43125 MHz | | 87 | | dB |
| Image rejection (image compensation enabled) (1) | BER = $10^{-2}$, 169.43125 MHz | | 50 | | dB |
| RSSI dynamic range | Starting from the sensitivity limit | | 92 | | dB |
| RSSI accuracy | Starting from the sensitivity limit across the given dynamic range | | ±3 | | dB |

(1) Wanted signal 3 dB above sensitivity limit


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## 8.18 143 MHz to 176 MHz - Transmit (TX)

When measured on the CC1352EM-XS169-XS24 reference design with $T_c$ = 25 °C, $V_{DDS}$ = 3.0 V with DC/DC enabled unless otherwise noted. All measurements are performed at the antenna input with a combined RX and TX path. All measurements are performed conducted.

| PARAMETER | | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|---|---|---|---|---|---|---|
| **General parameters** | | | | | | |
| Min output power, Sub-1 GHz PA | Min output power, Sub-1 GHz PA | 169.44375 MHz, without BOOST (VDDR = 1.7 V), single ended configuration. | | -10 | | dBm |
| Max output power, Sub-1 GHz PA | | 169.44375 MHz, without BOOST (VDDR = 1.7 V), single ended configuration. | | 9 | | dBm |
| Adjacent channel power | | 0 dBm setting, 4.8 kbit/s, 169.44375 MHz, without BOOST (VDDR = 1.7 V), single ended configuration. | | -47 | | dBc |
| **Spurious emissions and harmonics** | | | | | | |
| Spurious emissions (excluding harmonics) (1) | 30 MHz to 1 GHz | 0 dBm setting, ETSI restricted bands. Measured in 100 kHz bandwidth | | < -54 | | dBm |
| | | 0 dBm setting, ETSI outside restricted bands | | < -36 | | dBm |
| | 1 GHz to 12.75 GHz (outside ETSI restricted bands) | 0 dBm setting, measured in 1 MHz bandwidth (ETSI) | | < -30 | | dBm |
| Harmonics | Second harmonic | 0 dBm setting, 169.44375 MHz | | < -36 | | dBm |
| Harmonics | Third harmonic | 0 dBm setting, 169.44375 MHz | | < -54 | | dBm |
| Harmonics | Fourth harmonic | 0 dBm setting, 169.44375 MHz | | < -54 | | dBm |
| Harmonics | Fifth harmonic | 0 dBm setting, 169.44375 MHz | | < -36 | | dBm |

(1) Suitable for systems targeting compliance with EN 300 220.

## 8.19 143 MHz to 176 MHz - PLL Phase Noise

When measured on the CC1312REM-XD7793 reference design with $T_c$ = 25 °C, $V_{DDS}$ = 3.0 V. PLL settings for narrowband operation is used.

| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|---|---|---|---|---|---|
| Phase noise in the 169 MHz band | ±10 kHz offset | | – 108 | | dBc/Hz |
| | ±100 kHz offset | | – 108 | | dBc/Hz |
| | ±200 kHz offset | | – 110 | | dBc/Hz |
| | ±400 kHz offset | | -114 | | dBc/Hz |
| | ±1000 kHz offset | | -131 | | dBc/Hz |
| | ±2000 kHz offset | | – 141 | | dBc/Hz |
| | ±10000 kHz offset | | -150 | | dBc/Hz |

## 8.20 Timing and Switching Characteristics

### 8.20.1 Reset Timing

| PARAMETER | MIN | TYP | MAX | UNIT |
|---|---|---|---|---|
| RESET_N low duration | 1 | | | µs |

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### 8.20.2 Wakeup Timing

Measured over operating free-air temperature with $V_{DDS}$ = 3.0 V (unless otherwise noted). The times listed here do not include software overhead.

| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|---|---|---|---|---|---|
| MCU, Reset to Active(1) | | | 850 - 3000 | | µs |
| MCU, Shutdown to Active(1) | | | 850 - 3000 | | µs |
| MCU, Standby to Active | | | 160 | | µs |
| MCU, Active to Standby | | | 36 | | µs |
| MCU, Idle to Active | | | 14 | | µs |

(1) The wakeup time is dependent on remaining charge on VDDR capacitor when starting the device, and thus how long the device has been in Reset or Shutdown before starting up again.


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## 8.20.3 Clock Specifications

### 8.20.3.1 48 MHz Clock Input (TCXO)

Measured on a Texas Instruments reference design with $T_c$ = 25 °C, $V_{DDS}$ = 3.0 V, unless otherwise noted.(1) (2)

| | PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|---|---|---|---|---|---|---|
| | Clock frequency | | | 48 | | MHz |
| | TCXO clipped sine output, peak-to-peak | TCXO clipped sine output connected to pin X48M_P through series capacitor | 0.8 | | 1.7 | V |
| | TCXO with CMOS output, High input voltage | TCXO with CMOS output directly coupled to pin X48M_P | 1.3 | | VDDR | V |
| | TCXO with CMOS output, Low input voltage | | 0 | | 0.3 | V |

(1) Probing or otherwise stopping the TCXO while the DC/DC converter is enabled may cause permanent damage to the device.
(2) See CC13xx/CC26xx Hardware Configuration and PCB Design Considerations on how to add TCXO support

### 8.20.3.2 48 MHz Crystal Oscillator (XOSC_HF)

Measured on a Texas Instruments reference design with $T_c$ = 25 °C, $V_{DDS}$ = 3.0 V, unless otherwise noted.(1)

| | PARAMETER | MIN | TYP | MAX | UNIT |
|---|---|---|---|---|---|
| | Crystal frequency | | 48 | | MHz |
| ESR | Equivalent series resistance<br>6 pF < $C_L$ ⩽ 9 pF | | 20 | 60 | Ω |
| ESR | Equivalent series resistance<br>5 pF < $C_L$ ⩽ 6 pF | | | 80 | Ω |
| $L_M$ | Motional inductance, relates to the load capacitance that is used for the crystal ($C_L$ in Farads)(5) | | < $3 \times 10^{-25} / C_L^2$ | | H |
| $C_L$ | Crystal load capacitance(4) | 5 | 7(3) | 9 | pF |
| | Start-up time(2) | | 200 | | µs |

(1) Probing or otherwise stopping the crystal while the DC/DC converter is enabled may cause permanent damage to the device.
(2) Start-up time using the TI-provided power driver. Start-up time may increase if driver is not used.
(3) On-chip default connected capacitance including reference design parasitic capacitance. Connected internal capacitance is changed through software in the Customer Configuration section (CCFG).
(4) Adjustable load capacitance is integrated into the device. External load capacitors are required for systems targeting compliance with certain regulations. See the device errata for further details.
(5) The crystal manufacturer's specification must satisfy this requirement for proper operation.

### 8.20.3.3 48 MHz RC Oscillator (RCOSC_HF)

Measured on a Texas Instruments reference design with $T_c$ = 25 °C, $V_{DDS}$ = 3.0 V, unless otherwise noted.

| | MIN | TYP | MAX | UNIT |
|---|---|---|---|---|
| Frequency | | 48 | | MHz |
| Uncalibrated frequency accuracy | | ±1 | | % |
| Calibrated frequency accuracy(1) | | ±0.25 | | % |
| Start-up time | | 5 | | µs |

(1) Accuracy relative to the calibration source (XOSC_HF)

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### 8.20.3.4 2 MHz RC Oscillator (RCOSC_MF)

Measured on a Texas Instruments reference design with $T_c$ = 25 °C, $V_{DDS}$ = 3.0 V, unless otherwise noted.

| | MIN | TYP | MAX | UNIT |
|---|---|---|---|---|
| Calibrated frequency | | 2 | | MHz |
| Start-up time | | 5 | | µs |

### 8.20.3.5 32.768 kHz Crystal Oscillator (XOSC_LF)

Measured on a Texas Instruments reference design with $T_c$ = 25 °C, $V_{DDS}$ = 3.0 V, unless otherwise noted.

| | | MIN | TYP | MAX | UNIT |
|---|---|---|---|---|---|
| | Crystal frequency | | 32.768 | | kHz |
| ESR | Equivalent series resistance | | 30 | 100 | kΩ |
| $C_L$ | Crystal load capacitance | 6 | 7(1) | 12 | pF |

(1) Default load capacitance using TI reference designs including parasitic capacitance. Crystals with different load capacitance may be used.

### 8.20.3.6 32 kHz RC Oscillator (RCOSC_LF)

Measured on a Texas Instruments reference design with $T_c$ = 25 °C, $V_{DDS}$ = 3.0 V, unless otherwise noted.

| | MIN | TYP | MAX | UNIT |
|---|---|---|---|---|
| Calibrated frequency | | 32.8 (1) | | kHz |
| Temperature coefficient. | | 50 | | ppm/°C |

(1) When using RCOSC_LF as source for the low frequency system clock (SCLK_LF), the accuracy of the SCLK_LF-derived Real Time Clock (RTC) can be improved by measuring RCOSC_LF relative to XOSC_HF and compensating for the RTC tick speed. This functionality is available through the TI-provided Power driver.


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## 8.20.4 Synchronous Serial Interface (SSI) Characteristics

### *8.20.4.1 Synchronous Serial Interface (SSI) Characteristics*

over operating free-air temperature range (unless otherwise noted)

| PARAMETER NO. | PARAMETER | | MIN | TYP | MAX | UNIT |
|---|---|---|---|---|---|---|
| S1 | $t_{clk_per}$ | SSIClk cycle time | 12 | | 65024 | System Clocks (2) |
| S2(1) | $t_{clk_high}$ | SSIClk high time | | 0.5 | | $t_{clk_per}$ |
| S3(1) | $t_{clk_low}$ | SSIClk low time | | 0.5 | | $t_{clk_per}$ |

(1) Refer to SSI timing diagrams 图 8-1, 图 8-2, and 图 8-3
(2) When using the TI-provided Power driver, the SSI system clock is always 48 MHz.

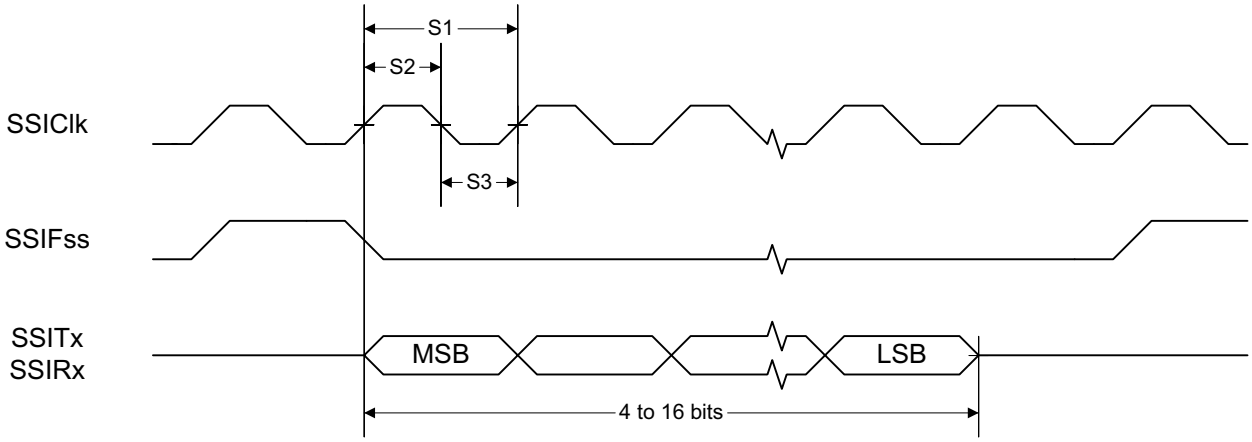



**图 8-1. SSI Timing for TI Frame Format (FRF = 01), Single Transfer Timing Measurement**

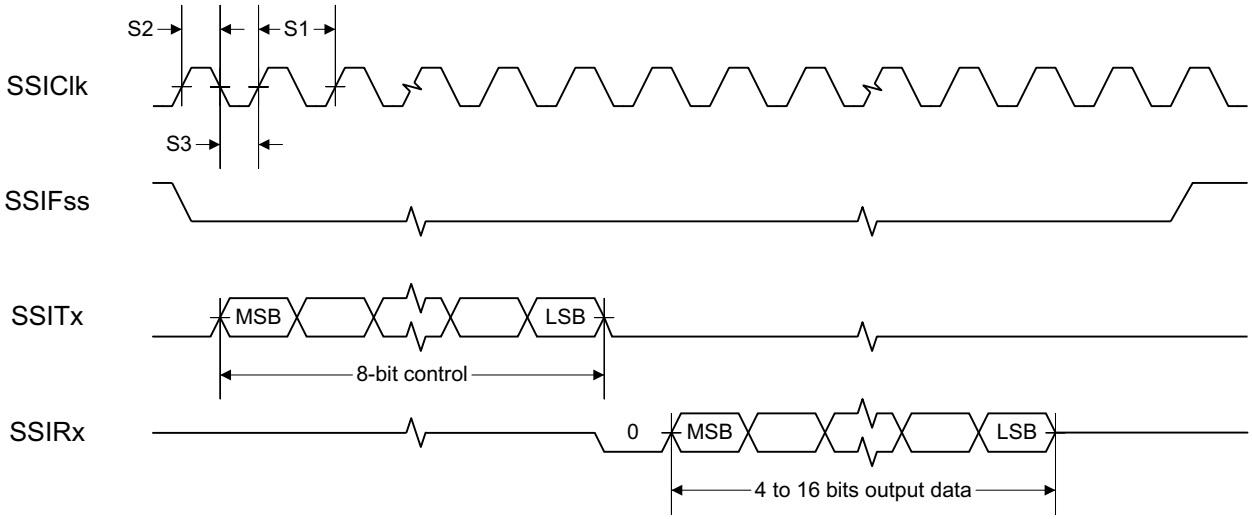



**图 8-2. SSI Timing for MICROWIRE Frame Format (FRF = 10), Single Transfer**

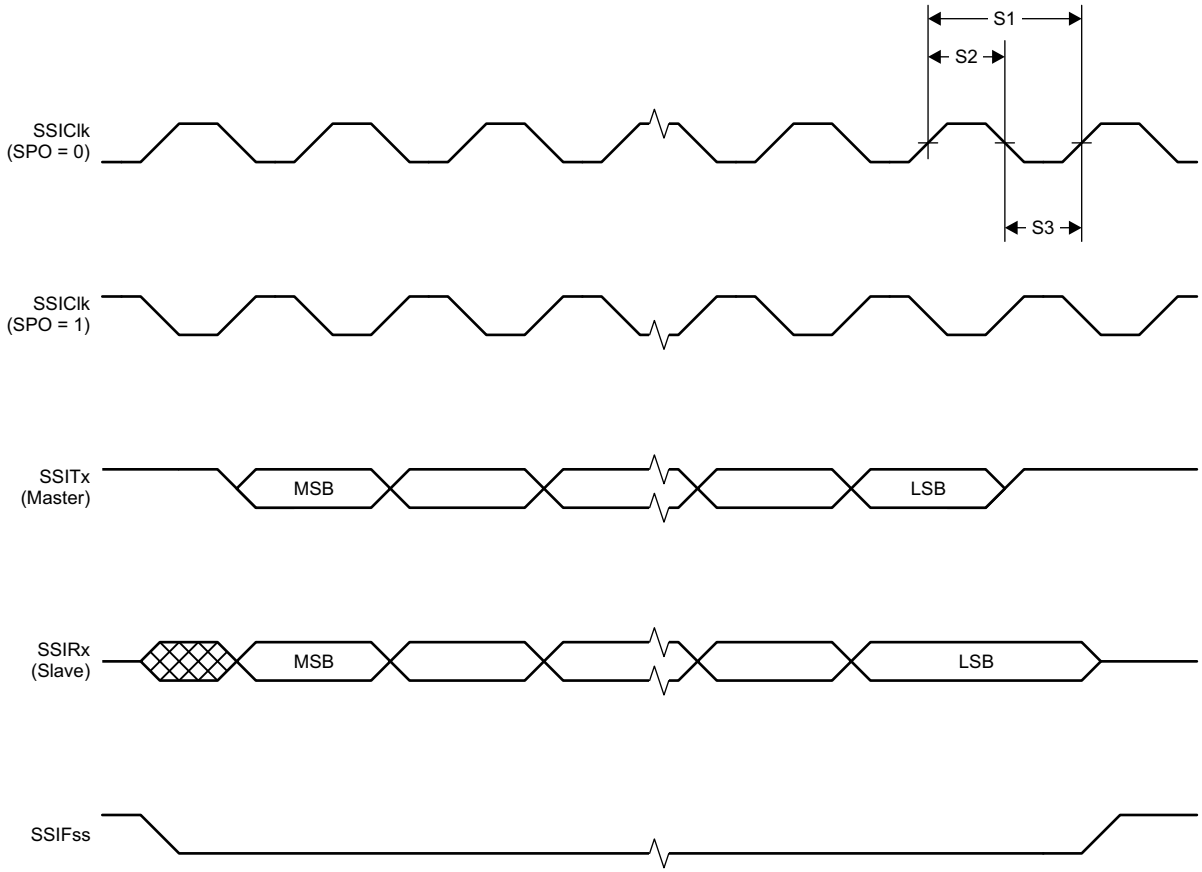



**图 8-3. SSI Timing for SPI Frame Format (FRF = 00), With SPH = 1**

## 8.20.5 UART

### *8.20.5.1 UART Characteristics*

over operating free-air temperature range (unless otherwise noted)

| PARAMETER | MIN | TYP | MAX | UNIT |
|---|---|---|---|---|
| UART rate | | | 3 | MBaud |


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## 8.21 Peripheral Characteristics

### 8.21.1 ADC

#### *8.21.1.1 Analog-to-Digital Converter (ADC) Characteristics*

$T_c$ = 25 °C, $V_{DDS}$ = 3.0 V and voltage scaling enabled, unless otherwise noted.(1)
Performance numbers require use of offset and gain adjustements in software by TI-provided ADC drivers.

| PARAMETER | | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|---|---|---|---|---|---|---|
| | Input voltage range | | 0 | | VDDS | V |
| | Resolution | | | 12 | | Bits |
| | Sample Rate | | | | 200 | ksps |
| | Offset | Internal 4.3 V equivalent reference(2) | | –0.24 | | LSB |
| | Gain error | Internal 4.3 V equivalent reference(2) | | 7.14 | | LSB |
| DNL(4) | Differential nonlinearity | | | > –1 | | LSB |
| INL | Integral nonlinearity | | | ±4 | | LSB |
| ENOB | Effective number of bits | Internal 4.3 V equivalent reference(2), 200 kSamples/s, 9.6 kHz input tone | | 9.8 | | Bits |
| | | Internal 4.3 V equivalent reference(2), 200 kSamples/s, 9.6 kHz input tone, DC/DC enabled | | 9.8 | | |
| | | VDDS as reference, 200 kSamples/s, 9.6 kHz input tone | | 10.1 | | |
| | | Internal reference, voltage scaling disabled, 32 samples average, 200 kSamples/s, 300 Hz input tone | | 11.1 | | |
| | | Internal reference, voltage scaling disabled, 14-bit mode, 200 kSamples/s, 600 Hz input tone (5) | | 11.3 | | |
| | | Internal reference, voltage scaling disabled, 15-bit mode, 200 kSamples/s, 150 Hz input tone (5) | | 11.6 | | |
| THD | Total harmonic distortion | Internal 4.3 V equivalent reference(2), 200 kSamples/s, 9.6 kHz input tone | | –65 | | dB |
| | | VDDS as reference, 200 kSamples/s, 9.6 kHz input tone | | –70 | | |
| | | Internal reference, voltage scaling disabled, 32 samples average, 200 kSamples/s, 300 Hz input tone | | –72 | | |
| SINAD, SNDR | Signal-to-noise and distortion ratio | Internal 4.3 V equivalent reference(2), 200 kSamples/s, 9.6 kHz input tone | | 60 | | dB |
| | | VDDS as reference, 200 kSamples/s, 9.6 kHz input tone | | 63 | | |
| | | Internal reference, voltage scaling disabled, 32 samples average, 200 kSamples/s, 300 Hz input tone | | 68 | | |
| SFDR | Spurious-free dynamic range | Internal 4.3 V equivalent reference(2), 200 kSamples/s, 9.6 kHz input tone | | 70 | | dB |
| | | VDDS as reference, 200 kSamples/s, 9.6 kHz input tone | | 73 | | |
| | | Internal reference, voltage scaling disabled, 32 samples average, 200 kSamples/s, 300 Hz input tone | | 75 | | |
| | Conversion time | Serial conversion, time-to-output, 24 MHz clock | | 50 | | Clock Cycles |
| | Current consumption | Internal 4.3 V equivalent reference(2) | | 0.42 | | mA |
| | Current consumption | VDDS as reference | | 0.6 | | mA |

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### 8.21.1.1 Analog-to-Digital Converter (ADC) Characteristics (continued)

$T_c$ = 25 °C, $V_{DDS}$ = 3.0 V and voltage scaling enabled, unless otherwise noted.(1)
Performance numbers require use of offset and gain adjustements in software by TI-provided ADC drivers.

| PARAMETER | | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|---|---|---|---|---|---|---|
| | Reference voltage | Equivalent fixed internal reference (input voltage scaling enabled). For best accuracy, the ADC conversion should be initiated through the TI-RTOS API in order to include the gain/offset compensation factors stored in FCFG1 | | 4.3(2) (3) | | V |
| | Reference voltage | Fixed internal reference (input voltage scaling disabled). For best accuracy, the ADC conversion should be initiated through the TI-RTOS API in order to include the gain/offset compensation factors stored in FCFG1. This value is derived from the scaled value (4.3 V) as follows: $V_{ref}$ = 4.3 V × 1408 / 4095 | | 1.48 | | V |
| | Reference voltage | VDDS as reference, input voltage scaling enabled | | VDDS | | V |
| | Reference voltage | VDDS as reference, input voltage scaling disabled | | VDDS / 2.82(3) | | V |
| | Input impedance | 200 kSamples/s, voltage scaling enabled. Capacitive input, Input impedance depends on sampling frequency and sampling time | | >1 | | MΩ |

(1) Using IEEE Std 1241-2010 for terminology and test methods
(2) Input signal scaled down internally before conversion, as if voltage range was 0 to 4.3 V
(3) Applied voltage must be within Absolute Maximum Ratings (see 节 8.1) at all times
(4) No missing codes
(5) ADC_output = Σ(4$^n$ samples ) >> n, n = desired extra bits


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## 8.21.2 DAC

### *8.21.2.1 Digital-to-Analog Converter (DAC) Characteristics*

$T_c$ = 25 °C, $V_{DDS}$ = 3.0 V, unless otherwise noted.

| PARAMETER | | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|---|---|---|---|---|---|---|
| **General Parameters** | | | | | | |
| | Resolution | | | 8 | | Bits |
| $V_{DDS}$ | Supply voltage | Any load, any $V_{REF}$, pre-charge OFF, DAC charge-pump ON | 1.8 | | 3.8 | V |
| | | External Load[4], any $V_{REF}$, pre-charge OFF, DAC charge-pump OFF | 2.0 | | 3.8 | |
| | | Any load, $V_{REF}$ = DCOUPL, pre-charge ON | 2.6 | | 3.8 | |
| $F_{DAC}$ | Clock frequency | Buffer ON (recommended for external load) | 16 | | 250 | kHz |
| | | Buffer OFF (internal load) | 16 | | 1000 | |
| | Voltage output settling time | $V_{REF}$ = VDDS, buffer OFF, internal load | | 13 | | 1 / $F_{DAC}$ |
| | | $V_{REF}$ = VDDS, buffer ON, external capacitive load = 20 pF[3] | | 13.8 | | |
| | External capacitive load | | | 20 | 200 | pF |
| | External resistive load | | 10 | | | MΩ |
| | Short circuit current | | | | 400 | µA |
| $Z_{MAX}$ | Max output impedance Vref = VDDS, buffer ON, CLK 250 kHz | VDDS = 3.8 V, DAC charge-pump OFF | | 50.8 | | kΩ |
| | | VDDS = 3.0 V, DAC charge-pump ON | | 51.7 | | |
| | | VDDS = 3.0 V, DAC charge-pump OFF | | 53.2 | | |
| | | VDDS = 2.0 V, DAC charge-pump ON | | 48.7 | | |
| | | VDDS = 2.0 V, DAC charge-pump OFF | | 70.2 | | |
| | | VDDS = 1.8 V, DAC charge-pump ON | | 46.3 | | |
| | | VDDS = 1.8 V, DAC charge-pump OFF | | 88.9 | | |
| **Internal Load - Continuous Time Comparator / Low Power Clocked Comparator** | | | | | | |
| DNL | Differential nonlinearity | $V_{REF}$ = VDDS, load = Continuous Time Comparator or Low Power Clocked Comparator $F_{DAC}$ = 250 kHz | | ±1 | | LSB[1] |
| | Differential nonlinearity | $V_{REF}$ = VDDS, load = Continuous Time Comparator or Low Power Clocked Comparator $F_{DAC}$ = 16 kHz | | ±1.2 | | |
| | Offset error[2] Load = Continuous Time Comparator | $V_{REF}$ = VDDS = 3.8 V | | ±0.64 | | LSB[1] |
| | | $V_{REF}$ = VDDS= 3.0 V | | ±0.81 | | |
| | | $V_{REF}$ = VDDS = 1.8 V | | ±1.27 | | |
| | | $V_{REF}$ = DCOUPL, pre-charge ON | | ±3.43 | | |
| | | $V_{REF}$ = DCOUPL, pre-charge OFF | | ±2.88 | | |
| | | $V_{REF}$ = ADCREF | | ±2.37 | | |
| | Offset error[2] Load = Low Power Clocked Comparator | $V_{REF}$ = VDDS= 3.8 V | | ±0.78 | | LSB[1] |
| | | $V_{REF}$ = VDDS = 3.0 V | | ±0.77 | | |
| | | $V_{REF}$ = VDDS= 1.8 V | | ±3.46 | | |
| | | $V_{REF}$ = DCOUPL, pre-charge ON | | ±3.44 | | |
| | | $V_{REF}$ = DCOUPL, pre-charge OFF | | ±4.70 | | |
| | | $V_{REF}$ = ADCREF | | ±4.11 | | |

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### 8.21.2.1 Digital-to-Analog Converter (DAC) Characteristics (continued)

$T_c$ = 25 °C, $V_{DDS}$ = 3.0 V, unless otherwise noted.

| PARAMETER | | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|---|---|---|---|---|---|---|
| | Max code output voltage variation[2] Load = Continuous Time Comparator | $V_{REF}$ = VDDS = 3.8 V | | ±1.53 | | LSB[1] |
| | | $V_{REF}$ = VDDS = 3.0 V | | ±1.71 | | |
| | | $V_{REF}$ = VDDS= 1.8 V | | ±2.10 | | |
| | | $V_{REF}$ = DCOUPL, pre-charge ON | | ±6.00 | | |
| | | $V_{REF}$ = DCOUPL, pre-charge OFF | | ±3.85 | | |
| | | $V_{REF}$ = ADCREF | | ±5.84 | | |
| | Max code output voltage variation[2] Load = Low Power Clocked Comparator | $V_{REF}$ = VDDS= 3.8 V | | ±2.92 | | LSB[1] |
| | | $V_{REF}$ =VDDS= 3.0 V | | ±3.06 | | |
| | | $V_{REF}$ = VDDS= 1.8 V | | ±3.91 | | |
| | | $V_{REF}$ = DCOUPL, pre-charge ON | | ±7.84 | | |
| | | $V_{REF}$ = DCOUPL, pre-charge OFF | | ±4.06 | | |
| | | $V_{REF}$ = ADCREF | | ±6.94 | | |
| | Output voltage range[2] Load = Continuous Time Comparator | $V_{REF}$ = VDDS = 3.8 V, code 1 | | 0.03 | | V |
| | | $V_{REF}$ = VDDS = 3.8 V, code 255 | | 3.62 | | |
| | | $V_{REF}$ = VDDS= 3.0 V, code 1 | | 0.02 | | |
| | | $V_{REF}$ = VDDS= 3.0 V, code 255 | | 2.86 | | |
| | | $V_{REF}$ = VDDS= 1.8 V, code 1 | | 0.01 | | |
| | | $V_{REF}$ = VDDS = 1.8 V, code 255 | | 1.71 | | |
| | | $V_{REF}$ = DCOUPL, pre-charge OFF, code 1 | | 0.01 | | |
| | | $V_{REF}$ = DCOUPL, pre-charge OFF, code 255 | | 1.21 | | |
| | | $V_{REF}$ = DCOUPL, pre-charge ON, code 1 | | 1.27 | | |
| | | $V_{REF}$ = DCOUPL, pre-charge ON, code 255 | | 2.46 | | |
| | | $V_{REF}$ = ADCREF, code 1 | | 0.01 | | |
| | | $V_{REF}$ = ADCREF, code 255 | | 1.41 | | |
| | Output voltage range[2] Load = Low Power Clocked Comparator | $V_{REF}$ = VDDS = 3.8 V, code 1 | | 0.03 | | V |
| | | $V_{REF}$ = VDDS= 3.8 V, code 255 | | 3.61 | | |
| | | $V_{REF}$ = VDDS= 3.0 V, code 1 | | 0.02 | | |
| | | $V_{REF}$ = VDDS= 3.0 V, code 255 | | 2.85 | | |
| | | $V_{REF}$ = VDDS = 1.8 V, code 1 | | 0.01 | | |
| | | $V_{REF}$ = VDDS = 1.8 V, code 255 | | 1.71 | | |
| | | $V_{REF}$ = DCOUPL, pre-charge OFF, code 1 | | 0.01 | | |
| | | $V_{REF}$ = DCOUPL, pre-charge OFF, code 255 | | 1.21 | | |
| | | $V_{REF}$ = DCOUPL, pre-charge ON, code 1 | | 1.27 | | |
| | | $V_{REF}$ = DCOUPL, pre-charge ON, code 255 | | 2.46 | | |
| | | $V_{REF}$ = ADCREF, code 1 | | 0.01 | | |
| | | $V_{REF}$ = ADCREF, code 255 | | 1.41 | | |
| **External Load (Keysight 34401A Multimeter)** | | | | | | |
| INL | Integral nonlinearity | $V_{REF}$ = VDDS, $F_{DAC}$ = 250 kHz | | ±1 | | LSB[1] |
| | | $V_{REF}$ = DCOUPL, $F_{DAC}$ = 250 kHz | | ±1 | | |
| | | $V_{REF}$ = ADCREF, $F_{DAC}$ = 250 kHz | | ±1 | | |
| DNL | Differential nonlinearity | $V_{REF}$ = VDDS, $F_{DAC}$ = 250 kHz | | ±1 | | LSB[1] |


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### 8.21.2.1 Digital-to-Analog Converter (DAC) Characteristics (continued)

$T_c$ = 25 °C, $V_{DDS}$ = 3.0 V, unless otherwise noted.

| PARAMETER | | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|---|---|---|---|---|---|---|
| | Offset error | $V_{REF}$ = VDDS= 3.8 V | | ±0.20 | | LSB(1) |
| | | $V_{REF}$ = VDDS= 3.0 V | | ±0.25 | | |
| | | $V_{REF}$ = VDDS = 1.8 V | | ±0.45 | | |
| | | $V_{REF}$ = DCOUPL, pre-charge ON | | ±1.55 | | |
| | | $V_{REF}$ = DCOUPL, pre-charge OFF | | ±1.30 | | |
| | | $V_{REF}$ = ADCREF | | ±1.10 | | |
| | Max code output voltage variation | $V_{REF}$ = VDDS= 3.8 V | | ±0.60 | | LSB(1) |
| | | $V_{REF}$ = VDDS= 3.0 V | | ±0.55 | | |
| | | $V_{REF}$ = VDDS= 1.8 V | | ±0.60 | | |
| | | $V_{REF}$ = DCOUPL, pre-charge ON | | ±3.45 | | |
| | | $V_{REF}$ = DCOUPL, pre-charge OFF | | ±2.10 | | |
| | | $V_{REF}$ = ADCREF | | ±1.90 | | |
| | Output voltage range Load = Low Power Clocked Comparator | $V_{REF}$ = VDDS = 3.8 V, code 1 | | 0.03 | | V |
| | | $V_{REF}$ = VDDS = 3.8 V, code 255 | | 3.61 | | |
| | | $V_{REF}$ = VDDS = 3.0 V, code 1 | | 0.02 | | |
| | | $V_{REF}$ = VDDS= 3.0 V, code 255 | | 2.85 | | |
| | | $V_{REF}$ = VDDS= 1.8 V, code 1 | | 0.02 | | |
| | | $V_{REF}$ = VDDS = 1.8 V, code 255 | | 1.71 | | |
| | | $V_{REF}$ = DCOUPL, pre-charge OFF, code 1 | | 0.02 | | |
| | | $V_{REF}$ = DCOUPL, pre-charge OFF, code 255 | | 1.20 | | |
| | | $V_{REF}$ = DCOUPL, pre-charge ON, code 1 | | 1.27 | | |
| | | $V_{REF}$ = DCOUPL, pre-charge ON, code 255 | | 2.46 | | |
| | | $V_{REF}$ = ADCREF, code 1 | | 0.02 | | |
| | | $V_{REF}$ = ADCREF, code 255 | | 1.42 | | |

(1) 1 LSB ($V_{REF}$ 3.8 V/3.0 V/1.8 V/DCOUPL/ADCREF) = 14.10 mV/11.13 mV/6.68 mV/4.67 mV/5.48 mV
(2) Includes comparator offset
(3) A load > 20 pF will increases the settling time
(4) Keysight 34401A Multimeter

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## 8.21.3 Temperature and Battery Monitor

### *8.21.3.1 Temperature Sensor*

Measured on a Texas Instruments reference design with $T_c$ = 25 °C, $V_{DDS}$ = 3.0 V, unless otherwise noted.

| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|---|---|---|---|---|---|
| Resolution | | | 2 | | °C |
| Accuracy | -40 °C to 0 °C | | ±4.0 | | °C |
| Accuracy | 0 °C to 105 °C | | ±2.5 | | °C |
| Supply voltage coefficient(1) | | | 3.6 | | °C/V |

(1) The temperature sensor is automatically compensated for VDDS variation when using the TI-provided driver.

### *8.21.3.2 Battery Monitor*

Measured on a Texas Instruments reference design with $T_c$ = 25 °C, unless otherwise noted.

| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|---|---|---|---|---|---|
| Resolution | | | 25 | | mV |
| Range | | 1.8 | | 3.8 | V |
| Integral nonlinearity (max) | | | 23 | | mV |
| Accuracy | VDDS = 3.0 V | | 22.5 | | mV |
| Offset error | | | -32 | | mV |
| Gain error | | | -1 | | % |


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## 8.21.4 Comparators

### 8.21.4.1 Low-Power Clocked Comparator

$T_c$ = 25 °C, $V_{DDS}$ = 3.0 V, unless otherwise noted.

| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|---|---|---|---|---|---|
| Input voltage range | | 0 | | $V_{DDS}$ | V |
| Clock frequency | | | SCLK_LF | | |
| Internal reference voltage(1) | Using internal DAC with VDDS as reference voltage, DAC code = 0 - 255 | | 0.024 - 2.865 | | V |
| Offset | Measured at $V_{DDS}$ / 2, includes error from internal DAC | | ±5 | | mV |
| Decision time | Step from –50 mV to 50 mV | | 1 | | Clock Cycle |

(1) The comparator can use an internal 8 bits DAC as its reference. The DAC output voltage range depends on the reference voltage selected. See 节 8.21.2.1

### 8.21.4.2 Continuous Time Comparator

$T_c$ = 25°C, $V_{DDS}$ = 3.0 V, unless otherwise noted.

| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|---|---|---|---|---|---|
| Input voltage range(1) | | 0 | | $V_{DDS}$ | V |
| Offset | Measured at $V_{DDS}$ / 2 | | ±5 | | mV |
| Decision time | Step from –10 mV to 10 mV | | 0.78 | | µs |
| Current consumption | Internal reference | | 8.6 | | µA |

(1) The input voltages can be generated externally and connected throughout I/Os or an internal reference voltage can be generated using the DAC

## 8.21.5 Current Source

### 8.21.5.1 Programmable Current Source

$T_c$ = 25 °C, $V_{DDS}$ = 3.0 V, unless otherwise noted.

| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|---|---|---|---|---|---|
| Current source programmable output range (logarithmic range) | | | 0.25 - 20 | | µA |
| Resolution | | | 0.25 | | µA |

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## 8.21.6 GPIO

### *8.21.6.1 GPIO DC Characteristics*

| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|---|---|---|---|---|---|
| **$T_A$ = 25 °C, $V_{DDS}$ = 1.8 V** | | | | | |
| GPIO VOH at 8 mA load | IOCURR = 2, high-drive GPIOs only | | 1.56 | | V |
| GPIO VOL at 8 mA load | IOCURR = 2, high-drive GPIOs only | | 0.24 | | V |
| GPIO VOH at 4 mA load | IOCURR = 1 | | 1.59 | | V |
| GPIO VOL at 4 mA load | IOCURR = 1 | | 0.21 | | V |
| GPIO pullup current | Input mode, pullup enabled, Vpad = 0 V | | 73 | | µA |
| GPIO pulldown current | Input mode, pulldown enabled, Vpad = VDDS | | 19 | | µA |
| GPIO low-to-high input transition, with hysteresis | IH = 1, transition voltage for input read as 0 → 1 | | 1.08 | | V |
| GPIO high-to-low input transition, with hysteresis | IH = 1, transition voltage for input read as 1 → 0 | | 0.73 | | V |
| GPIO input hysteresis | IH = 1, difference between 0 → 1 and 1 → 0 points | | 0.35 | | V |
| **$T_A$ = 25 °C, $V_{DDS}$ = 3.0 V** | | | | | |
| GPIO VOH at 8 mA load | IOCURR = 2, high-drive GPIOs only | | 2.59 | | V |
| GPIO VOL at 8 mA load | IOCURR = 2, high-drive GPIOs only | | 0.42 | | V |
| GPIO VOH at 4 mA load | IOCURR = 1 | | 2.63 | | V |
| GPIO VOL at 4 mA load | IOCURR = 1 | | 0.40 | | V |
| **$T_A$ = 25 °C, $V_{DDS}$ = 3.8 V** | | | | | |
| GPIO pullup current | Input mode, pullup enabled, Vpad = 0 V | | 282 | | µA |
| GPIO pulldown current | Input mode, pulldown enabled, Vpad = VDDS | | 110 | | µA |
| GPIO low-to-high input transition, with hysteresis | IH = 1, transition voltage for input read as 0 → 1 | | 1.97 | | V |
| GPIO high-to-low input transition, with hysteresis | IH = 1, transition voltage for input read as 1 → 0 | | 1.55 | | V |
| GPIO input hysteresis | IH = 1, difference between 0 → 1 and 1 → 0 points | | 0.42 | | V |
| **$T_A$ = 25 °C** | | | | | |
| VIH | Lowest GPIO input voltage reliably interpreted as a *High* | $0.8*V_{DDS}$ | | | V |
| VIL | Highest GPIO input voltage reliably interpreted as a *Low* | | | $0.2*V_{DDS}$ | V |


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## 8.22 Typical Characteristics

All measurements in this section are done with $T_c$ = 25 °C and $V_{DDS}$ = 3.0 V, unless otherwise noted. See *Recommended Operating Conditions* for device limits. Values exceeding these limits are for reference only.

### 8.22.1 MCU Current

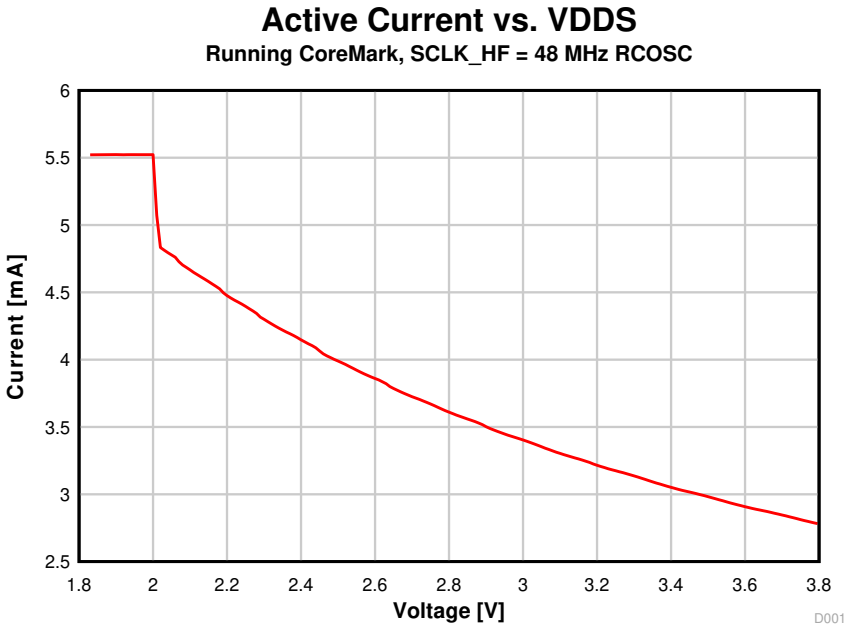



**图 8-4. Active Mode (MCU) Current vs. Supply Voltage (VDDS)**

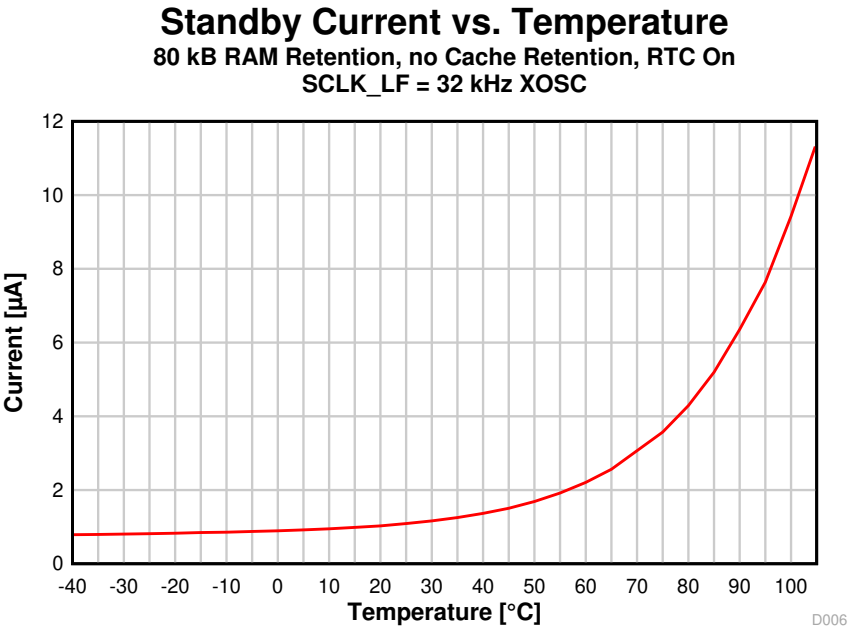



**图 8-5. Standby Mode (MCU) Current vs. Temperature**

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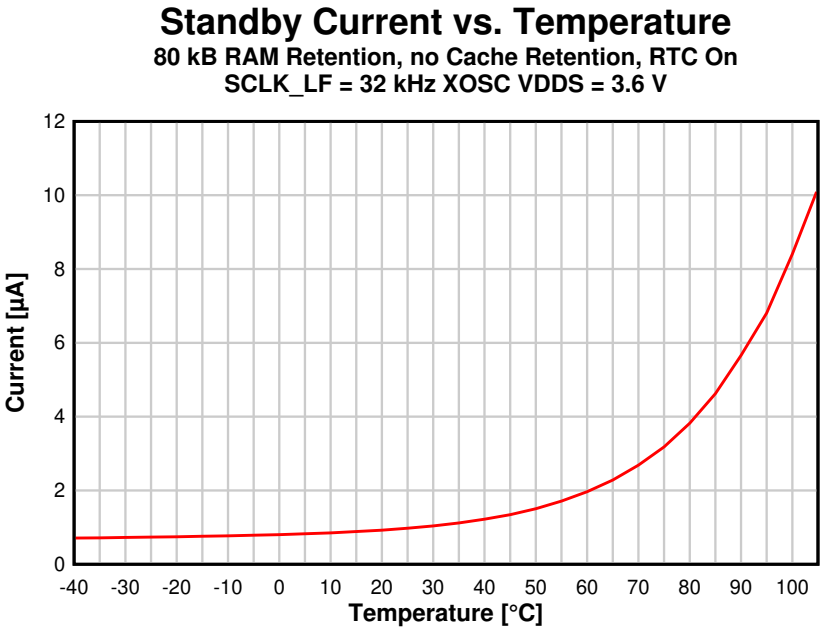



**图 8-6. Standby Mode (MCU) Current vs. Temperature (VDDS = 3.6 V)**


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### 8.22.2 RX Current

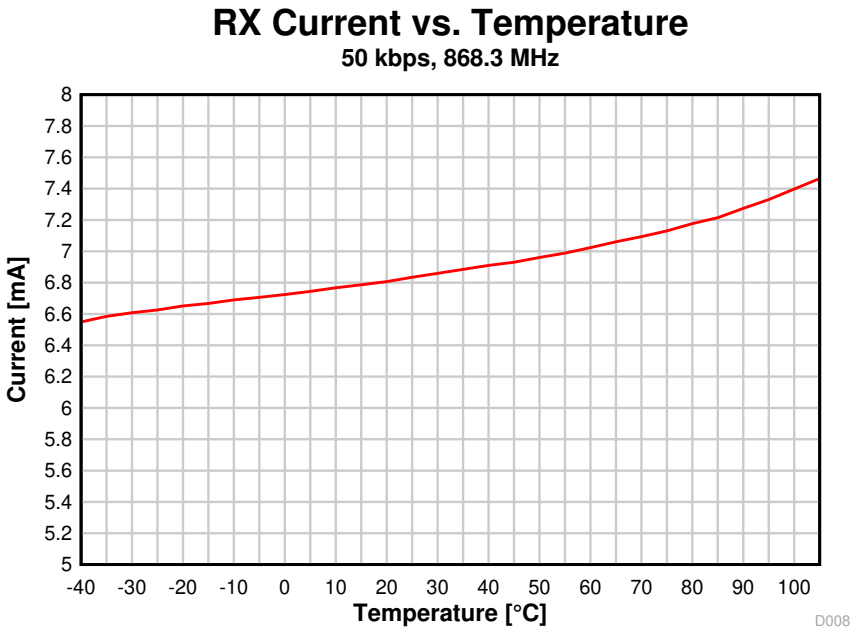



**图 8-7. RX Current vs. Temperature (50 kbps, 868.3 MHz)**

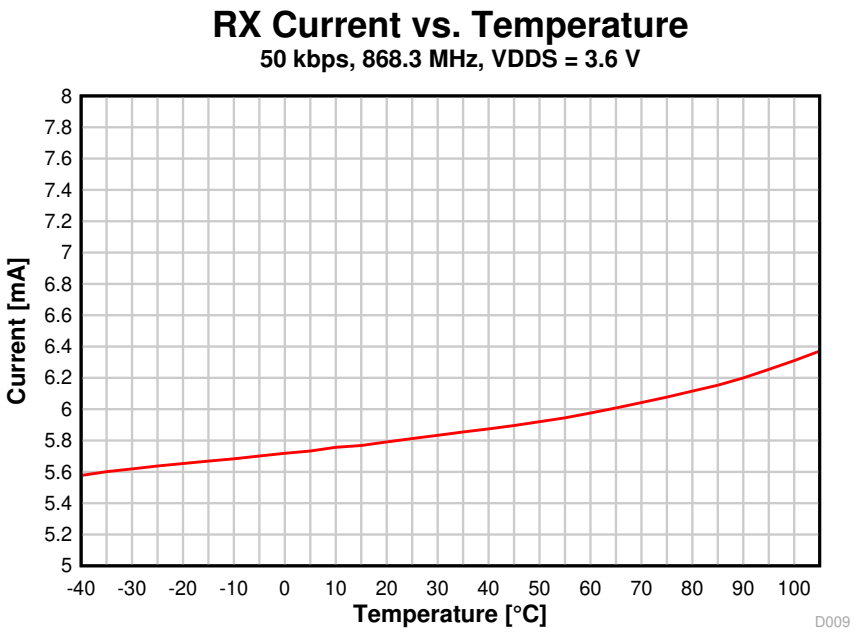



**图 8-8. RX Current vs. Temperature (50 kbps, 868.3 MHz, VDDS = 3.6 V)**

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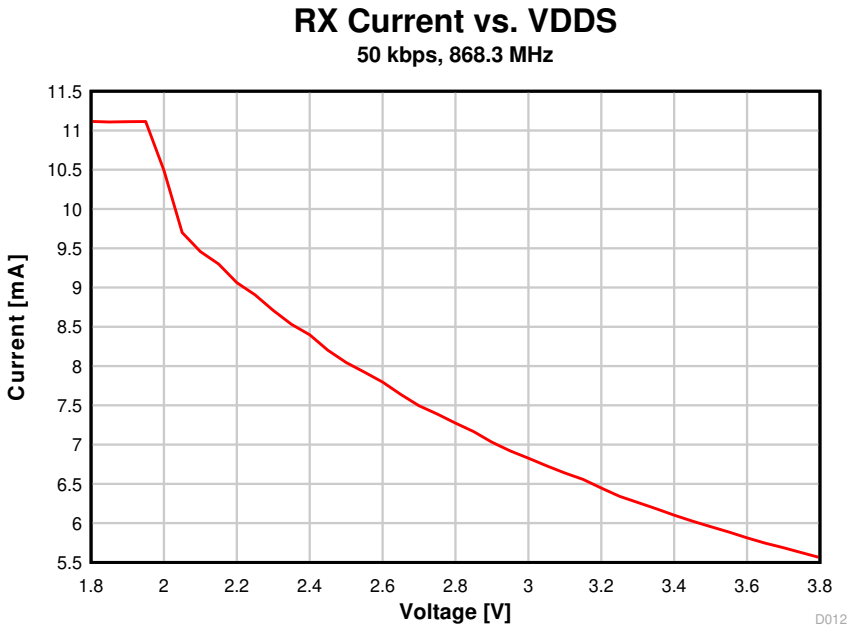



**图 8-9. RX Current vs. Supply Voltage (VDDS) (50 kbps, 868.3 MHz)**


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### 8.22.3 TX Current

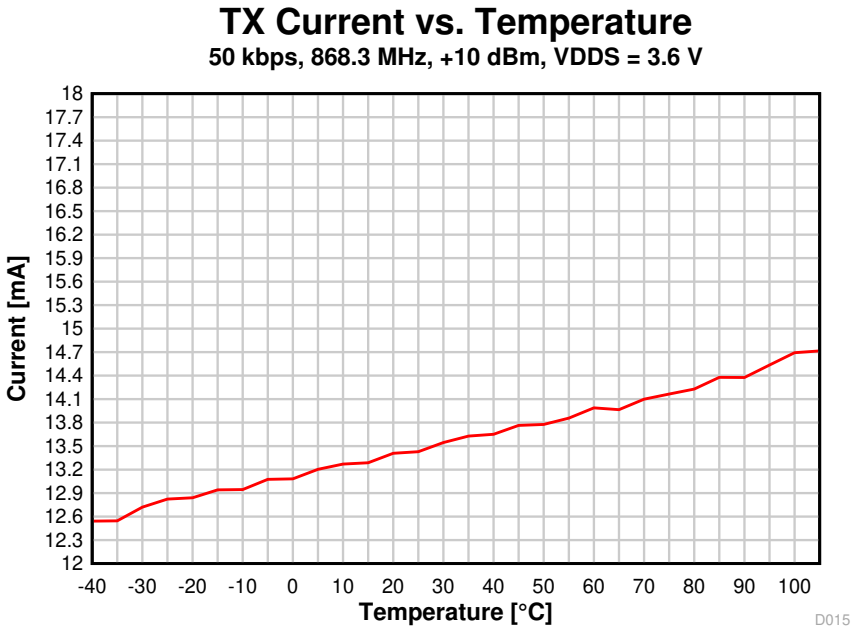



**图 8-10. TX Current vs. Temperature (50 kbps, 868.3 MHz, VDDS = 3.6 V)**

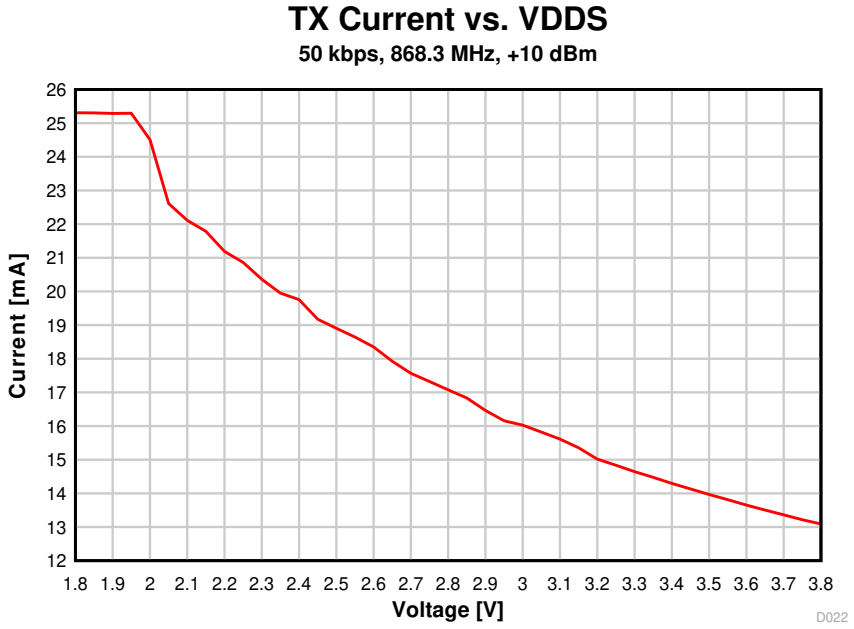



**图 8-11. TX Current vs. Supply Voltage (VDDS) (50 kbps, 868.3 MHz)**

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表 8-1 shows typical TX current and output power for different output power settings.

**表 8-1. Typical TX Current and Output Power**

| CC1312R at 915 MHz, VDDS = 3.6 V (Measured on CC1312REM-XD7793) | | | |
|---|---|---|---|
| **txPower** | **TX Power Setting (SmartRF Studio)** | **Typical Output Power [dBm]** | **Typical Current Consumption [mA]** |
| 0x013F | 14 | 14.3 | 25 |
| 0xB224 | 12.5 | 12.7 | 18.3 |
| 0xA410 | 12 | 12.2 | 17.4 |
| 0x669A | 11 | 11 | 15.8 |
| 0x3E92 | 10 | 10 | 14.2 |
| 0x3EDC | 9 | 8.8 | 13.3 |
| 0x2CD8 | 8 | 7.9 | 12.4 |
| 0x26D4 | 7 | 6.7 | 11.5 |
| 0x20D1 | 6 | 5.6 | 10.6 |
| 0x1CCE | 5 | 4.2 | 9.8 |
| 0x16CD | 4 | 3.4 | 9.4 |
| 0x14CB | 3 | 2.1 | 8.8 |
| 0x12CA | 2 | 1.3 | 8.4 |
| 0x12C9 | 1 | 0.4 | 8.0 |
| 0x10C8 | 0 | -0.7 | 7.7 |
| 0x0AC4 | -5 | -7 | 6.1 |
| 0x0AC2 | -10 | -12.8 | 5.4 |
| 0x06C1 | -15 | -17 | 5.0 |
| 0x04C0 | -20 | -23 | 4.7 |


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### 8.22.4 RX Performance

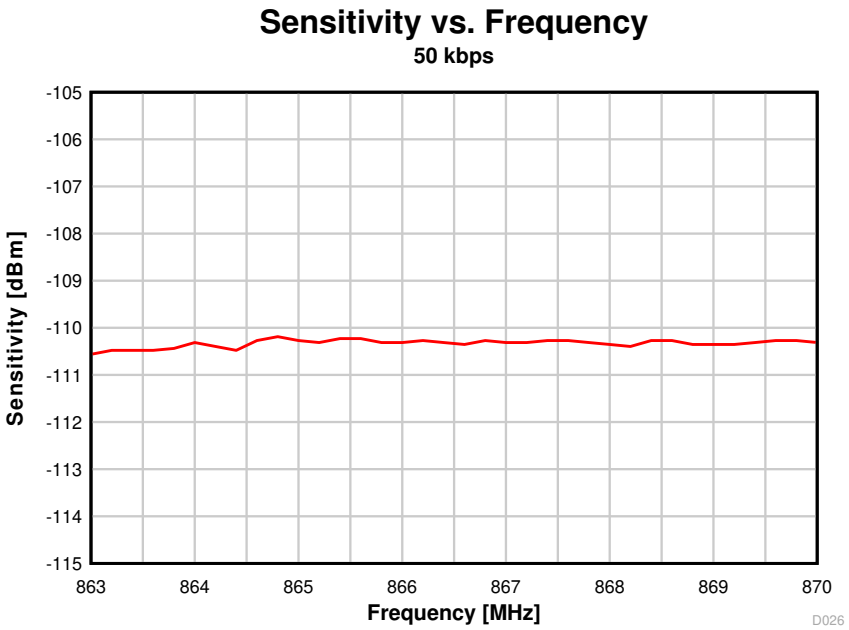



**图 8-12. Sensitivity vs. Frequency (50 kbps, 868 MHz)**

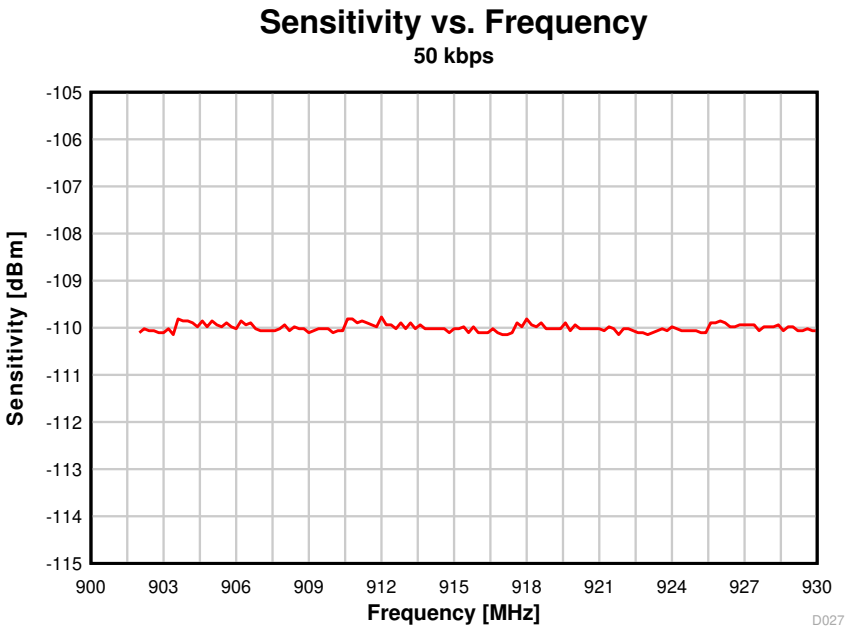



**图 8-13. Sensitivity vs. Frequency (50 kbps, 915 MHz)**

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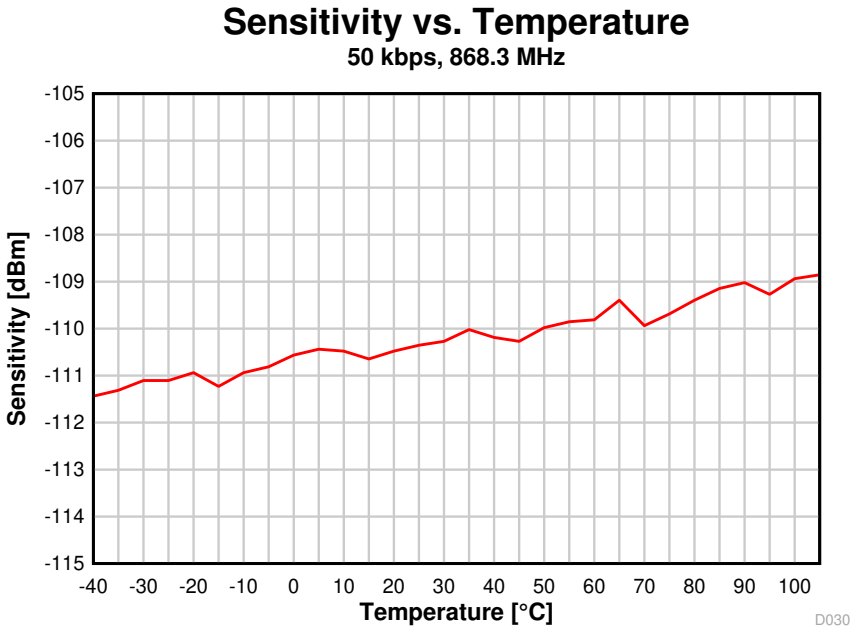



**图 8-14. Sensitivity vs. Temperature (50 kbps, 868.3 MHz)**

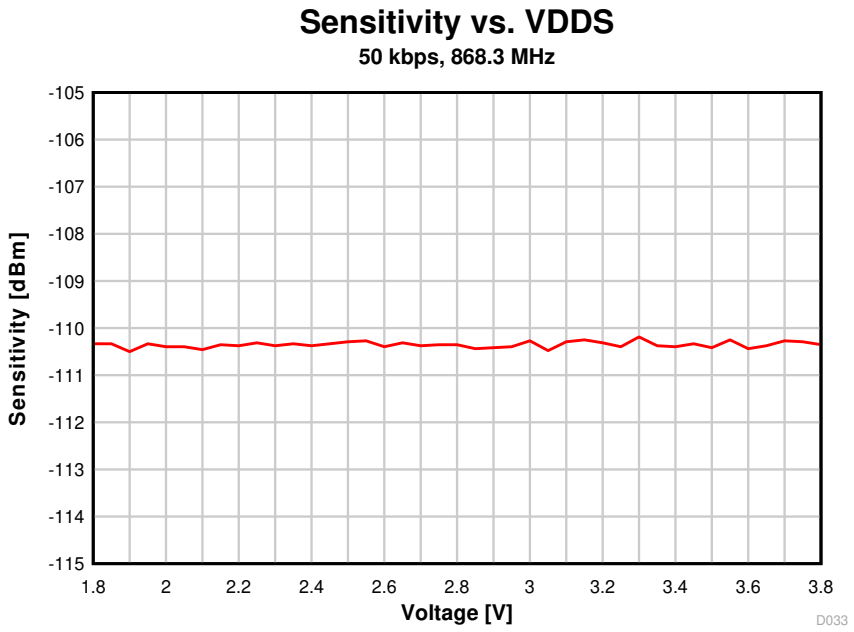



**图 8-15. Sensitivity vs. Supply Voltage (VDDS) (50 kbps, 868.3 MHz)**


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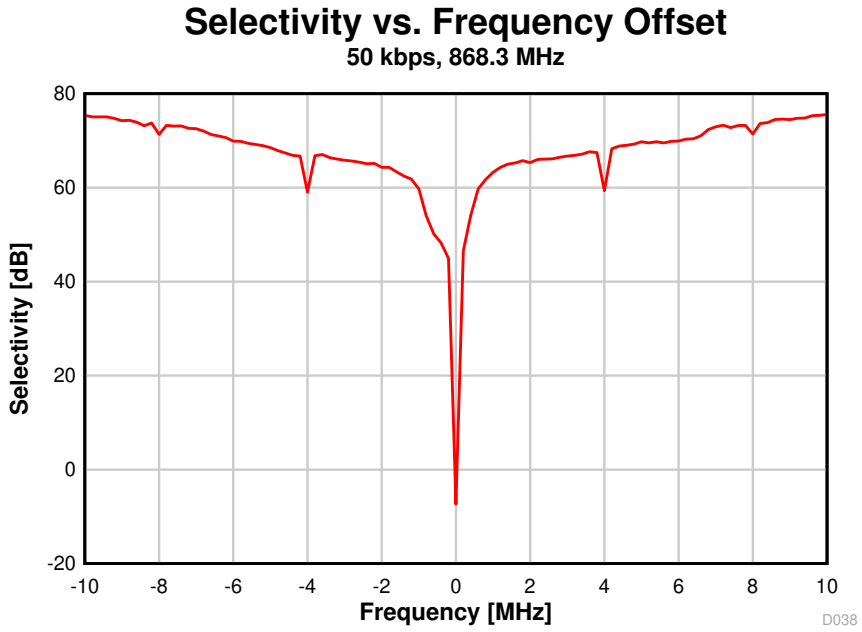



**图 8-16. Selectivity vs. Frequency Offset (50 kbps, 868.3 MHz)**

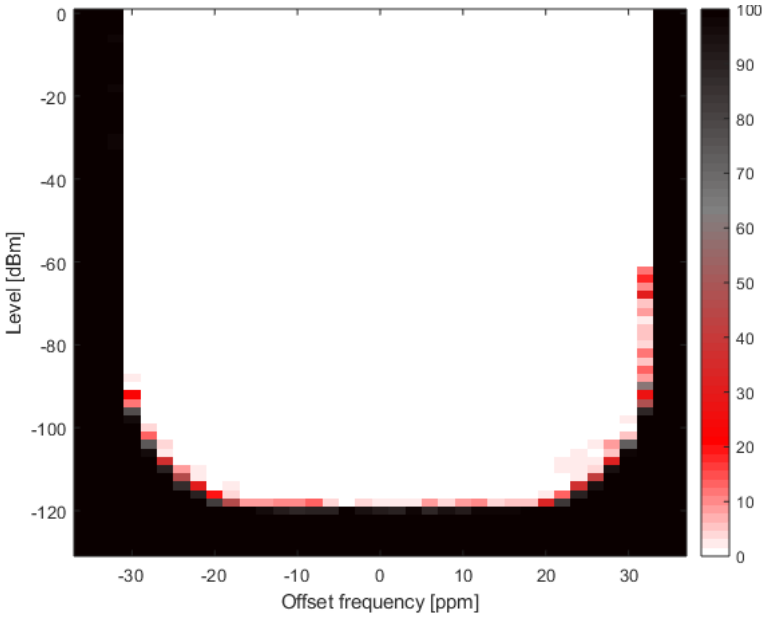



**图 8-17. PER vs. Level vs. Frequency (SimpleLink™ Long Range 5 kbps, 868 MHz)**

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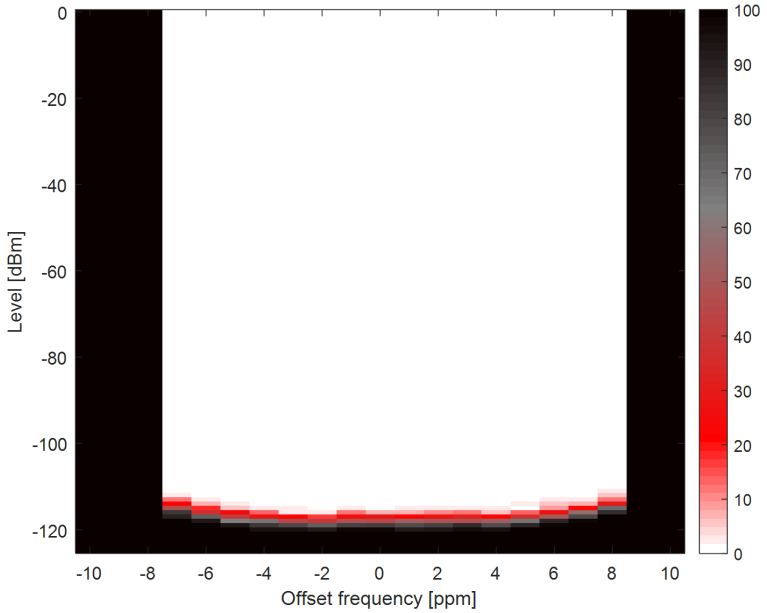



**图 8-18. Narrowband, 9.6 kbps ±2.4 kHz deviation, 2-GFSK, 868 MHz, 17.1 kHz RX Bandwidth**

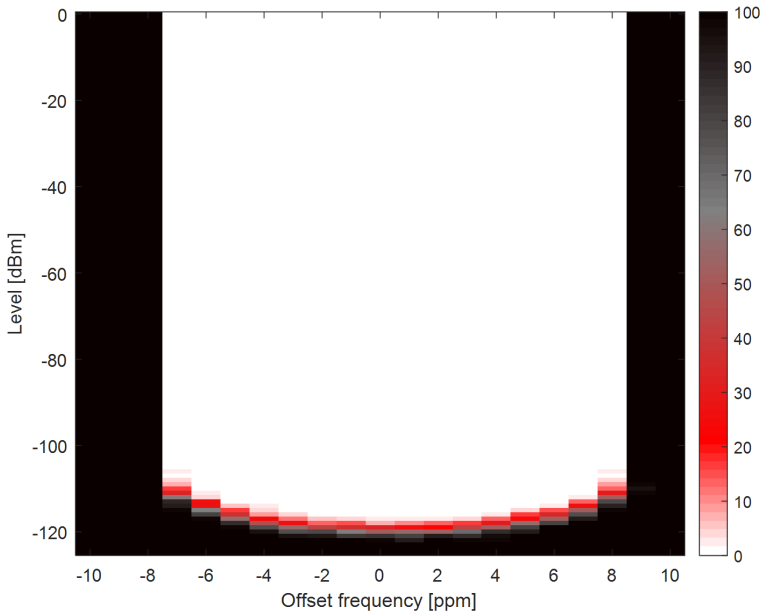



**图 8-19. Narrowband, 4.8 kbps ±2 kHz deviation, 2-GFSK, 426.1 MHz, 10.1 kHz RX Bandwidth**


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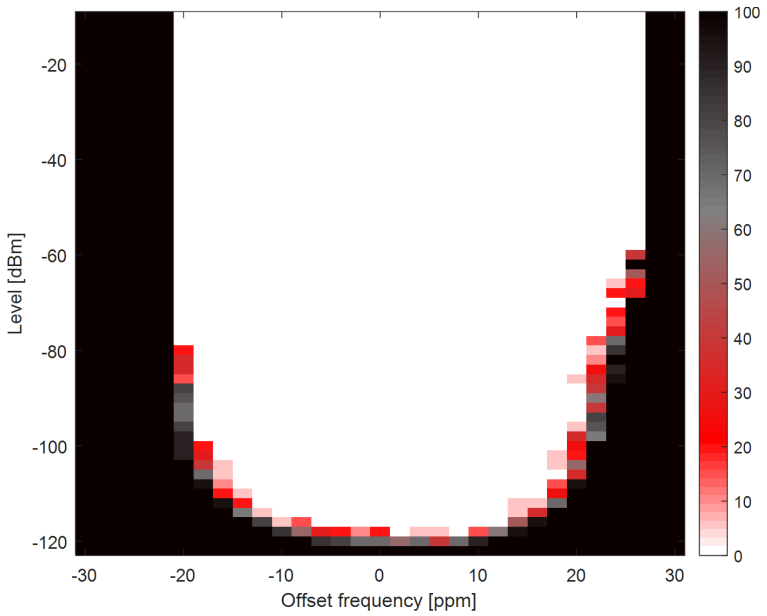



**图 8-20. Narrowband, WMBUS N-MODE, 2.4 kbps, 169 MHz**

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### 8.22.5 TX Performance

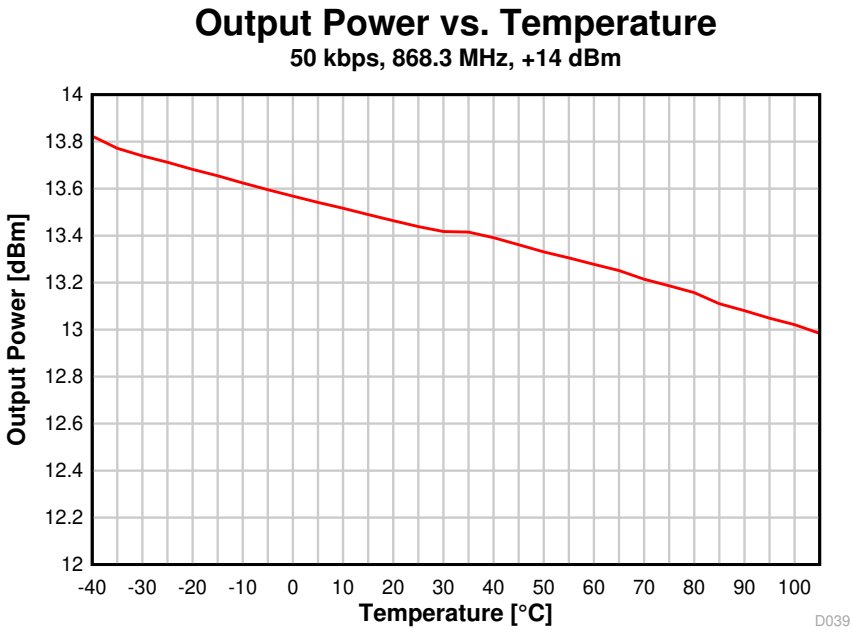



**图 8-21. Output Power vs. Temperature (50 kbps, 868.3 MHz)**

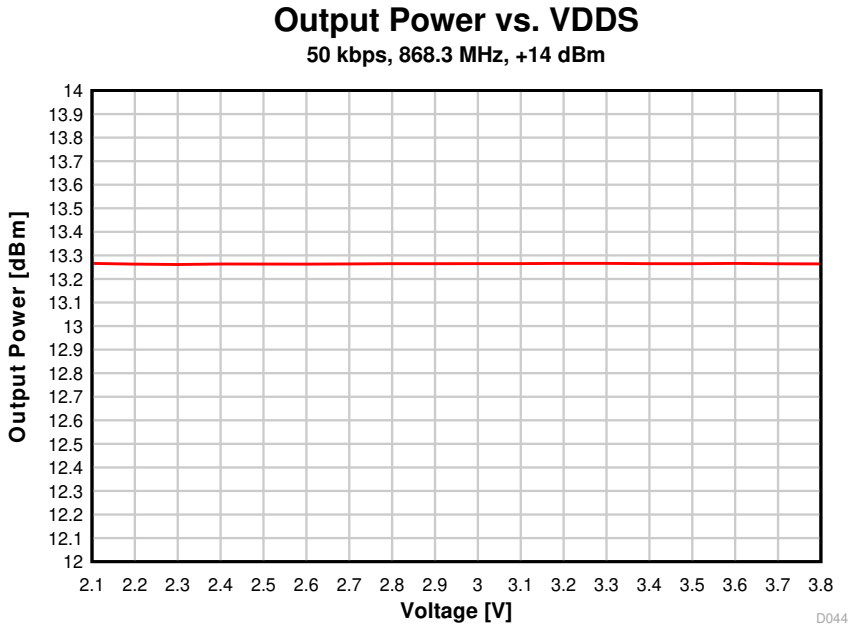



**图 8-22. Output Power vs. Supply Voltage (VDDS) (50 kbps, 868.3 MHz)**


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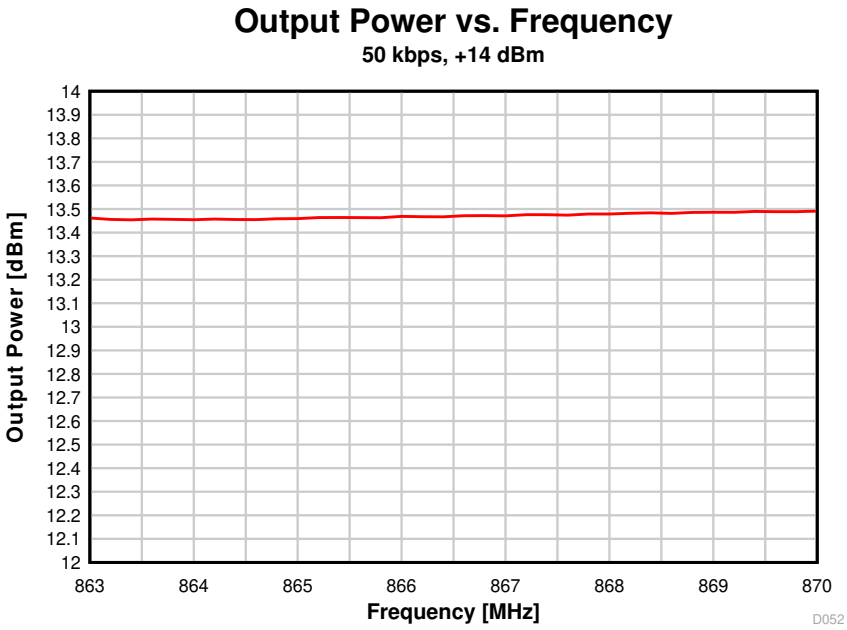



**图 8-23. Output Power vs. Frequency (50 kbps, 868 MHz)**

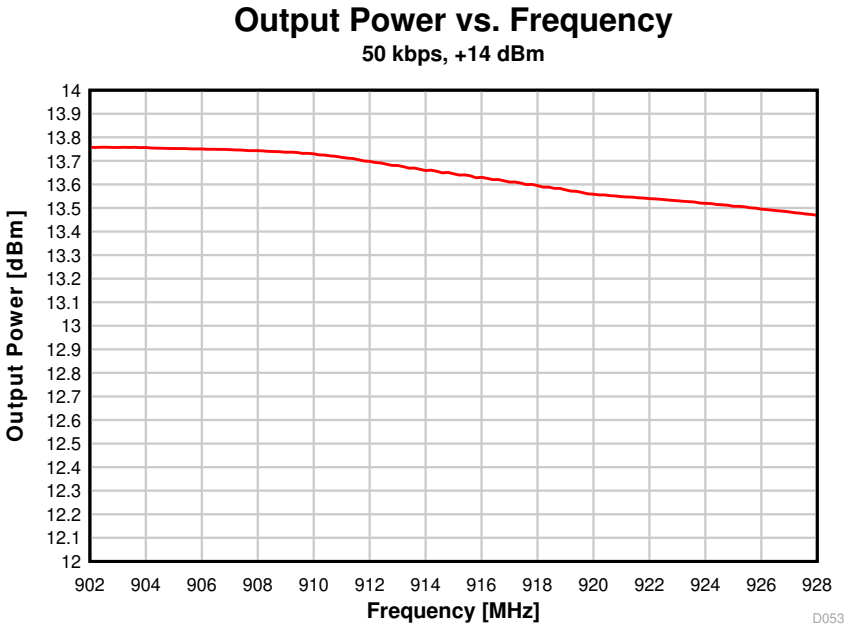



**图 8-24. Output Power vs. Frequency (50 kbps, 915 MHz)**

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### 8.22.6 ADC Performance

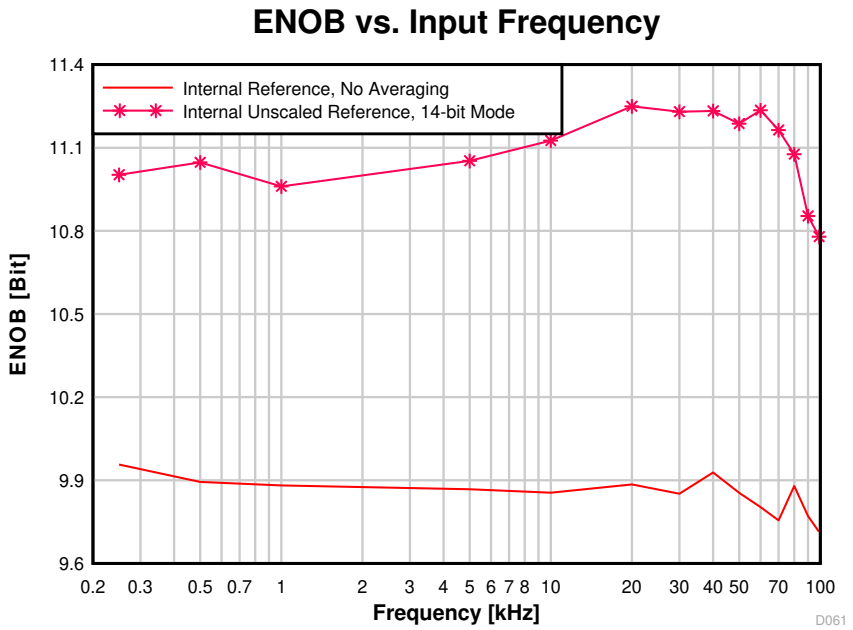



**图 8-25. ENOB vs. Input Frequency**

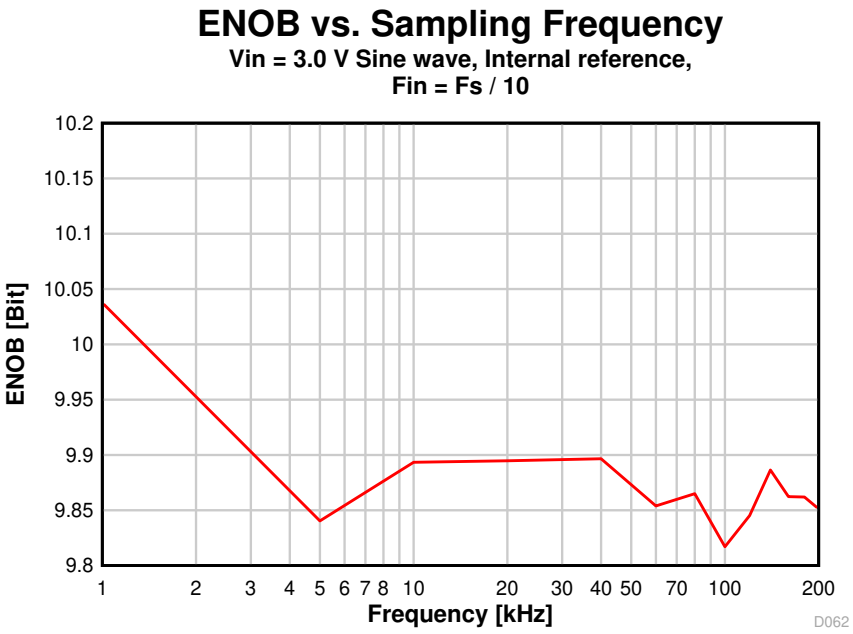



**图 8-26. ENOB vs. Sampling Frequency**


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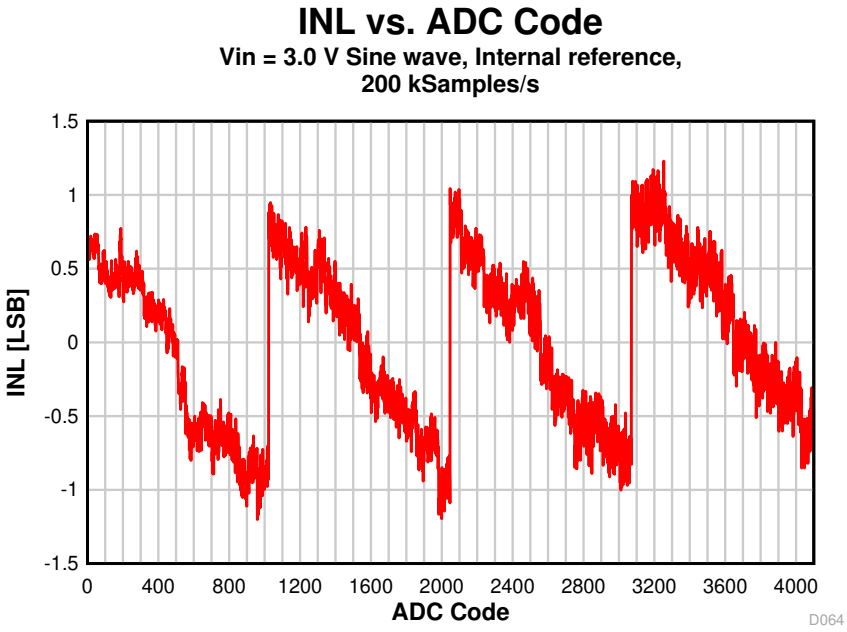



图 8-27. INL vs. ADC Code

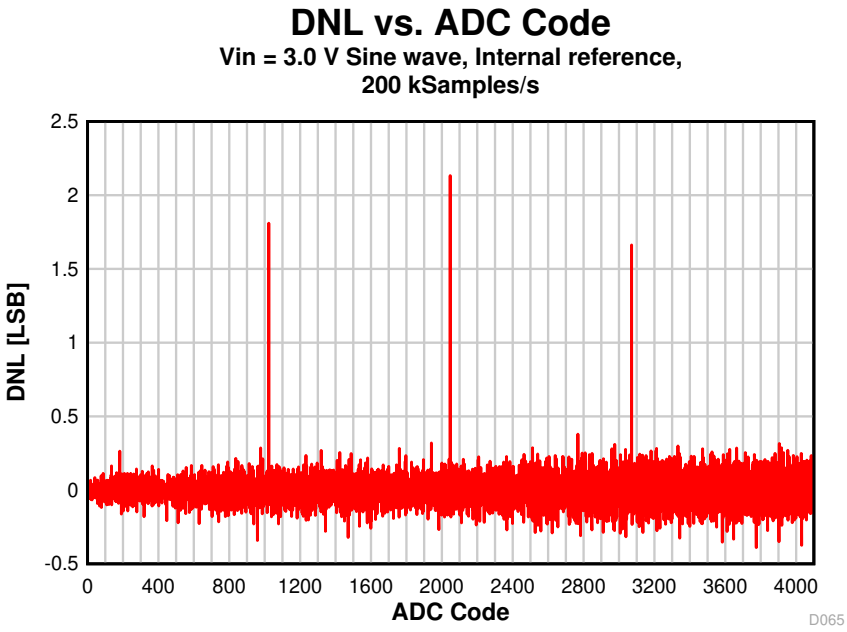



图 8-28. DNL vs. ADC Code

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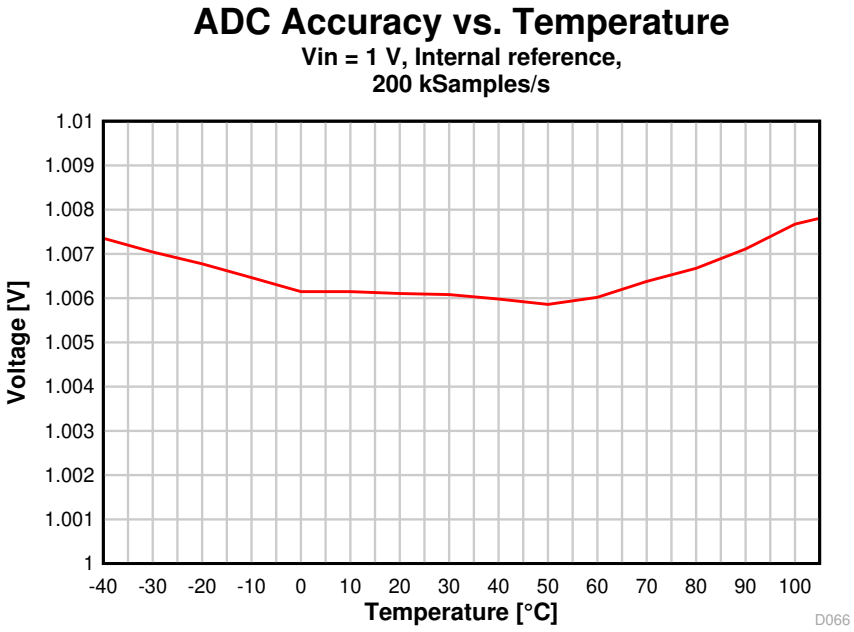



**图 8-29. ADC Accuracy vs. Temperature**

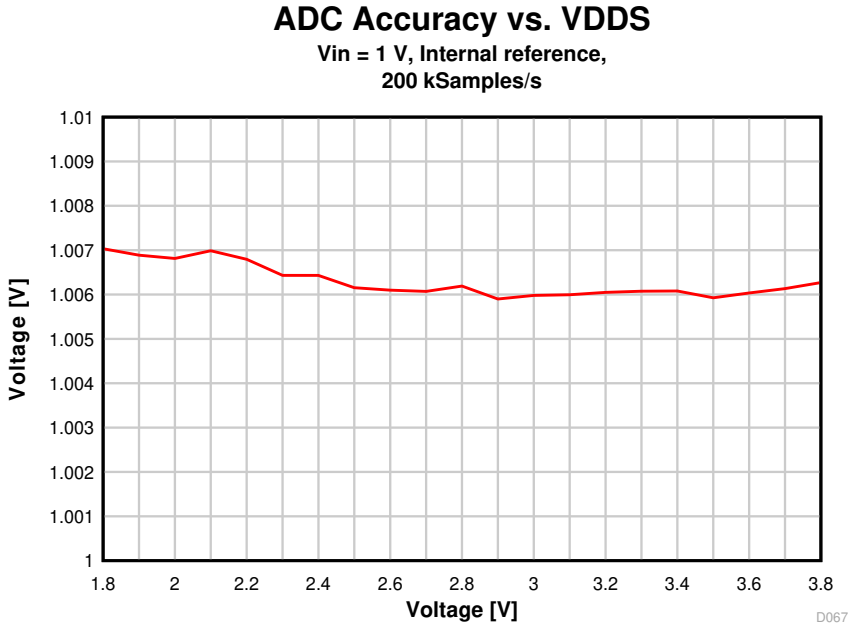



**图 8-30. ADC Accuracy vs. Supply Voltage (VDDS)**


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# 9 Detailed Description

## 9.1 Overview

节 4 shows the core modules of the CC1312R device.

## 9.2 System CPU

The CC1312R SimpleLink™ Wireless MCU contains an Arm® Cortex®-M4F system CPU, which runs the application and the higher layers of radio protocol stacks.

The system CPU is the foundation of a high-performance, low-cost platform that meets the system requirements of minimal memory implementation, and low-power consumption, while delivering outstanding computational performance and exceptional system response to interrupts.

Its features include the following:

- ARMv7-M architecture optimized for small-footprint embedded applications
- Arm Thumb®-2 mixed 16- and 32-bit instruction set delivers the high performance expected of a 32-bit Arm core in a compact memory size
- Fast code execution permits increased sleep mode time
- Deterministic, high-performance interrupt handling for time-critical applications
- Single-cycle multiply instruction and hardware divide
- Hardware division and fast digital-signal-processing oriented multiply accumulate
- Saturating arithmetic for signal processing
- IEEE 754-compliant single-precision Floating Point Unit (FPU)
- Memory Protection Unit (MPU) for safety-critical applications
- Full debug with data matching for watchpoint generation
  - Data Watchpoint and Trace Unit (DWT)
  - JTAG Debug Access Port (DAP)
  - Flash Patch and Breakpoint Unit (FPB)
- Trace support reduces the number of pins required for debugging and tracing
  - Instrumentation Trace Macrocell Unit (ITM)
  - Trace Port Interface Unit (TPIU) with asynchronous serial wire output (SWO)
- Optimized for single-cycle flash memory access
- Tightly connected to 8-KB 4-way random replacement cache for minimal active power consumption and wait states
- Ultra-low-power consumption with integrated sleep modes
- 48 MHz operation
- 1.25 DMIPS per MHz

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## 9.3 Radio (RF Core)

The RF Core is a highly flexible and future proof radio module which contains an Arm Cortex-M0 processor that interfaces the analog RF and base-band circuitry, handles data to and from the system CPU side, and assembles the information bits in a given packet structure. The RF core offers a high level, command-based API to the main CPU that configurations and data are passed through. The Arm Cortex-M0 processor is not programmable by customers and is interfaced through the TI-provided RF driver that is included with the SimpleLink Software Development Kit (SDK).

The RF core can autonomously handle the time-critical aspects of the radio protocols, thus offloading the main CPU, which reduces power and leaves more resources for the user application. Several signals are also available to control external circuitry such as RF switches or range extenders autonomously.

The various physical layer radio formats are partly built as a software defined radio where the radio behavior is either defined by radio ROM contents or by non-ROM radio formats delivered in form of firmware patches with the SimpleLink SDKs. This allows the radio platform to be updated for support of future versions of standards even with over-the-air (OTA) updates while still using the same silicon.

**备注**

Not all combinations of features, frequencies, data rates, and modulation formats described in this chapter are supported. Over time, TI can enable new physical radio formats (PHYs) for the device and provides performance numbers for selected PHYs in the data sheet. Supported radio formats for a specific device, including optimized settings to use with the TI RF driver, are included in the SmartRF Studio tool with performance numbers of selected formats found in the *Specifications* section.


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### 9.3.1 Proprietary Radio Formats

The CC1312R radio can support a wide range of physical radio formats through a set of hardware peripherals combined with firmware available in the device ROM, covering various customer needs for optimizing towards parameters such as speed or sensitivity. This allows great flexibility in tuning the radio both to work with legacy protocols as well as customizing the behavior for specific application needs.

表 9-1 gives a simplified overview of features of the various radio formats available in ROM. Other radio formats may be available in the form of radio firmware patches or programs through the Software Development Kit (SDK) and may combine features in a different manner, as well as add other features.

**表 9-1. Feature Support**

| Feature | Main 2-(G)FSK Mode | High Data Rates | Low Data Rates | SimpleLink™ Long Range |
|---|---|---|---|---|
| Programmable preamble, sync word and CRC | Yes | Yes | Yes | No |
| Programmable receive bandwidth | Yes | Yes | Yes (down to 4 kHz) | Yes |
| Data / Symbol rate(3) | 20 to 1000 kbps | ⩽ 2 Msps | ⩽ 100 ksps | ⩽ 20 ksps |
| Modulation format | 2-(G)FSK | 2-(G)FSK<br>4-(G)FSK | 2-(G)FSK<br>4-(G)FSK | 2-(G)FSK |
| Dual Sync Word | Yes | Yes | No | No |
| Carrier Sense (1) (2) | Yes | No | No | No |
| Preamble Detection(2) | Yes | Yes | Yes | No |
| Data Whitening | Yes | Yes | Yes | Yes |
| Digital RSSI | Yes | Yes | Yes | Yes |
| CRC filtering | Yes | Yes | Yes | Yes |
| Direct-sequence spread spectrum (DSSS) | No | No | No | 1:2<br>1:4<br>1:8 |
| Forward error correction (FEC) | No | No | No | Yes |
| Link Quality Indicator (LQI) | Yes | Yes | Yes | Yes |

(1) Carrier Sense can be used to implement HW-controlled listen-before-talk (LBT) and Clear Channel Assessment (CCA) for compliance with such requirements in regulatory standards. This is available through the CMD_PROP_CS radio API.
(2) Carrier Sense and Preamble Detection can be used to implement sniff modes where the radio is duty cycled to save power.
(3) Data rates are only indicative. Data rates outside this range may also be supported. For some specific combinations of settings, a smaller range might be supported.

## 9.4 Memory

The up to 352-KB nonvolatile (Flash) memory provides storage for code and data. The flash memory is in-system programmable and erasable. The last flash memory sector must contain a Customer Configuration section (CCFG) that is used by boot ROM and TI provided drivers to configure the device. This configuration is done through the ccfg.c source file that is included in all TI provided examples.

The ultra-low leakage system static RAM (SRAM) is split into up to five 16-KB blocks and can be used for both storage of data and execution of code. Retention of SRAM contents in Standby power mode is enabled by default and included in Standby mode power consumption numbers. Parity checking for detection of bit errors in memory is built-in, which reduces chip-level soft errors and thereby increases reliability. System SRAM is always initialized to zeroes upon code execution from boot.

To improve code execution speed and lower power when executing code from nonvolatile memory, a 4-way nonassociative 8-KB cache is enabled by default to cache and prefetch instructions read by the system CPU. The cache can be used as a general-purpose RAM by enabling this feature in the Customer Configuration Area (CCFG).

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There is a 4-KB ultra-low leakage SRAM available for use with the Sensor Controller Engine which is typically used for storing Sensor Controller programs, data and configuration parameters. This RAM is also accessible by the system CPU. The Sensor Controller RAM is not cleared to zeroes between system resets.

The ROM includes a TI-RTOS kernel and low-level drivers, as well as significant parts of selected radio stacks, which frees up flash memory for the application. The ROM also contains a serial (SPI and UART) bootloader that can be used for initial programming of the device.

## 9.5 Sensor Controller

The Sensor Controller contains circuitry that can be selectively enabled in both Standby and Active power modes. The peripherals in this domain can be controlled by the Sensor Controller Engine, which is a proprietary power-optimized CPU. This CPU can read and monitor sensors or perform other tasks autonomously; thereby significantly reducing power consumption and offloading the system CPU.

The Sensor Controller Engine is user programmable with a simple programming language that has syntax similar to C. This programmability allows for sensor polling and other tasks to be specified as sequential algorithms rather than static configuration of complex peripheral modules, timers, DMA, register programmable state machines, or event routing.

The main advantages are:

- Flexibility - data can be read and processed in unlimited manners while still ensuring ultra-low power
- 2 MHz low-power mode enables lowest possible handling of digital sensors
- Dynamic reuse of hardware resources
- 40-bit accumulator supporting multiplication, addition and shift
- Observability and debugging options

Sensor Controller Studio is used to write, test, and debug code for the Sensor Controller. The tool produces C driver source code, which the System CPU application uses to control and exchange data with the Sensor Controller. Typical use cases may be (but are not limited to) the following:

- Read analog sensors using integrated ADC or comparators
- Interface digital sensors using GPIOs, SPI, UART, or $I^2C$ (UART and $I^2C$ are bit-banged)
- Capacitive sensing
- Waveform generation
- Very low-power pulse counting (flow metering)
- Key scan

The peripherals in the Sensor Controller include the following:

- The low-power clocked comparator can be used to wake the system CPU from any state in which the comparator is active. A configurable internal reference DAC can be used in conjunction with the comparator. The output of the comparator can also be used to trigger an interrupt or the ADC.
- Capacitive sensing functionality is implemented through the use of a constant current source, a time-to-digital converter, and a comparator. The continuous time comparator in this block can also be used as a higher-accuracy alternative to the low-power clocked comparator. The Sensor Controller takes care of baseline tracking, hysteresis, filtering, and other related functions when these modules are used for capacitive sensing.
- The ADC is a 12-bit, 200-ksamples/s ADC with eight inputs and a built-in voltage reference. The ADC can be triggered by many different sources including timers, I/O pins, software, and comparators.
- The analog modules can connect to up to eight different GPIOs
- Dedicated SPI master with up to 6 MHz clock speed

The peripherals in the Sensor Controller can also be controlled from the main application processor.


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## 9.6 Cryptography

The CC1312R device comes with a wide set of modern cryptography-related hardware accelerators, drastically reducing code footprint and execution time for cryptographic operations. It also has the benefit of being lower power and improves availability and responsiveness of the system because the cryptography operations runs in a background hardware thread.
Together with a large selection of open-source cryptography libraries provided with the Software Development Kit (SDK), this allows for secure and future proof IoT applications to be easily built on top of the platform. The hardware accelerator modules are:

- **True Random Number Generator (TRNG)** module provides a true, nondeterministic noise source for the purpose of generating keys, initialization vectors (IVs), and other random number requirements. The TRNG is built on 24 ring oscillators that create unpredictable output to feed a complex nonlinear-combinatorial circuit.
- **Secure Hash Algorithm 2 (SHA-2)** with support for SHA224, SHA256, SHA384, and SHA512
- **Advanced Encryption Standard (AES)** with 128 and 256 bit key lengths
- **Public Key Accelerator** - Hardware accelerator supporting mathematical operations needed for elliptic curves up to 512 bits and RSA key pair generation up to 1024 bits.

Through use of these modules and the TI provided cryptography drivers, the following capabilities are available for an application or stack:

- **Key Agreement Schemes**
  - Elliptic curve Diffie – Hellman with static or ephemeral keys (ECDH and ECDHE)
  - Elliptic curve Password Authenticated Key Exchange by Juggling (ECJ-PAKE)
- **Signature Generation**
  - Elliptic curve Diffie-Hellman Digital Signature Algorithm (ECDSA)
- **Curve Support**
  - Short Weierstrass form (full hardware support), such as:
    - NIST-P224, NIST-P256, NIST-P384, NIST-P521
    - Brainpool-256R1, Brainpool-384R1, Brainpool-512R1
    - secp256r1
  - Montgomery form (hardware support for multiplication), such as:
    - Curve25519
- **SHA2 based MACs**
  - HMAC with SHA224, SHA256, SHA384, or SHA512
- Block cipher mode of operation
  - AESCCM
  - AESGCM
  - AESECB
  - AESCBC
  - AESCBC-MAC
- **True random number generation**

Other capabilities, such as RSA encryption and signatures as well as Edwards type of elliptic curves such as Curve1174 or Ed25519, can also be implemented using the provided hardware accelerators but are not part of the TI SimpleLink SDK for the CC1312R device.

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## 9.7 Timers

A large selection of timers are available as part of the CC1312R device. These timers are:

- **Real-Time Clock (RTC)**

  A 70-bit 3-channel timer running on the 32 kHz low frequency system clock (SCLK_LF)
  This timer is available in all power modes except Shutdown. The timer can be calibrated to compensate for frequency drift when using the LF RCOSC as the low frequency system clock. If an external LF clock with frequency different from 32.768 kHz is used, the RTC tick speed can be adjusted to compensate for this. When using TI-RTOS, the RTC is used as the base timer in the operating system and should thus only be accessed through the kernel APIs such as the Clock module. The real time clock can also be read by the Sensor Controller Engine to timestamp sensor data and also has dedicated capture channels. By default, the RTC halts when a debugger halts the device.
- **General Purpose Timers (GPTIMER)**

  The four flexible GPTIMERs can be used as either 4× 32 bit timers or 8× 16 bit timers, all running on up to 48 MHz. Each of the 16- or 32-bit timers support a wide range of features such as one-shot or periodic counting, pulse width modulation (PWM), time counting between edges and edge counting. The inputs and outputs of the timer are connected to the device event fabric, which allows the timers to interact with signals such as GPIO inputs, other timers, DMA and ADC. The GPTIMERs are available in Active and Idle power modes.
- **Sensor Controller Timers**

  The Sensor Controller contains 3 timers:

  AUX Timer 0 and 1 are 16-bit timers with a $2^N$ prescaler. Timers can either increment on a clock or on each edge of a selected tick source. Both one-shot and periodical timer modes are available.

  AUX Timer 2 is a 16-bit timer that can operate at 24 MHz, 2 MHz or 32 kHz independent of the Sensor Controller functionality. There are 4 capture or compare channels, which can be operated in one-shot or periodical modes. The timer can be used to generate events for the Sensor Controller Engine or the ADC, as well as for PWM output or waveform generation.
- **Radio Timer**

  A multichannel 32-bit timer running at 4 MHz is available as part of the device radio. The radio timer is typically used as the timing base in wireless network communication using the 32-bit timing word as the network time. The radio timer is synchronized with the RTC by using a dedicated radio API when the device radio is turned on or off. This ensures that for a network stack, the radio timer seems to always be running when the radio is enabled. The radio timer is in most cases used indirectly through the trigger time fields in the radio APIs and should only be used when running the accurate 48 MHz high frequency crystal is the source of SCLK_HF.
- **Watchdog timer**

  The watchdog timer is used to regain control if the system operates incorrectly due to software errors. It is typically used to generate an interrupt to and reset of the device for the case where periodic monitoring of the system components and tasks fails to verify proper functionality. The watchdog timer runs on a 1.5 MHz clock rate and cannot be stopped once enabled. The watchdog timer pauses to run in Standby power mode and when a debugger halts the device.


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## 9.8 Serial Peripherals and I/O

The SSIs are synchronous serial interfaces that are compatible with SPI, MICROWIRE, and TI's synchronous serial interfaces. The SSIs support both SPI master and slave up to 4 MHz. The SSI modules support configurable phase and polarity.

The UARTs implement universal asynchronous receiver and transmitter functions. They support flexible baud-rate generation up to a maximum of 3 Mbps.

The $I^2S$ interface is used to handle digital audio and can also be used to interface pulse-density modulation microphones (PDM).

The $I^2C$ interface is also used to communicate with devices compatible with the $I^2C$ standard. The $I^2C$ interface can handle 100 kHz and 400 kHz operation, and can serve as both master and slave.

The I/O controller (IOC) controls the digital I/O pins and contains multiplexer circuitry to allow a set of peripherals to be assigned to I/O pins in a flexible manner. All digital I/Os are interrupt and wake-up capable, have a programmable pullup and pulldown function, and can generate an interrupt on a negative or positive edge (configurable). When configured as an output, pins can function as either push-pull or open-drain. Five GPIOs have high-drive capabilities, which are marked in **bold** in 节 7. All digital peripherals can be connected to any digital pin on the device.

For more information, see the CC13x2, CC26x2 SimpleLink™ Wireless MCU Technical Reference Manual.

## 9.9 Battery and Temperature Monitor

A combined temperature and battery voltage monitor is available in the CC1312R device. The battery and temperature monitor allows an application to continuously monitor on-chip temperature and supply voltage and respond to changes in environmental conditions as needed. The module contains window comparators to interrupt the system CPU when temperature or supply voltage go outside defined windows. These events can also be used to wake up the device from Standby mode through the Always-On (AON) event fabric.

## 9.10 µDMA

The device includes a direct memory access (µDMA) controller. The µDMA controller provides a way to offload data-transfer tasks from the system CPU, thus allowing for more efficient use of the processor and the available bus bandwidth. The µDMA controller can perform a transfer between memory and peripherals. The µDMA controller has dedicated channels for each supported on-chip module and can be programmed to automatically perform transfers between peripherals and memory when the peripheral is ready to transfer more data.

Some features of the µDMA controller include the following (this is not an exhaustive list):

- Highly flexible and configurable channel operation of up to 32 channels
- Transfer modes: memory-to-memory, memory-to-peripheral, peripheral-to-memory, and peripheral-to-peripheral
- Data sizes of 8, 16, and 32 bits
- Ping-pong mode for continuous streaming of data

## 9.11 Debug

The on-chip debug support is done through a dedicated cJTAG (IEEE 1149.7) or JTAG (IEEE 1149.1) interface. The device boots by default into cJTAG mode and must be reconfigured to use 4-pin JTAG.

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## 9.12 Power Management

To minimize power consumption, the CC1312R supports a number of power modes and power management features (see 表 9-2).

**表 9-2. Power Modes**

| MODE | SOFTWARE CONFIGURABLE POWER MODES | | | | RESET PIN HELD |
|---|---|---|---|---|---|
| | ACTIVE | IDLE | STANDBY | SHUTDOWN | |
| **CPU** | Active | Off | Off | Off | Off |
| **Flash** | On | Available | Off | Off | Off |
| **SRAM** | On | On | Retention | Off | Off |
| **Supply System** | On | On | Duty Cycled | Off | Off |
| Register and CPU retention | Full | Full | Partial | No | No |
| SRAM retention | Full | Full | Full | No | No |
| 48 MHz high-speed clock (SCLK_HF) | XOSC_HF or RCOSC_HF | XOSC_HF or RCOSC_HF | Off | Off | Off |
| 2 MHz medium-speed clock (SCLK_MF) | RCOSC_MF | RCOSC_MF | Available | Off | Off |
| 32 kHz low-speed clock (SCLK_LF) | XOSC_LF or RCOSC_LF | XOSC_LF or RCOSC_LF | XOSC_LF or RCOSC_LF | Off | Off |
| Peripherals | Available | Available | Off | Off | Off |
| Sensor Controller | Available | Available | Available | Off | Off |
| Wake-up on RTC | Available | Available | Available | Off | Off |
| Wake-up on pin edge | Available | Available | Available | Available | Off |
| Wake-up on reset pin | On | On | On | On | On |
| Brownout detector (BOD) | On | On | Duty Cycled | Off | Off |
| Power-on reset (POR) | On | On | On | Off | Off |
| Watchdog timer (WDT) | Available | Available | Paused | Off | Off |

In **Active** mode, the application system CPU is actively executing code. Active mode provides normal operation of the processor and all of the peripherals that are currently enabled. The system clock can be any available clock source (see 表 9-2).

In **Idle** mode, all active peripherals can be clocked, but the Application CPU core and memory are not clocked and no code is executed. Any interrupt event brings the processor back into active mode.

In **Standby** mode, only the always-on (AON) domain is active. An external wake-up event, RTC event, or Sensor Controller event is required to bring the device back to active mode. MCU peripherals with retention do not need to be reconfigured when waking up again, and the CPU continues execution from where it went into standby mode. All GPIOs are latched in standby mode.

In **Shutdown** mode, the device is entirely turned off (including the AON domain and Sensor Controller), and the I/Os are latched with the value they had before entering shutdown mode. A change of state on any I/O pin defined as a *wake from shutdown pin* wakes up the device and functions as a reset trigger. The CPU can differentiate between reset in this way and reset-by-reset pin or power-on reset by reading the reset status register. The only state retained in this mode is the latched I/O state and the flash memory contents.


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The Sensor Controller is an autonomous processor that can control the peripherals in the Sensor Controller independently of the system CPU. This means that the system CPU does not have to wake up, for example to perform an ADC sampling or poll a digital sensor over SPI, thus saving both current and wake-up time that would otherwise be wasted. The Sensor Controller Studio tool enables the user to program the Sensor Controller, control its peripherals, and wake up the system CPU as needed. All Sensor Controller peripherals can also be controlled by the system CPU.

备注

The power, RF and clock management for the CC1312R device require specific configuration and handling by software for optimized performance. This configuration and handling is implemented in the TI-provided drivers that are part of the CC1312R software development kit (SDK). Therefore, TI highly recommends using this software framework for all application development on the device. The complete SDK with TI-RTOS (optional), device drivers, and examples are offered free of charge in source code.

## 9.13 Clock Systems

The CC1312R device has several internal system clocks.

The 48 MHz SCLK_HF is used as the main system (MCU and peripherals) clock. This can be driven by the internal 48 MHz RC Oscillator (RCOSC_HF) or an external 48 MHz crystal (XOSC_HF). Radio operation requires an external 48 MHz crystal or TCXO.

SCLK_MF is an internal 2 MHz clock that is used by the Sensor Controller in low-power mode and also for internal power management circuitry. The SCLK_MF clock is always driven by the internal 2 MHz RC Oscillator (RCOSC_MF).

SCLK_LF is the 32.768 kHz internal low-frequency system clock. It can be used by the Sensor Controller for ultra-low-power operation and is also used for the RTC and to synchronize the radio timer before or after Standby power mode. SCLK_LF can be driven by the internal 32.8 kHz RC Oscillator (RCOSC_LF), a 32.768 kHz watch-type crystal, or a clock input on any digital IO.

When using a crystal or the internal RC oscillator, the device can output the 32 kHz SCLK_LF signal to other devices, thereby reducing the overall system cost.

## 9.14 Network Processor

Depending on the product configuration, the CC1312R device can function as a wireless network processor (WNP - a device running the wireless protocol stack with the application running on a separate host MCU), or as a system-on-chip (SoC) with the application and protocol stack running on the system CPU inside the device.

In the first case, the external host MCU communicates with the device using SPI or UART. In the second case, the application must be written according to the application framework supplied with the wireless protocol stack.

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# 10 Application, Implementation, and Layout

**备注**

以下应用部分的信息不属于 TI 组件规范，TI 不担保其准确性和完整性。客户应负责确定 TI 组件是否适用于其应用。客户应验证并测试其设计，以确保系统功能。

For general design guidelines and hardware configuration guidelines, refer to CC13xx/CC26xx Hardware Configuration and PCB Design Considerations Application Report.

## 10.1 Reference Designs

The following reference designs should be followed closely when implementing designs using the CC1312R device.

Special attention must be paid to RF component placement, decoupling capacitors and DCDC regulator components, as well as ground connections for all of these.

Integrated matched filter-balun devices can be used both at sub-1 GHz frequencies and at 2.4 GHz for the low-power RF outputs. Refer to the "Integrated Passive Component" section in CC13xx/CC26xx Hardware Configuration and PCB Design Considerations for further information.

| | |
|---|---|
| CC1312REM-XD7793 Design Files | The CC1312REM-XD7793 reference design provides schematic, layout and production files for the characterization board used for deriving the performance number found in this document. |
| LAUNCHXL-CC1312R1 Design Files | The CC1312R LaunchPad Design Files contain detailed schematics and layouts to build application specific boards using the CC1312R device. |
| LAUNCHXL-CC1352P-4 Design Files | Detailed schematics and layouts for the multi-band CC1352P LaunchPad evaluation board featuring 2.4 GHz RF matching optimized for 10 dBm operation on the 20 dBm PA output and up to 13 dBm TX power at 433 MHz. |
| Sub-1 GHz and 2.4 GHz Antenna Kit for LaunchPad ™ Development Kit and SensorTag | The antenna kit allows real-life testing to identify the optimal antenna for your application. The antenna kit includes 16 antennas for frequencies from 169 MHz to 2.4 GHz, including:<br>• PCB antennas<br>• Helical antennas<br>• Chip antennas<br>• Dual-band antennas for 868 MHz and 915 MHz combined with 2.4 GHz<br>The antenna kit includes a JSC cable to connect to the Wireless MCU LaunchPad development kits and SensorTags. |


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## 10.2 Junction Temperature Calculation

This section shows the different techniques for calculating the junction temperature under various operating conditions. For more details, see Semiconductor and IC Package Thermal Metrics.

There are three recommended ways to derive the junction temperature from other measured temperatures:

1. From package temperature:

$$T_J = \psi_{\mathrm{JT}} \times P + T_{\mathrm{case}} \quad (1)$$

2. From board temperature:

$$T_J = \psi_{\mathrm{JB}} \times P + T_{\mathrm{board}} \quad (2)$$

3. From ambient temperature:

$$T_J = R_{\theta\mathrm{JA}} \times P + T_A \quad (3)$$

P is the power dissipated from the device and can be calculated by multiplying current consumption with supply voltage. Thermal resistance coefficients are found in *Thermal Resistance Characteristics*.

**Example:**

Using 方程式 3, the temperature difference between ambient temperature and junction temperature is calculated. In this example, we assume a simple use case where the radio is transmitting continuously at 10 dBm output power. Let us assume the ambient temperature is 85 °C and the supply voltage is 3.6 V. To calculate P, we need to look up the current consumption for Tx at 85 °C in 节 8.22. From the plot, we see that the current consumption is 14.4 mA. This means that P is 14.4 mA × 3.6 V = 51.8 mW.

The junction temperature is then calculated as:

$$T_J = 23.4^{\circ C}/_{W} \times 51.8mW + T_A = 1.2^{\circ}C + T_A \quad (4)$$

As can be seen from the example, the junction temperature is 1.2 °C higher than the ambient temperature when running continuous Tx at 85 °C and, thus, well within the recommended operating conditions.

For various application use cases current consumption for other modules may have to be added to calculate the appropriate power dissipation. For example, the MCU may be running simultaneously as the radio, peripheral modules may be enabled, etc. Typically, the easiest way to find the peak current consumption, and thus the peak power dissipation in the device, is to measure as described in Measuring CC13xx and CC26xx current consumption.

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# 11 Device and Documentation Support

TI offers an extensive line of development tools. Tools and software to evaluate the performance of the device, generate code, and develop solutions are listed as follows.

## 11.1 Tools and Software

The CC1312R device is supported by a variety of software and hardware development tools.

### Development Kit

| | |
|---|---|
| CC1312R LaunchPad™ Development Kit | The CC1312R LaunchPad™ Development Kit enables development of high-performance Sub-1 GHz wireless applications that benefit from low-power operation. The kit features the CC1312R Sub-1 GHz SimpleLink Wireless MCU. The kit works with the LaunchPad ecosystem, easily enabling additional functionality like sensors, display, and more. The built-in EnergyTrace™ software is an energy-based code analysis tool that measures and displays the application's energy profile and helps to optimize it for ultra-low power consumption. |

### Software

| | |
|---|---|
| SimpleLink™ CC13x2-CC26x2 SDK | The SimpleLink CC13x2-CC26x2 Software Development Kit (SDK) provides a complete package for the development of wireless applications on the CC13x2 / CC26x2 family of devices. The SDK includes a comprehensive software package for the CC1312R device, including the following protocol stacks:<br>• Bluetooth Low Energy 4 and 5.1<br>• Thread (based on OpenThread)<br>• Zigbee 3.0<br>• TI 15.4-Stack - an IEEE 802.15.4-based star networking solution for Sub-1 GHz and 2.4 GHz<br>• EasyLink - a large set of building blocks for building proprietary RF software stacks<br>• Multiprotocol support - concurrent operation between stacks using the Dynamic Multiprotocol Manager (DMM)<br><br>The SimpleLink CC13x2-CC26x2 SDK is part of TI's SimpleLink MCU platform, offering a single development environment that delivers flexible hardware, software and tool options for customers developing wired and wireless applications. For more information about the SimpleLink MCU Platform, visit http://www.ti.com/simplelink. |


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## Development Tools

| | |
|---|---|
| Code Composer Studio™ Integrated Development Environment (IDE) | Code Composer Studio is an integrated development environment (IDE) that supports TI's Microcontroller and Embedded Processors portfolio. Code Composer Studio comprises a suite of tools used to develop and debug embedded applications. It includes an optimizing C/C++ compiler, source code editor, project build environment, debugger, profiler, and many other features. The intuitive IDE provides a single user interface taking you through each step of the application development flow. Familiar tools and interfaces allow users to get started faster than ever before. Code Composer Studio combines the advantages of the Eclipse® software framework with advanced embedded debug capabilities from TI resulting in a compelling feature-rich development environment for embedded developers.<br><br>CCS has support for all SimpleLink Wireless MCUs and includes support for EnergyTrace™ software (application energy usage profiling). A real-time object viewer plugin is available for TI-RTOS, part of the SimpleLink SDK.<br><br>Code Composer Studio is provided free of charge when used in conjunction with the XDS debuggers included on a LaunchPad Development Kit. |
| Code Composer Studio™ Cloud IDE | Code Composer Studio (CCS) Cloud is a web-based IDE that allows you to create, edit and build CCS and Energia™ projects. After you have successfully built your project, you can download and run on your connected LaunchPad. Basic debugging, including features like setting breakpoints and viewing variable values is now supported with CCS Cloud. |
| IAR Embedded Workbench® for Arm® | IAR Embedded Workbench® is a set of development tools for building and debugging embedded system applications using assembler, C and C++. It provides a completely integrated development environment that includes a project manager, editor, and build tools. IAR has support for all SimpleLink Wireless MCUs. It offers broad debugger support, including XDS110, IAR I-jet™ and Segger J-Link™. A real-time object viewer plugin is available for TI-RTOS, part of the SimpleLink SDK. IAR is also supported out-of-the-box on most software examples provided as part of the SimpleLink SDK.<br><br>A 30-day evaluation or a 32 KB size-limited version is available through iar.com. |
| SmartRF™ Studio | SmartRF™ Studio is a Windows® application that can be used to evaluate and configure SimpleLink Wireless MCUs from Texas Instruments. The application will help designers of RF systems to easily evaluate the radio at an early stage in the design process. It is especially useful for generation of configuration register values and for practical testing and debugging of the RF system. SmartRF Studio can be used either as a standalone application or together with applicable evaluation boards or debug probes for the RF device. Features of the SmartRF Studio include:<br>• Link tests - send and receive packets between nodes<br>• Antenna and radiation tests - set the radio in continuous wave TX and RX states<br>• Export radio configuration code for use with the TI SimpleLink SDK RF driver<br>• Custom GPIO configuration for signaling and control of external switches |

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| | |
|---|---|
| Sensor Controller Studio | Sensor Controller Studio is used to write, test and debug code for the Sensor Controller peripheral. The tool generates a Sensor Controller Interface driver, which is a set of C source files that are compiled into the System CPU application. These source files also contain the Sensor Controller binary image and allow the System CPU application to control and exchange data with the Sensor Controller. Features of the Sensor Controller Studio include:<br>• Ready-to-use examples for several common use cases<br>• Full toolchain with built-in compiler and assembler for programming in a C-like programming language<br>• Provides rapid development by using the integrated sensor controller task testing and debugging functionality, including visualization of sensor data and verification of algorithms |
| CCS UniFlash | CCS UniFlash is a standalone tool used to program on-chip flash memory on TI MCUs. UniFlash has a GUI, command line, and scripting interface. CCS UniFlash is available free of charge. |

### 11.1.1 SimpleLink™ Microcontroller Platform

The SimpleLink microcontroller platform sets a new standard for developers with the broadest portfolio of wired and wireless Arm® MCUs (System-on-Chip) in a single software development environment. Delivering flexible hardware, software and tool options for your IoT applications. Invest once in the SimpleLink software development kit and use throughout your entire portfolio. Learn more on ti.com/simplelink.

## 11.2 Documentation Support

To receive notification of documentation updates on data sheets, errata, application notes and similar, navigate to the device product folder on ti.com/product/CC1312R. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

The current documentation that describes the MCU, related peripherals, and other technical collateral is listed as follows.

**TI Resource Explorer**

| | |
|---|---|
| TI Resource Explorer | Software examples, libraries, executables, and documentation are available for your device and development board. |

**Errata**

| | |
|---|---|
| *CC1312R Silicon Errata* | The silicon errata describes the known exceptions to the functional specifications for each silicon revision of the device and description on how to recognize a device revision. |

**Application Reports**

All application reports for the CC1312R device are found on the device product folder at: ti.com/product/CC1312R/technicaldocuments.

**Technical Reference Manual (TRM)**

| | |
|---|---|
| *CC13x2, CC26x2 SimpleLink™ Wireless MCU TRM* | The TRM provides a detailed description of all modules and peripherals available in the device family. |


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## 11.3 支持资源

TI E2E™ 支持论坛是工程师的重要参考资料，可直接从专家获得快速、经过验证的解答和设计帮助。搜索现有解答或提出自己的问题可获得所需的快速设计帮助。

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ESD 的损坏小至导致微小的性能降级，大至整个器件故障。精密的集成电路可能更容易受到损坏，这是因为非常细微的参数更改都可能会导致器件与其发布的规格不相符。

## 11.6 术语表

TI 术语表　　本术语表列出并解释了术语、首字母缩略词和定义。

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# 12 Mechanical, Packaging, and Orderable Information

## 12.1 Packaging Information

The following pages include mechanical packaging and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.


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## PACKAGING INFORMATION

| Orderable part number | Status (1) | Material type (2) | Package \| Pins | Package qty \| Carrier | RoHS (3) | Lead finish/ Ball material (4) | MSL rating/ Peak reflow (5) | Op temp (°C) | Part marking (6) |
|---|---|---|---|---|---|---|---|---|---|
| CC1312R1F3RGZR | Active | Production | VQFN (RGZ) \| 48 | 2500 \| LARGE T&R | Yes | NIPDAU \| NIPDAUAG | Level-3-260C-168 HR | -40 to 105 | CC1312 R1F3 |
| CC1312R1F3RGZR.A | Active | Production | VQFN (RGZ) \| 48 | 2500 \| LARGE T&R | Yes | NIPDAU | Level-3-260C-168 HR | -40 to 105 | CC1312 R1F3 |
| CC1312R1F3RGZR.B | Active | Production | VQFN (RGZ) \| 48 | 2500 \| LARGE T&R | Yes | NIPDAU | Level-3-260C-168 HR | -40 to 105 | CC1312 R1F3 |
| CC1312R1F3RGZRG4 | Active | Production | VQFN (RGZ) \| 48 | 2500 \| LARGE T&R | Yes | NIPDAU | Level-3-260C-168 HR | -40 to 105 | CC1312 R1F3 |
| CC1312R1F3RGZRG4.A | Active | Production | VQFN (RGZ) \| 48 | 2500 \| LARGE T&R | Yes | NIPDAU | Level-3-260C-168 HR | -40 to 105 | CC1312 R1F3 |
| CC1312R1F3RGZRG4.B | Active | Production | VQFN (RGZ) \| 48 | 2500 \| LARGE T&R | Yes | NIPDAU | Level-3-260C-168 HR | -40 to 105 | CC1312 R1F3 |
| CC1312R1F3RGZT | Active | Production | VQFN (RGZ) \| 48 | 250 \| SMALL T&R | Yes | NIPDAU \| NIPDAUAG | Level-3-260C-168 HR | -40 to 105 | CC1312 R1F3 |
| CC1312R1F3RGZT.A | Active | Production | VQFN (RGZ) \| 48 | 250 \| SMALL T&R | Yes | NIPDAU | Level-3-260C-168 HR | -40 to 105 | CC1312 R1F3 |
| CC1312R1F3RGZT.B | Active | Production | VQFN (RGZ) \| 48 | 250 \| SMALL T&R | Yes | NIPDAU | Level-3-260C-168 HR | -40 to 105 | CC1312 R1F3 |

(1) **Status:** For more details on status, see our product life cycle.

(2) **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

(3) **RoHS values:** Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

(4) **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

(5) **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

(6) **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

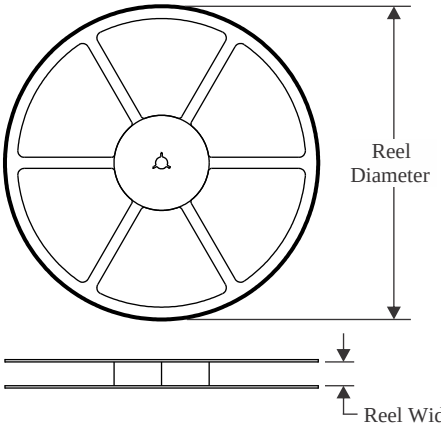
Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

**Important Information and Disclaimer:**The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

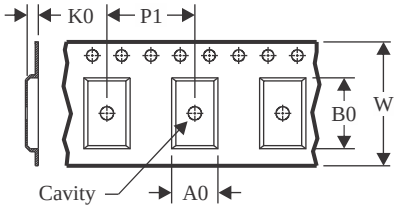
In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

## TAPE AND REEL INFORMATION

**REEL DIMENSIONS**

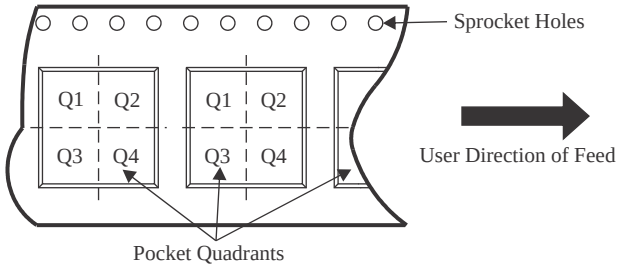



**TAPE DIMENSIONS**




| | |
|---|---|
| A0 | Dimension designed to accommodate the component width |
| B0 | Dimension designed to accommodate the component length |
| K0 | Dimension designed to accommodate the component thickness |
| W | Overall width of the carrier tape |
| P1 | Pitch between successive cavity centers |

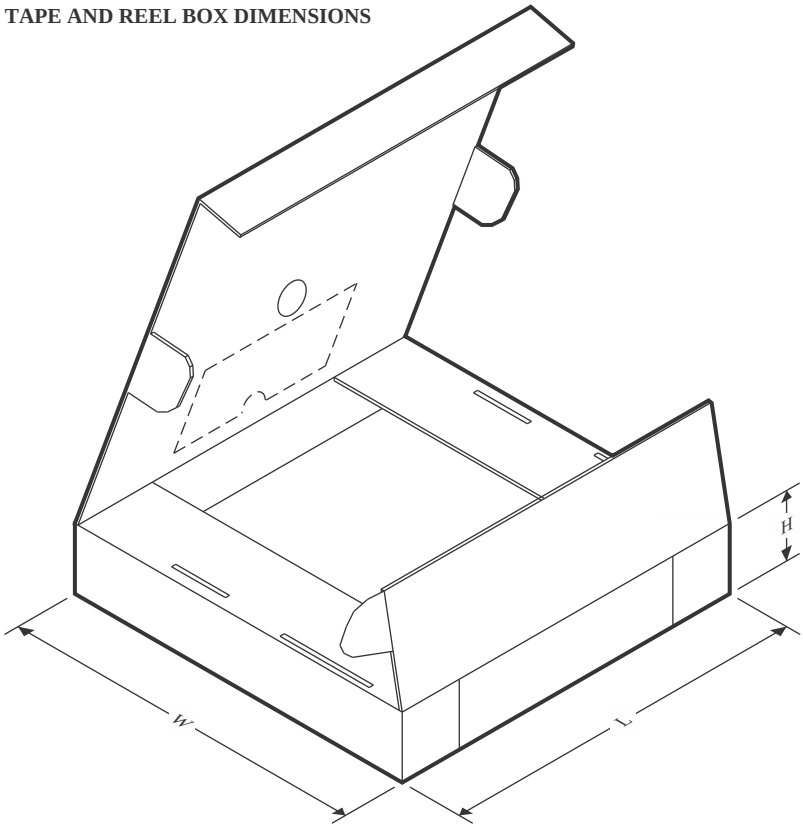
**QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE**




*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|---|---|---|---|---|---|---|---|---|---|---|---|---|
| CC1312R1F3RGZR | VQFN | RGZ | 48 | 2500 | 330.0 | 16.4 | 7.3 | 7.3 | 1.1 | 12.0 | 16.0 | Q2 |
| CC1312R1F3RGZR | VQFN | RGZ | 48 | 2500 | 330.0 | 16.4 | 7.3 | 7.3 | 1.1 | 12.0 | 16.0 | Q2 |
| CC1312R1F3RGZR | VQFN | RGZ | 48 | 2500 | 330.0 | 16.4 | 7.3 | 7.3 | 1.1 | 12.0 | 16.0 | Q2 |
| CC1312R1F3RGZRG4 | VQFN | RGZ | 48 | 2500 | 330.0 | 16.4 | 7.3 | 7.3 | 1.1 | 12.0 | 16.0 | Q2 |
| CC1312R1F3RGZT | VQFN | RGZ | 48 | 250 | 180.0 | 16.4 | 7.3 | 7.3 | 1.1 | 12.0 | 16.0 | Q2 |

TAPE AND REEL BOX DIMENSIONS




*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Length (mm) | Width (mm) | Height (mm) |
|---|---|---|---|---|---|---|---|
| CC1312R1F3RGZR | VQFN | RGZ | 48 | 2500 | 353.0 | 353.0 | 32.0 |
| CC1312R1F3RGZR | VQFN | RGZ | 48 | 2500 | 360.0 | 360.0 | 36.0 |
| CC1312R1F3RGZR | VQFN | RGZ | 48 | 2500 | 367.0 | 367.0 | 35.0 |
| CC1312R1F3RGZRG4 | VQFN | RGZ | 48 | 2500 | 336.6 | 336.6 | 31.8 |
| CC1312R1F3RGZT | VQFN | RGZ | 48 | 250 | 210.0 | 185.0 | 35.0 |

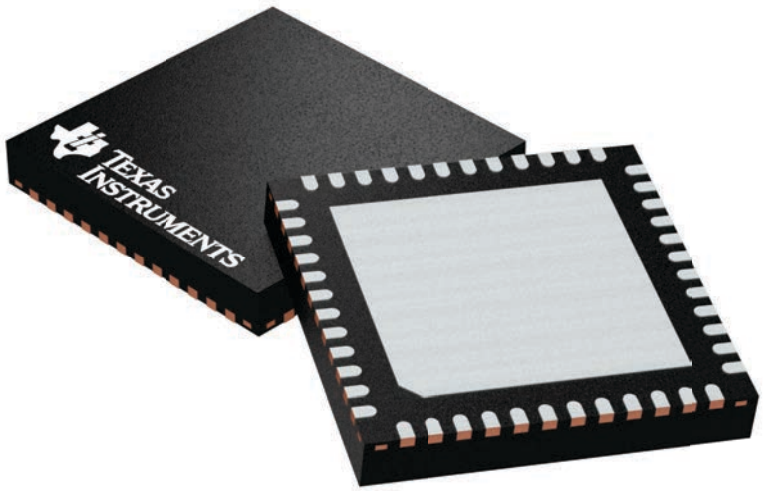
# GENERIC PACKAGE VIEW

## RGZ 48

## VQFN - 1 mm max height

**7 x 7, 0.5 mm pitch**

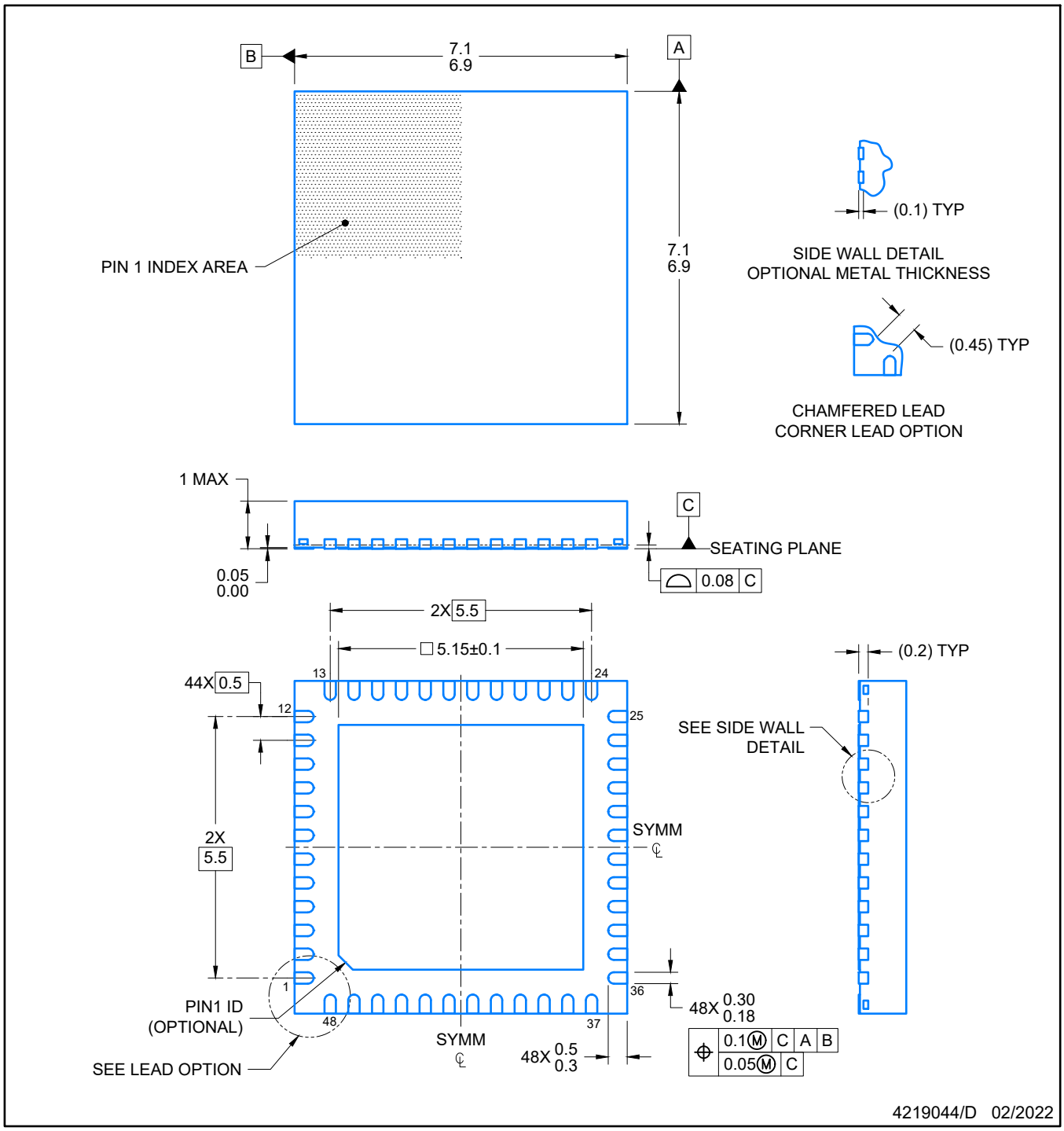
PLASTIC QUADFLAT PACK- NO LEAD




Images above are just a representation of the package family, actual package may vary.
Refer to the product data sheet for package details.

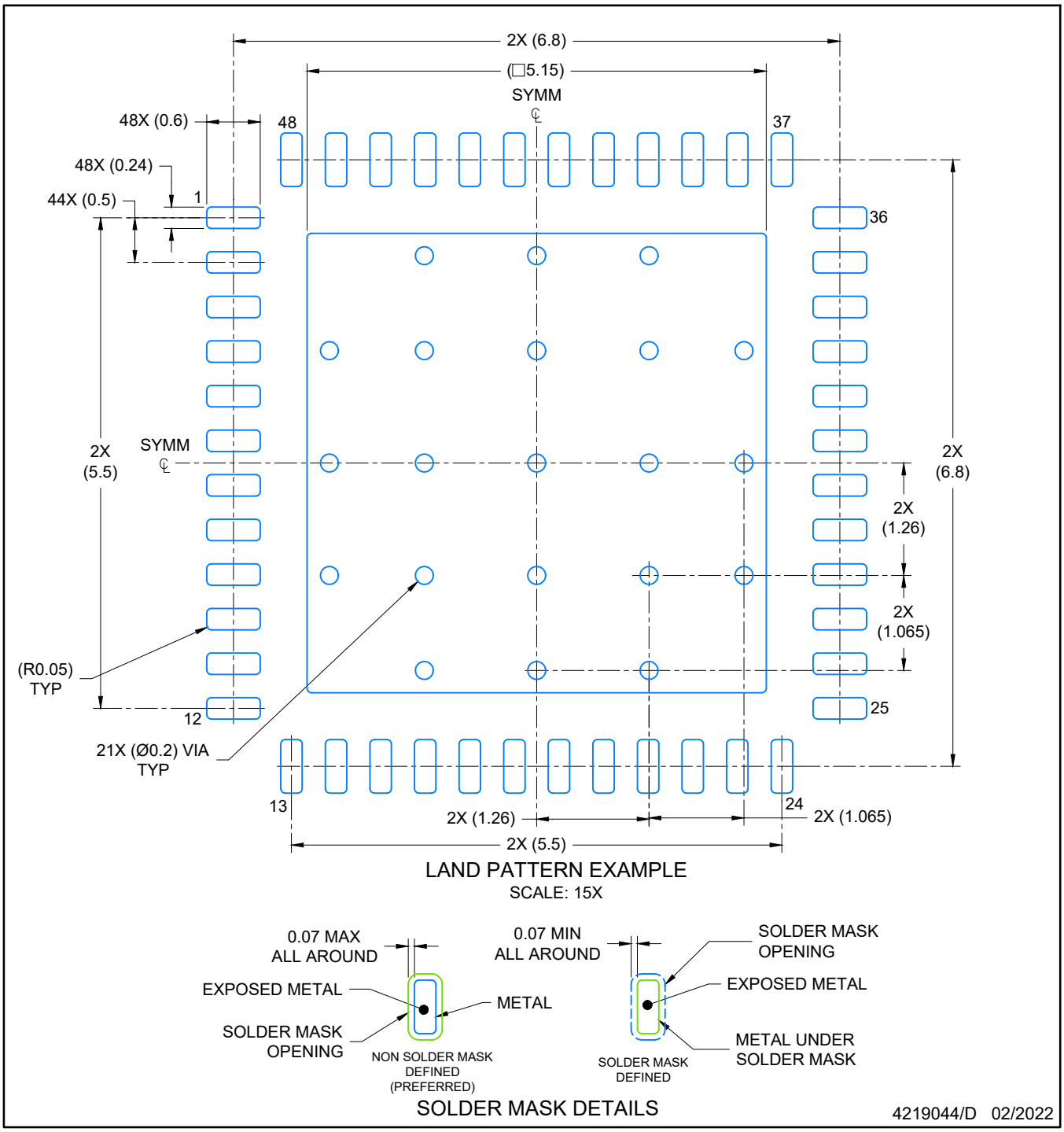
4224671/A

PLASTIC QUADFLAT PACK- NO LEAD



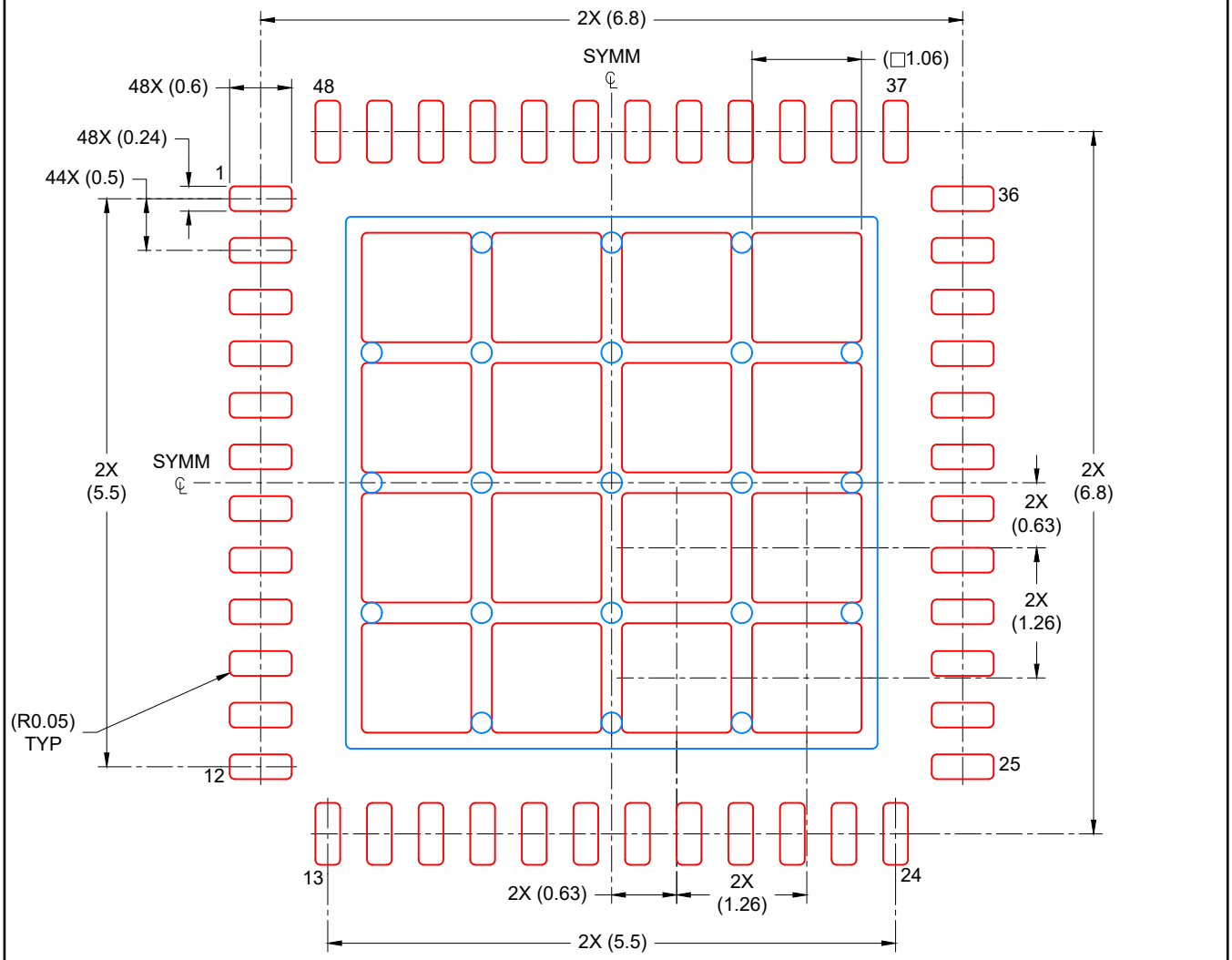

NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for optimal thermal and mechanical performance.




NOTES: (continued)

4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).
5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.




SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL

EXPOSED PAD
67% PRINTED COVERAGE BY AREA
SCALE: 15X

4219044/D 02/2022

NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

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